

# Virtex-5 FPGA Data Sheet: DC and Switching Characteristics

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**Product Specification** 

# **Virtex-5 FPGA Electrical Characteristics**

Virtex®-5 FPGAs are available in -3, -2, -1 speed grades, with -3 having the highest performance. Virtex-5 FPGA DC and AC characteristics are specified for both commercial and industrial grades. Except the operating temperature range or unless otherwise noted, all the DC and AC electrical parameters are the same for a particular speed grade (that is, the timing characteristics of a -1 speed grade industrial device are the same as for a -1 speed grade commercial device). However, only selected speed grades and/or devices might be available in the industrial range.

All supply voltage and junction temperature specifications are representative of worst-case conditions. The parameters included are common to popular designs and typical applications.

This Virtex-5 FPGA data sheet, part of an overall set of documentation on the Virtex-5 family of FPGAs, is available on the Xilinx website:

- Virtex-5 Family Overview
- Virtex-5 FPGA User Guide
- Virtex-5 FPGA Configuration Guide
- Virtex-5 FPGA XtremeDSP™ Design Considerations
- Virtex-5 FPGA Packaging and Pinout Specification
- Embedded Processor Block in Virtex-5 FPGAs Reference Guide
- Virtex-5 FPGA RocketIO<sup>™</sup> GTP Transceiver User Guide
- Virtex-5 FPGA RocketIO GTX Transceiver User Guide
- Virtex-5 FPGA Embedded Tri-Mode Ethernet MAC User Guide
- Virtex-5 FPGA Integrated Endpoint Block User Guide for PCI Express® Designs
- Virtex-5 FPGA System Monitor User Guide
- Virtex-5 FPGA PCB Designer's Guide

All specifications are subject to change without notice.

### Virtex-5 FPGA DC Characteristics

Table 1: Absolute Maximum Ratings

Symbol	Description		Units
V <sub>CCINT</sub>	Internal supply voltage relative to GND	-0.5 to 1.1	V
V <sub>CCAUX</sub>	Auxiliary supply voltage relative to GND	-0.5 to 3.0	V
V <sub>CCO</sub>	Output drivers supply voltage relative to GND	-0.5 to 3.75	V
$V_{BATT}$	Key memory battery backup supply	-0.5 to 4.05	V
$V_{REF}$	Input reference voltage	-0.5 to 3.75	V
	3.3V I/O input voltage relative to GND <sup>(4)</sup> (user and dedicated I/Os)	-0.75 to 4.05	V
V <sub>IN</sub> <sup>(3)</sup>	3.3V I/O input voltage relative to GND (restricted to maximum of 100 user I/Os) <sup>(5)</sup>	-0.95 to 4.4 (Commercial Temperature)	V
VIN.	0.50 % input voltage relative to GND (restricted to maximum of 100 deci 7/05).	-0.85 to 4.3 (Industrial Temperature)	
	2.5V or below I/O input voltage relative to GND (user and dedicated I/Os)	-0.75 to V <sub>CCO</sub> + 0.5	V
ı	Current applied to an I/O pin, powered or unpowered	±100	mA
I <sub>IN</sub>	Total current applied to all I/O pins, powered or unpowered	±100	mA
W	Voltage applied to 3-state 3.3V output <sup>(4)</sup> (user and dedicated I/Os)	-0.75 to 4.05	V
$V_{TS}$	Voltage applied to 3-state 2.5V or below output (user and dedicated I/Os)	-0.75 to V <sub>CCO</sub> + 0.5	V
T <sub>STG</sub>	Storage temperature (ambient)	-65 to 150	°C
T <sub>SOL</sub>	Maximum soldering temperature <sup>(2)</sup>	+220	°C
TJ	Maximum junction temperature <sup>(2)</sup>	+125	°C

#### Notes:

- Stresses beyond those listed under Absolute Maximum Ratings might cause permanent damage to the device. These are stress ratings only, and
  functional operation of the device at these or any other conditions beyond those listed under Operating Conditions is not implied. Exposure to Absolute
  Maximum Ratings conditions for extended periods of time might affect device reliability.
- 2. For soldering guidelines, refer to <u>UG112</u>: Device Package User Guide. For thermal considerations, refer to <u>UG195</u>: Virtex-5 FPGA Packaging and Pinout Specification on the Xilinx website.
- 3. 3.3V I/O absolute maximum limit applied to DC and AC signals.
- 4. For 3.3V I/O operation, refer to <u>UG190</u>: Virtex-5 FPGA User Guide, Chapter 6, 3.3V I/O Design Guidelines.
- 5. For more flexibility in specific designs, a maximum of 100 user I/Os can be stressed beyond the normal specification for no more than 20% of a data period.

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Table 2: Recommended Operating Conditions

Symbol	Description	Temperature Range	Min	Max	Units
V	Internal supply voltage relative to GND, $T_J = 0$ °C to +85°C	Commercial	0.95	1.05	٧
V <sub>CCINT</sub>	Internal supply voltage relative to GND, $T_J = -40^{\circ}\text{C}$ to $+100^{\circ}\text{C}$	Industrial	0.95	1.05	V
V (1)	Auxiliary supply voltage relative to GND, T <sub>J</sub> = 0°C to +85°C	Commercial	2.375	2.625	٧
V <sub>CCAUX</sub> <sup>(1)</sup>	Auxiliary supply voltage relative to GND, $T_J = -40^{\circ}C$ to $+100^{\circ}C$	Industrial	2.375	2.625	V
V <sub>CCO</sub> (2,4,5)	Supply voltage relative to GND, T <sub>J</sub> = 0°C to +85°C	Commercial	1.14	3.45	٧
VCCO( <sup>L</sup> , 1,0)	Supply voltage relative to GND, $T_J = -40^{\circ}C$ to $+100^{\circ}C$	Industrial	1.14	3.45	V
	3.3V supply voltage relative to GND, T <sub>J</sub> = 0°C to +85°C	Commercial	GND - 0.20	3.45	V
	3.3V supply voltage relative to GND, $T_J = -40^{\circ}\text{C}$ to +100°C	Industrial	GND - 0.20	3.45	V
V <sub>IN</sub>	2.5V and below supply voltage relative to GND, $T_J = 0^{\circ}\text{C}$ to +85°C	Commercial	GND - 0.20	V <sub>CCO</sub> + 0.2	V
	2.5V and below supply voltage relative to GND, $T_J = -40^{\circ}\text{C}$ to $+100^{\circ}\text{C}$	Industrial	GND - 0.20	V <sub>CCO</sub> + 0.2	V
ı (6)	Maximum current through any pin in a powered or unpowered	Commercial		10	mA
I <sub>IN</sub> <sup>(6)</sup>	bank when forward biasing the clamp diode	Industrial		10	mA
V (3)	Battery voltage relative to GND, T <sub>J</sub> = 0°C to +85°C	Commercial	1.0	3.6	٧
V <sub>BATT</sub> <sup>(3)</sup>	Battery voltage relative to GND, T <sub>J</sub> = -40°C to +100°C	Industrial	1.0	3.6	٧

- 1. Recommended maximum voltage drop for  $V_{CCAUX}$  is 10 mV/ms.
- 2. Configuration data is retained even if  $V_{CCO}$  drops to 0V.
- 3. V<sub>BATT</sub> is required only when using bitstream encryption. If battery is not used, connect V<sub>BATT</sub> to either ground or V<sub>CCAUX</sub>.
- 4. Includes  $V_{CCO}$  of 1.2V, 1.5V, 1.8V, 2.5V, and 3.3V.
- 5. The configuration supply voltage  $V_{CC\_CONFIG}$  is also known as  $V_{CCO\_0}$ .
- 6. A total of 100 mA per bank should not be exceeded.

Table 3: DC Characteristics Over Recommended Operating Conditions

Symbol	Description	Data Rate	Min	Тур	Max	Units
$V_{DRINT}$	Data retention V <sub>CCINT</sub> voltage (below which configuration data might be lost)		0.75			V
$V_{DRI}$	Data retention V <sub>CCAUX</sub> voltage (below which configuration data might be lost)		2.0			V
I <sub>REF</sub>	V <sub>REF</sub> leakage current per pin				10	μΑ
ΙL	Input or output leakage current per pin (sample-tested)				10	μΑ
C <sub>IN</sub>	Input capacitance (sample-tested)				8	pF
	Pad pull-up (when selected) @ V <sub>IN</sub> = 0V, V <sub>CCO</sub> = 3.3V		20		150	μΑ
	Pad pull-up (when selected) @ V <sub>IN</sub> = 0V, V <sub>CCO</sub> = 2.5V		10		90	μΑ
$I_{RPU}^{(1)}$	Pad pull-up (when selected) @ V <sub>IN</sub> = 0V, V <sub>CCO</sub> = 1.8V		5		45	μΑ
	Pad pull-up (when selected) @ V <sub>IN</sub> = 0V, V <sub>CCO</sub> = 1.5V		3		30	μΑ
	Pad pull-up (when selected) @ V <sub>IN</sub> = 0V, V <sub>CCO</sub> = 1.2V		2		15	μΑ
I <sub>RPD</sub> <sup>(1)</sup>	Pad pull-down (when selected) @ V <sub>IN</sub> = 2.5V		5		110	μΑ
I <sub>BATT</sub> (2)	Battery supply current				150	nA
n	Temperature diode ideality factor			1.0002		n
r	Series resistance			5.0		Ω

- Typical values are specified at nominal voltage, 25°C.
- 2. Maximum value specified for worst case process at 25°C.



# **Important Note**

Typical values for quiescent supply current are now specified at nominal voltage, 85°C junction temperatures  $(T_j)$ . Xilinx recommends analyzing static power consumption at  $T_j = 85$ °C because the majority of designs operate near the high end of the commercial temperature range. Data sheets for older products (e.g., Virtex-4 devices) still specify typical quiescent supply current at  $T_j = 25$ °C. Quiescent supply current is specified by speed grade for Virtex-5 devices. Use the XPOWER<sup>TM</sup> Estimator (XPE) spreadsheet tool (download at <a href="http://www.xilinx.com/power">http://www.xilinx.com/power</a>) to calculate static power consumption for conditions other than those specified in Table 4.

Table 4: Typical Quiescent Supply Current

Complete	Decembries	Device	Speed	and Temperature	e Grade	Unita
Symbol	Description	Device	-3 (C)	-2 (C & I)	-1 (C & I)	Units
I <sub>CCINTQ</sub>	Quiescent V <sub>CCINT</sub> supply current	XC5VLX20T	N/A	406	253	mA
		XC5VLX30	480	480	300	mA
		XC5VLX30T	507	507	317	mA
		XC5VLX50	651	651	449	mA
		XC5VLX50T	689	689	475	mA
		XC5VLX85	1072	1072	833	mA
		XC5VLX85T	1115	1115	866	mA
		XC5VLX110	1391	1391	1109	mA
		XC5VLX110T	1448	1448	1154	mA
		XC5VLX155	2615	2615	2141	mA
		XC5VLX155T	2674	2674	2188	mA
		XC5VLX220	N/A	2783	2278	mA
		XC5VLX220T	N/A	2844	2328	mA
		XC5VLX330	N/A	4193	3432	mA
		XC5VLX330T	N/A	4267	3492	mA
		XC5VSX35T	720	720	554	mA
		XC5VSX50T	1092	1092	840	mA
		XC5VSX95T	N/A	1924	1475	mA
		XC5VSX240T	N/A	4137	3168	mA
		XC5VTX150T	N/A	2067	2067	mA
		XC5VTX240T	N/A	2881	2881	mA
		XC5VFX30T	1024	1024	1024	mA
		XC5VFX70T	1658	1658	1658	mA
		XC5VFX100T	2875	2875	2875	mA
		XC5VFX130T	3041	3041	3041	mA
		XC5VFX200T	N/A	3755	3755	mA
	I .	1	1	1	1	



Table 4: Typical Quiescent Supply Current (Cont'd)

0	December	D	Speed	and Temperature	e Grade	
Symbol	Description	Device	-3 (C)	-2 (C & I)	-1 (C & I)	Units
I <sub>ccoq</sub>	Quiescent V <sub>CCO</sub> supply current	XC5VLX20T	N/A	2	2	mA
		XC5VLX30	1.5	1.5	1.5	mA
		XC5VLX30T	1.5	1.5	1.5	mA
		XC5VLX50	2	2	2	mA
		XC5VLX50T	2	2	2	mA
		XC5VLX85	3	3	3	mA
		XC5VLX85T	3	3	3	mA
		XC5VLX110	4	4	4	mA
		XC5VLX110T	4	4	4	mA
		XC5VLX155	8	8	8	mA
		XC5VLX155T	8	8	8	mA
		XC5VLX220	N/A	8	8	mA
		XC5VLX220T	N/A	8	8	mA
		XC5VLX330	N/A	12	12	mA
		XC5VLX330T	N/A	12	12	mA
		XC5VSX35T	1.5	1.5	1.5	mA
		XC5VSX50T	2	2	2	mA
		XC5VSX95T	N/A	4	4	mA
		XC5VSX240T	N/A	12	12	mA
		XC5VTX150T	N/A	7	7	mA
		XC5VTX240T	N/A	7	7	mA
		XC5VFX30T	4	4	4	mA
		XC5VFX70T	6	6	6	mA
		XC5VFX100T	7	7	7	mA
		XC5VFX130T	8	8	8	mA
		XC5VFX200T	N/A	10	10	mA



Table 4: Typical Quiescent Supply Current (Cont'd)

Combal	Description	Davisa	Speed	and Temperature	e Grade	Unito	
Symbol	Description	Device	-3 (C)	-2 (C & I)	-1 (C & I)	- Units	
I <sub>CCAUXQ</sub>	Quiescent V <sub>CCAUX</sub> supply current	XC5VLX20T	N/A	32	32	mA	
		XC5VLX30	38	38	38	mA	
		XC5VLX30T	43	43	43	mA	
		XC5VLX50	57	57	57	mA	
		XC5VLX50T	62	62	62	mA	
		XC5VLX85	93	93	93	mA	
		XC5VLX85T	98	98	98	mA	
		XC5VLX110	125	125	125	mA	
		XC5VLX110T	130	130	130	mA	
		XC5VLX155	172	172	172	mA	
		XC5VLX155T	177	177	177	mA	
		XC5VLX220	N/A	229	229	mA	
		XC5VLX220T	N/A	236	236	mA	
		XC5VLX330	N/A	345	345	mA	
			XC5VLX330T	N/A	353	353	mA
		XC5VSX35T	49	49	49	mA	
		XC5VSX50T	74	74	74	mA	
		XC5VSX95T	N/A	131	131	mA	
		XC5VSX240T	N/A	300	300	mA	
		XC5VTX150T	N/A	180	180	mA	
		XC5VTX240T	N/A	300	300	mA	
		XC5VFX30T	60	60	60	mA	
		XC5VFX70T	110	110	110	mA	
		XC5VFX100T	150	150	150	mA	
		XC5VFX130T	180	180	180	mA	
		XC5VFX200T	N/A	250	250	mA	

<sup>1.</sup> Typical values are specified at nominal voltage, 85°C junction temperatures (Tj). Industrial (I) grade devices have the same typical values as commercial (C) grade devices at 85°C, but higher values at 100°C. Use the XPE tool to calculate 100°C values.

<sup>2.</sup> Typical values are for blank configured devices with no output current loads, no active input pull-up resistors, all I/O pins are 3-state and floating.

<sup>3.</sup> If DCI or differential signaling is used, more accurate quiescent current estimates can be obtained by using the XPOWER Estimator (XPE) or XPOWER Analyzer (XPA) tools.



### **Power-On Power Supply Requirements**

Xilinx® FPGAs require a certain amount of supply current during power-on to insure proper device initialization. The actual current consumed depends on the power-on ramp rate of the power supply.

The power supplies can be turned on in any sequence, though the specifications shown in Table 5 are for the recommended power-on sequence of  $V_{CCINT}$ ,  $V_{CCAUX}$ , and  $V_{CCO}$ . The I/O will remain 3-stated through power-on if the recommended power-on sequence is followed. Xilinx does not specify the current or I/O behavior for other power-on sequences.

Table 5 shows the minimum current required by Virtex-5 devices for proper power-on and configuration.

If the current minimums shown in Table 5 are met, the device powers on properly after all three supplies have passed through their power-on reset threshold voltages.

The FPGA must be configured after V<sub>CCINT</sub> is applied.

Once initialized and configured, use the XPOWER tools to estimate current drain on these supplies.

Table 5: Power-On Current for Virtex-5 Devices

Device	I <sub>CCINTMIN</sub> Typ <sup>(1)</sup>	I <sub>CCAUXMIN</sub> Typ <sup>(1)</sup>	I <sub>CCOMIN</sub> Typ <sup>(1)</sup>	Units
XC5VLX20T	172	54	50	mA
XC5VLX30	235	76	50	mA
XC5VLX30T	246	86	50	mA
XC5VLX50	320	114	50	mA
XC5VLX50T	336	124	50	mA
XC5VLX85	492	186	100	mA
XC5VLX85T	515	196	100	mA

Table 5: Power-On Current for Virtex-5 Devices

Device	ICCINTMIN	I <sub>CCAUXMIN</sub>	I <sub>CCOMIN</sub>	Units
Device	Typ <sup>(1)</sup>	Typ <sup>(1)</sup>	Typ <sup>(1)</sup>	Ullits
XC5VLX110	623	250	100	mA
XC5VLX110T	651	260	100	mA
XC5VLX155	695	351	100	mA
XC5VLX155T	728	368	100	mA
XC5VLX220	1023	458	150	mA
XC5VLX220T	1056	472	150	mA
XC5VLX330	1470	690	150	mA
XC5VLX330T	1509	706	150	mA
XC5VSX35T	307	98	50	mA
XC5VSX50T	472	148	50	mA
XC5VSX95T	804	262	100	mA
XC5VSX240T	1632	662	150	mA
XC5VTX150T	969	386	150	mA
XC5VTX240T	1245	572	150	mA
XC5VFX30T	358	116	50	mA
XC5VFX70T	695	232	100	mA
XC5VFX100T	749	298	100	mA
XC5VFX130T	1111	392	150	mA
XC5VFX200T	1222	534	150	mA

- 1. Typical values are specified at nominal voltage, 25°C.
- The maximum startup current can be obtained using the XPOWER Estimator (XPE) or XPOWER Analyzer (XPA) tools and adding the quiescent plus dynamic current consumption.

Table 6: Power Supply Ramp Time

Symbol	Description	Ramp Time	Units
V <sub>CCINT</sub>	Internal supply voltage relative to GND	0.20 to 50.0	ms
V <sub>CCO</sub>	Output drivers supply voltage relative to GND	0.20 to 50.0	ms
V <sub>CCAUX</sub>	Auxiliary supply voltage relative to GND	0.20 to 50.0	ms



### SelectIO™ DC Input and Output Levels

Values for  $V_{IL}$  and  $V_{IH}$  are recommended input voltages. Values for  $I_{OL}$  and  $I_{OH}$  are guaranteed over the recommended operating conditions at the  $V_{OL}$  and  $V_{OH}$  test points. Only selected standards are tested. These are chosen to ensure that all standards meet their specifications. The selected standards are tested at a minimum  $V_{CCO}$  with the respective  $V_{OL}$  and  $V_{OH}$  voltage levels shown. Other standards are sample tested.

Table 7: SelectIO DC Input and Output Levels

I/O Standard	V <sub>IL</sub>		V <sub>IH</sub>		V <sub>OL</sub>	V <sub>OH</sub>	l <sub>OL</sub>	I <sub>OH</sub>
i/O Standard	V, Min	V, Max	V, Min	V, Max	V, Max	V, Min	mA	mA
LVTTL	-0.3	0.8	2.0	3.45	0.4	2.4	Note(3)	Note(3)
LVCMOS33, LVDCl33	-0.3	0.8	2.0	3.45	0.4	V <sub>CCO</sub> - 0.4	Note(3)	Note(3)
LVCMOS25, LVDCI25	-0.3	0.7	1.7	V <sub>CCO</sub> + 0.3	0.4	V <sub>CCO</sub> - 0.4	Note(3)	Note(3)
LVCMOS18, LVDCI18	-0.3	35% V <sub>CCO</sub>	65% V <sub>CCO</sub>	V <sub>CCO</sub> + 0.3	0.45	V <sub>CCO</sub> - 0.45	Note(4)	Note(4)
LVCMOS15, LVDCI15	-0.3	35% V <sub>CCO</sub>	65% V <sub>CCO</sub>	V <sub>CCO</sub> + 0.3	25% V <sub>CCO</sub>	75% V <sub>CCO</sub>	Note(4)	Note(4)
LVCMOS12	-0.3	35% V <sub>CCO</sub>	65% V <sub>CCO</sub>	V <sub>CCO</sub> + 0.3	25% V <sub>CCO</sub>	75% V <sub>CCO</sub>	Note(6)	Note(6)
PCI33_3 <sup>(5)</sup>	-0.2	30% V <sub>CCO</sub>	50% V <sub>CCO</sub>	V <sub>CCO</sub>	10% V <sub>CCO</sub>	90% V <sub>CCO</sub>	Note(5)	Note(5)
PCI66_3 <sup>(5)</sup>	-0.2	30% V <sub>CCO</sub>	50% V <sub>CCO</sub>	V <sub>CCO</sub>	10% V <sub>CCO</sub>	90% V <sub>CCO</sub>	Note(5)	Note(5)
PCI-X <sup>(5)</sup>	-0.2	35% V <sub>CCO</sub>	50% V <sub>CCO</sub>	V <sub>CCO</sub>	10% V <sub>CCO</sub>	90% V <sub>CCO</sub>	Note(5)	Note(5)
GTLP	-0.3	V <sub>REF</sub> - 0.1	V <sub>REF</sub> + 0.1	_	0.6	N/A	36	N/A
GTL	-0.3	V <sub>REF</sub> - 0.05	V <sub>REF</sub> + 0.05	_	0.4	N/A	32	N/A
HSTL I_12	-0.3	V <sub>REF</sub> - 0.1	V <sub>REF</sub> + 0.1	V <sub>CCO</sub> + 0.3	25% V <sub>CCO</sub>	75% V <sub>CCO</sub>	6.3	6.3
HSTL I <sup>(2)</sup>	-0.3	V <sub>REF</sub> – 0.1	V <sub>REF</sub> + 0.1	V <sub>CCO</sub> + 0.3	0.4	V <sub>CCO</sub> - 0.4	8	-8
HSTL II <sup>(2)</sup>	-0.3	V <sub>REF</sub> – 0.1	V <sub>REF</sub> + 0.1	V <sub>CCO</sub> + 0.3	0.4	V <sub>CCO</sub> - 0.4	16	-16
HSTL III <sup>(2)</sup>	-0.3	V <sub>REF</sub> - 0.1	V <sub>REF</sub> + 0.1	V <sub>CCO</sub> + 0.3	0.4	V <sub>CCO</sub> - 0.4	24	-8
HSTL IV <sup>(2)</sup>	-0.3	V <sub>REF</sub> – 0.1	V <sub>REF</sub> + 0.1	V <sub>CCO</sub> + 0.3	0.4	V <sub>CCO</sub> - 0.4	48	-8
DIFF HSTL I <sup>(2)</sup>	-0.3	50% V <sub>CCO</sub> - 0.1	50% V <sub>CCO</sub> + 0.1	V <sub>CCO</sub> + 0.3	_	_	-	_
DIFF HSTL II <sup>(2)</sup>	-0.3	50% V <sub>CCO</sub> – 0.1	50% V <sub>CCO</sub> + 0.1	V <sub>CCO</sub> + 0.3	_	_	_	_
SSTL2 I	-0.3	V <sub>REF</sub> – 0.15	V <sub>REF</sub> + 0.15	V <sub>CCO</sub> + 0.3	V <sub>TT</sub> – 0.61	V <sub>TT</sub> + 0.61	8.1	-8.1
SSTL2 II	-0.3	V <sub>REF</sub> – 0.15	V <sub>REF</sub> + 0.15	V <sub>CCO</sub> + 0.3	V <sub>TT</sub> – 0.81	V <sub>TT</sub> + 0.81	16.2	-16.2
DIFF SSTL2 I	-0.3	50% V <sub>CCO</sub> – 0.15	50% V <sub>CCO</sub> + 0.15	V <sub>CCO</sub> + 0.3	_	_	_	_
DIFF SSTL2 II	-0.3	50% V <sub>CCO</sub> – 0.15	50% V <sub>CCO</sub> + 0.15	V <sub>CCO</sub> + 0.3	_	_	_	-
SSTL18 I	-0.3	V <sub>REF</sub> – 0.125	V <sub>REF</sub> + 0.125	V <sub>CCO</sub> + 0.3	V <sub>TT</sub> - 0.47	V <sub>TT</sub> + 0.47	6.7	-6.7
SSTL18 II	-0.3	V <sub>REF</sub> – 0.125	V <sub>REF</sub> + 0.125	V <sub>CCO</sub> + 0.3	V <sub>TT</sub> – 0.60	V <sub>TT</sub> + 0.60	13.4	-13.4
DIFF SSTL18 I	-0.3	50% V <sub>CCO</sub> – 0.125	50% V <sub>CCO</sub> + 0.125	V <sub>CCO</sub> + 0.3	_	_	_	_
DIFF SSTL18 II	-0.3	50% V <sub>CCO</sub> – 0.125	50% V <sub>CCO</sub> + 0.125	V <sub>CCO</sub> + 0.3	-	-	_	-

- 1. Tested according to relevant specifications.
- 2. Applies to both 1.5V and 1.8V HSTL.
- 3. Using drive strengths of 2, 4, 6, 8, 12, 16, or 24 mA.
- 4. Using drive strengths of 2, 4, 6, 8, 12, or 16 mA.
- 5. For more information on PCl33\_3, PCl66\_3, and PCl-X, refer to UG190: Virtex-5 FPGA User Guide, Chapter 6, 3.3V I/O Design Guidelines.
- 6. Supported drive strengths of 2, 4, 6, or 8 mA.



# **HT DC Specifications (HT\_25)**

Table 8: HT DC Specifications

Symbol	DC Parameter	Conditions	Min	Тур	Max	Units
V <sub>CCO</sub>	Supply Voltage		2.38	2.5	2.63	V
V <sub>OD</sub>	Differential Output Voltage	$R_T = 100 \Omega$ across Q and $\overline{Q}$ signals	495	600	715	mV
ΔV <sub>OD</sub>	Change in V <sub>OD</sub> Magnitude		-15		15	mV
V <sub>OCM</sub>	Output Common Mode Voltage	$R_T = 100 \Omega$ across Q and $\overline{Q}$ signals	495	600	715	mV
Δ V <sub>OCM</sub>	Change in V <sub>OCM</sub> Magnitude		-15		15	mV
V <sub>ID</sub>	Input Differential Voltage		200	600	1000	mV
$\Delta$ V <sub>ID</sub>	Change in V <sub>ID</sub> Magnitude		-15		15	mV
V <sub>ICM</sub>	Input Common Mode Voltage		440	600	780	mV
Δ V <sub>ICM</sub>	Change in V <sub>ICM</sub> Magnitude		-15		15	mV

# LVDS DC Specifications (LVDS\_25)

Table 9: LVDS DC Specifications

Symbol	DC Parameter	Conditions	Min	Тур	Max	Units
V <sub>CCO</sub>	Supply Voltage		2.38	2.5	2.63	V
V <sub>OH</sub>	Output High Voltage for Q and Q	$R_T = 100 \Omega$ across Q and $\overline{Q}$ signals			1.675	V
V <sub>OL</sub>	Output Low Voltage for Q and Q	$R_T = 100 \Omega$ across Q and $\overline{Q}$ signals	0.825			V
V <sub>ODIFF</sub>	Differential Output Voltage $(Q - \overline{Q})$ , $Q = \text{High } (\overline{Q} - Q)$ , $\overline{Q} = \text{High }$	$R_T = 100 \Omega$ across Q and $\overline{Q}$ signals	247	350	600	mV
V <sub>OCM</sub>	Output Common-Mode Voltage	$R_T = 100 \Omega$ across Q and $\overline{Q}$ signals	1.125	1.250	1.375	V
V <sub>IDIFF</sub>	Differential Input Voltage $(Q - \overline{Q})$ , $Q = \text{High } (\overline{Q} - Q)$ , $\overline{Q} = \text{High }$		100	350	600	mV
V <sub>ICM</sub>	Input Common-Mode Voltage		0.3	1.2	2.2	٧

# **Extended LVDS DC Specifications (LVDSEXT\_25)**

Table 10: Extended LVDS DC Specifications

Symbol	DC Parameter	Conditions	Min	Тур	Max	Units
V <sub>CCO</sub>	Supply Voltage		2.38	2.5	2.63	V
$V_{OH}$	Output High Voltage for Q and $\overline{\mathbf{Q}}$	$R_T = 100 \Omega$ across Q and $\overline{Q}$ signals		_	1.785	V
V <sub>OL</sub>	Output Low Voltage for Q and Q	$R_T = 100 \Omega$ across Q and $\overline{Q}$ signals	0.715	_	_	V
V <sub>ODIFF</sub>	Differential Output Voltage $(Q - \overline{Q})$ , $Q = \text{High } (\overline{Q} - Q)$ , $\overline{Q} = \text{High }$	$R_T = 100 \Omega$ across Q and $\overline{Q}$ signals	350	_	820	mV
$V_{OCM}$	Output Common-Mode Voltage	$R_T = 100 \Omega$ across Q and $\overline{Q}$ signals	1.125	1.250	1.375	V
V <sub>IDIFF</sub>	Differential Input Voltage $(Q - \overline{Q})$ , $Q = \text{High } (\overline{Q} - Q)$ , $\overline{Q} = \text{High }$	Common-mode input voltage = 1.25V	100	_	1000	mV
V <sub>ICM</sub>	Input Common-Mode Voltage	Differential input voltage = ±350 mV	0.3	1.2	2.2	V



# LVPECL DC Specifications (LVPECL\_25)

These values are valid when driving a  $100\Omega$  differential load only, i.e., a  $100\Omega$  resistor between the two receiver pins. The  $V_{OH}$  levels are 200 mV below standard LVPECL levels and are compatible with devices tolerant of lower common-mode ranges. Table 11 summarizes the DC output specifications of LVPECL. For more information on using LVPECL, see <u>UG190</u>: *Virtex-5 FPGA User Guide, Chapter 6, SelectIO Resources*.

Table 11: LVPECL DC Specifications

Symbol	DC Parameter	Min	Тур	Max	Units
V <sub>OH</sub>	Output High Voltage	V <sub>CC</sub> – 1.025	1.545	V <sub>CC</sub> – 0.88	V
V <sub>OL</sub>	Output Low Voltage	V <sub>CC</sub> – 1.81	0.795	V <sub>CC</sub> - 1.62	V
V <sub>ICM</sub>	Input Common-Mode Voltage	0.6		2.2	V
V <sub>IDIFF</sub>	Differential Input Voltage <sup>(1,2)</sup>	0.100		1.5	V

#### Notes:

- Recommended input maximum voltage not to exceed V<sub>CCO</sub> + 0.2V.
- 2. Recommended input minimum voltage not to go below -0.5V.

# **PowerPC 440 Switching Characteristics**

Consult the Embedded Processor Block in Virtex-5 FPGAs Reference Guide for further information.

Table 12: Processor Block Switching Characteristics

Clock Name	Deceription	(	Speed Grade			
Clock Name	Description	-3	-2	-1	- Units	
CPMC440CLK	CPU clock	550	475	400	MHz	
CPMINTERCONNECTCLK	Xbar clock	366.6	316.6	266.6	MHz	
CPMPPCS0PLBCLK	Slave 0 PLB clock <sup>(1)</sup>	183.3	158.3	133.3	MHz	
CPMPPCS1PLBCLK	Slave 1 PLB clock <sup>(1)</sup>	183.3	158.3	133.3	MHz	
CPMPPCMPLBCLK	Master PLB clock <sup>(1)</sup>	183.3	158.3	133.3	MHz	
CPMMCCLK	Memory interface clock <sup>(1)(2)</sup>	366.6	316.6	266.6	MHz	
CPMFCMCLK	FCM clock <sup>(1)</sup>	275	237.5	200	MHz	
CPMDCRCLK	FPGA logic DCR clock <sup>(1)</sup>	183.3	158.3	133.3	MHz	
CPMDMA0LLCLK	DMA0 LL clock <sup>(1)</sup>	250	250	200	MHz	
CPMDMA1LLCLK	DMA1 LL clock <sup>(1)</sup>	250	250	200	MHz	
CPMDMA2LLCLK	DMA2 LL clock <sup>(1)</sup>	250	250	200	MHz	
CPMDMA3LLCLK	DMA3 LL clock <sup>(1)</sup>	250	250	200	MHz	
JTGC440TCK	JTAG clock	50	50	50	MHz	
CPMC440TIMERCLOCK	Timer clock	275	237.5	200	MHz	

- 1. Typical bus frequencies are provided for reference only, actual frequencies are user-design dependent.
- 2. Refer to DS567 for maximum clock speed of designs using the DDR2 Memory Controller for PowerPC® 440 Processors.



Table 13: Processor Block MIB Switching Characteristics

Clock Name	Decemention	Reference Clock	,	le	Unito	
	Description	Description Hererence Clock	-3	-2	-1	Units
Clock-to-out and setup rela	tive to clock					
T <sub>CK_CONTROL</sub>		CPMMCCLK	1.146	1.247	1.463	ps
T <sub>CK_ADDRESS</sub>		CPMMCCLK	1.017	1.136	1.38	ps
T <sub>CK_DATA</sub>		CPMMCCLK	1.076	1.172	1.38	ps
T <sub>CONTROL_CK</sub>		CPMMCCLK	0.736	0.844	0.941	ps
T <sub>DATA_CK</sub>		CPMMCCLK	0.834	0.95	1.058	ps

# Table 14: Processor Block PLBM Switching Characteristics

Clock Name	Description Reference Clock	Poforonoo Clook	5	e	Units	
Clock Name		neierence Clock	-3	-2	-1	Uiils
Clock-to-out and setup relative	ve to clock					
T <sub>CK_CONTROL</sub>		CPMPPCMPLBCLK	0.971	1.095	1.354	ps
T <sub>CK_ADDRESS</sub>		CPMPPCMPLBCLK	1.215	1.372	1.673	ps
T <sub>CK_DATA</sub>		CPMPPCMPLBCLK	1.115	1.257	1.535	ps
T <sub>CONTROL_CK</sub>		CPMPPCMPLBCLK	1.7	1.79	1.86	ps
T <sub>DATA_CK</sub>		CPMPPCMPLBCLK	0.774	0.914	1.059	ps

### Table 15: Processor Block PLBS0 Switching Characteristics

Clock Name	Description	D / OI I		Speed Grade				
	Description	Reference Clock	-3	-2	-1	Units		
Clock-to-out and setup relative to clock								
T <sub>CK_CONTROL</sub>		CPMPPCS0PLBCLK	1.063	1.196	1.462	ps		
T <sub>CK_DATA</sub>		CPMPPCS0PLBCLK	1.052	1.189	1.461	ps		
T <sub>CONTROL_CK</sub>		CPMPPCS0PLBCLK	1.307	1.545	1.836	ps		
T <sub>ADDRESS_CK</sub>		CPMPPCS0PLBCLK	1.253	1.492	1.787	ps		
T <sub>DATA_CK</sub>		CPMPPCS0PLBCLK	0.825	0.971	1.124	ps		

### Table 16: Processor Block PLBS1 Switching Characteristics

Clock Name	Description	Description Reference Clock	Speed Grade			Heita
Clock Name	Description		-3	-2	-1	Units
Clock-to-out and setup rela	tive to clock					
T <sub>CK_CONTROL</sub>		CPMPPCS1PLBCLK	1.083	1.234	1.525	ps
T <sub>CK_DATA</sub>		CPMPPCS1PLBCLK	1.146	1.298	1.615	ps
T <sub>CONTROL_CK</sub>		CPMPPCS1PLBCLK	1.335	1.596	1.921	ps
T <sub>ADDRESS_CK</sub>		CPMPPCS1PLBCLK	1.328	1.568	1.864	ps
T <sub>DATA_CK</sub>		CPMPPCS1PLBCLK	0.821	0.969	1.127	ps



### Table 17: Processor Block DMA0 Switching Characteristics

Clock Name	Description	Description Reference Clock		Speed Grade			
	Description		-3	-2	-1	Units	
Clock-to-out and setup relative to clock							
T <sub>CK_CONTROL</sub>		CPMDMA0LLCLK	1.256	1.42	1.665	ps	
T <sub>CK_DATA</sub>		CPMDMA0LLCLK	1.312	1.472	1.712	ps	
T <sub>CONTROL_CK</sub>		CPMDMA0LLCLK	0.453	0.558	0.716	ps	
T <sub>DATA_CK</sub>		CPMDMA0LLCLK	-0.105	-0.105	-0.104	ps	

### Table 18: Processor Block DMA1 Switching Characteristics

Clock Name	Description Reference	Reference Clock	S	Speed Grade			
		neierence Glock	-3	-2	-1	- Units	
Clock-to-out and setup relative to clock							
T <sub>CK_CONTROL</sub>		CPMDMA1LLCLK	1.127	1.266	1.474	ps	
T <sub>CK_DATA</sub>		CPMDMA1LLCLK	1.266	1.418	1.645	ps	
T <sub>CONTROL_CK</sub>		CPMDMA1LLCLK	0.447	0.555	0.717	ps	
T <sub>DATA_CK</sub>		CPMDMA1LLCLK	-0.014	0.01	0.046	ps	

### Table 19: Processor Block DMA2 Switching Characteristics

Clock Name	Description Reference Clock	Poforonoo Clook	5	Units			
		-3	-2	-1	Ullits		
Clock-to-out and setup relative to clock							
T <sub>CK_CONTROL</sub>		CPMDMA2LLCLK	1.101	1.235	1.437	ps	
T <sub>CK_DATA</sub>		CPMDMA2LLCLK	1.127	1.262	1.463	ps	
T <sub>CONTROL_CK</sub>		CPMDMA2LLCLK	0.771	0.924	1.155	ps	
T <sub>DATA_CK</sub>		CPMDMA2LLCLK	0.135	0.142	0.168	ps	

### Table 20: Processor Block DMA3 Switching Characteristics

Clock Name	Description Reference Clock	5	Units					
CIOCK Name		-3	-2	-1	Uiilis			
Clock-to-out and setup relative to clock								
T <sub>CK_CONTROL</sub>		CPMDMA3LLCLK	1.094	1.242	1.462	ps		
T <sub>CK_DATA</sub>		CPMDMA3LLCLK	1.056	1.184	1.376	ps		
T <sub>CONTROL_CK</sub>		CPMDMA3LLCLK	0.636	0.767	0.965	ps		
T <sub>DATA_CK</sub>		CPMDMA3LLCLK	0.087	0.119	0.116	ps		



Table 21: Processor Block DCR Switching Characteristics

Clock Name	Description	Reference Clock	Speed Grade			Units
Clock Name	Description Neterence Glock	-3	-2	-1	Ullits	
Clock-to-out and setup rela	tive to clock					
T <sub>CK_CONTROL</sub>		CPMDCRCLK				
T <sub>CK_ADDRESS</sub>		CPMDCRCLK				
T <sub>CK_DATA</sub>		CPMDCRCLK				
T <sub>CONTROL_CK</sub>		CPMDCRCLK				
T <sub>ADDRESS_CK</sub>		CPMDCRCLK				
T <sub>DATA_CK</sub>		CPMDCRCLK				

### Table 22: Processor Block FCM Switching Characteristics

Clock Name	Description	Reference Clock	9	Speed Grade					
Clock Name	Description		-3	-2	-1	Units			
Clock-to-out and setup relative to clock									
T <sub>CK_CONTROL</sub>		CPMFCMCLK	0.967	1.084	1.324	ps			
T <sub>CK_DATA</sub>		CPMFCMCLK	1.041	1.158	1.4	ps			
T <sub>CK_INSTRUCTION</sub>		CPMFCMCLK	0.701	0.818	1.06	ps			
T <sub>CONTROL_CK</sub>		CPMFCMCLK	1.057	1.218	1.395	ps			
T <sub>DATA_CK</sub>		CPMFCMCLK	0.608	0.698	0.768	ps			
T <sub>RESULT_CK</sub>		CPMFCMCLK	0.608	0.698	0.768	ps			

# Table 23: Processor Block MISC Switching Characteristics

Clock Name	Description	Reference Clock	(	Speed Grad	le	l le:te
Clock Name	Description	Reference Clock	-3	-2	-1	Units
Clock-to-out and setup rela	tive to clock			•		
T <sub>CK_CONTROL</sub>		CLK1				
T <sub>CK_ADDRESS</sub>		CLK2				
T <sub>CK_DATA</sub>		CLK3				
T <sub>CONTROL_CK</sub>		CLK4				
T <sub>ADDRESS_CK</sub>		CLK5				
T <sub>DATA_CK</sub>		CLK6				



# **GTP\_DUAL Tile Specifications**

### **GTP DUAL Tile DC Characteristics**

Table 24: Absolute Maximum Ratings for GTP\_DUAL Tiles

Symbol	Description		Units
MGTAVCCPLL	Analog supply voltage for the GTP_DUAL shared PLL relative to GND	-0.5 to 1.32	V
MGTAVTTTX	Analog supply voltage for the GTP_DUAL transmitters relative to GND	-0.5 to 1.32	V
MGTAVTTRX	Analog supply voltage for the GTP_DUAL receivers relative to GND	-0.5 to 1.32	V
MGTAVCC	Analog supply voltage for the GTP_DUAL common circuits relative to GND	-0.5 to 1.1	V
MGTAVTTRXC	Analog supply voltage for the resistor calibration circuit of the GTP_DUAL column	-0.5 to 1.32	V

#### Notes:

Table 25: Recommended Operating Conditions for GTP\_DUAL Tiles(1)(2)

Symbol	Description	Min	Max	Units
MGTAVCCPLL <sup>(1)</sup>	Analog supply voltage for the GTP_DUAL shared PLL relative to GND	1.14	1.26	V
MGTAVTTTX <sup>(1)</sup>	Analog supply voltage for the GTP_DUAL transmitters relative to GND	1.14	1.26	V
MGTAVTTRX <sup>(1)</sup>	Analog supply voltage for the GTP_DUAL receivers relative to GND	1.14	1.26	V
MGTAVCC <sup>(1)</sup>	Analog supply voltage for the GTP_DUAL common circuits relative to GND	0.95	1.05	V
MGTAVTTRXC <sup>(1)</sup>	Analog supply voltage for the resistor calibration circuit of the GTP_DUAL column	1.14	1.26	V

#### Notes:

- 1. Each voltage listed requires the filter circuit described in UG196: Virtex-5 FPGA RocketIO GTP Transceiver User Guide.
- 2. Voltages are specified for the temperature range of  $T_J = -40$ °C to +100°C.

Table 26: DC Characteristics Over Recommended Operating Conditions for GTP\_DUAL Tiles(1)

Symbol	Description		Тур	Max	Units
I <sub>MGTAVTTTX</sub>	GTP_DUAL tile transmitter termination supply current <sup>(2)</sup>		71	90	mA
I <sub>MGTAVCCPLL</sub>	TAVCCPLL GTP_DUAL tile shared PLL supply current		36	60	mA
I <sub>MGTAVTTRXC</sub>	GTP_DUAL tile resistor termination calibration supply current		0.1	0.5	mA
I <sub>MGTAVTTRX</sub>	GTP_DUAL tile receiver termination supply current <sup>(3)</sup>		0.1	0.5	mA
I <sub>MGTAVCC</sub>	I <sub>MGTAVCC</sub> GTP_DUAL tile internal analog supply current		56	110	mA
MGTR <sub>REF</sub>	Precision reference resistor for internal calibration termination	49.9 ± 1% tolerance		Ω	

- 1. Typical values are specified at nominal voltage, 25°C, with a 3.2 Gb/s line rate.
- 2. ICC numbers are given per GTP\_DUAL tile with both GTP transceivers operating with default settings.
- AC coupled TX/RX link.

Stresses beyond those listed under Absolute Maximum Ratings might cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those listed under Operating Conditions is not implied. Exposure to Absolute Maximum Ratings conditions for extended periods of time might affect device reliability.



Table 27: GTP\_DUAL Tile Quiescent Supply Current

Symbol	Description	Typ <sup>(1)</sup>	Max	Units
I <sub>AVTTTXQ</sub>	Quiescent MGTAVTTTX (transmitter termination) supply current	8.5	18	mA
I <sub>AVCCPLLQ</sub>	Quiescent MGTAVCCPLL (PLL) supply current	8	18	mA
I <sub>AVTTRXQ</sub>	Quiescent MGTAVTTRX (receiver termination) supply current. Includes MGTAVTTRXCQ.		0.8	mA
I <sub>AVCCQ</sub>	Quiescent MGTAVCC (analog) supply current	2.5	11	mA

- Typical values are specified at nominal voltage, 25°C.
- 2. Device powered and unconfigured.
- 3. Currents for conditions other than values specified in this table can be obtained by using the XPOWER Estimator (XPE) or XPOWER Analyzer (XPA) tools.
- 4. GTP\_DUAL tile quiescent supply current for an entire device can be calculated by multiplying the values in this table by the number of available GTP\_DUAL tiles in the target LXT or SXT device.

### **GTP\_DUAL Tile DC Input and Output Levels**

Table 28 summarizes the DC output specifications of the GTP\_DUAL tiles in Virtex-5 FPGAs. Figure 1 shows the single-ended output voltage swing. Figure 2 shows the peak-to-peak differential output voltage.

Consult UG196: Virtex-5 FPGA RocketIO GTP Transceiver User Guide for further details.

Table 28: GTP\_DUAL Tile DC Specifications

Symbol	DC Parameter	Conditions	Min	Тур	Max	Units
DV	Differential peak-to-peak input	External AC coupled ≤ 3.2 Gb/s	150		2000	mV
DV <sub>PPIN</sub>	voltage	External AC coupled > 3.2 Gb/s	180		2000	mV
V <sub>IN</sub>	Absolute input voltage	DC coupled	-400		MGTAVTTRX + 400 up to 1320	mV
V <sub>CMIN</sub>	Common mode input voltage	DC coupled MGTAVTTRX = 1.2V		800		mV
DV <sub>PPOUT</sub>	Differential peak-to-peak output voltage <sup>(1)</sup>	TXBUFDIFFCTRL = 000, TX_DIFF_BOOST = ON			1400	mV
V <sub>SEOUT</sub>	Single-ended output voltage swing <sup>(1)</sup>	TXBUFDIFFCTRL = 000, TX_DIFF_BOOST = ON			700	mV
V <sub>CMOUT</sub>	Common mode output voltage	Equation based MGTAVTTTX = 1.2V		1200 – Amplitude/2		
R <sub>IN</sub>	Differential input resistance		90	100	120	Ω
R <sub>OUT</sub>	Differential output resistance		90	100	120	Ω
T <sub>OSKEW</sub>	Transmitter output skew	1			15	ps
C <sub>EXT</sub>	Recommended external AC coupling capacitor <sup>(2)</sup>		75	100	200	nF

- 1. The output swing and preemphasis levels are programmable using the attributes discussed in <u>UG196</u>: *Virtex-5 FPGA RocketIO GTP Transceiver User Guide* and can result in values lower than reported in this table.
- 2. Values outside of this range can be used as appropriate to conform to specific protocols and standards.

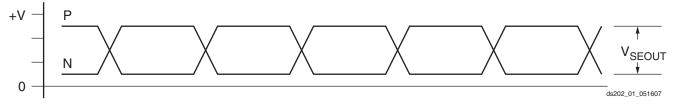


Figure 1: Single-Ended Output Voltage Swing

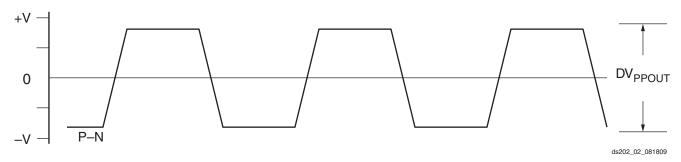


Figure 2: Peak-to-Peak Differential Output Voltage

Table 29 summarizes the DC specifications of the clock input of the GTP\_DUAL tile. Figure 3 shows the single-ended input voltage swing. Figure 4 shows the peak-to-peak differential clock input voltage swing. Consult <u>UG196</u>: *Virtex-5 FPGA RocketIO GTP Transceiver User Guide* for further details.

Table 29: GTP\_DUAL Tile Clock DC Input Specifications(1)

Symbol	DC Parameter	Conditions	Min	Тур	Max	Units
$V_{IDIFF}$	Differential peak-to-peak input voltage		200	800	2000	mV
V <sub>ISE</sub>	Single-ended input voltage		100	400	1000	mV
R <sub>IN</sub>	Differential input resistance		80	105	130	Ω
C <sub>EXT</sub>	Required external AC coupling capacitor		75	100	200	nF

#### Notes:

1.  $V_{MIN} = 0V \text{ and } V_{MAX} = 1200 \text{mV}$ 

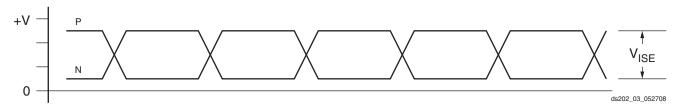


Figure 3: Single-Ended Clock Input Voltage Swing Peak-to-Peak

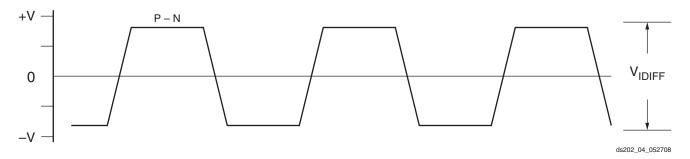


Figure 4: Differential Clock Input Voltage Swing Peak-to-Peak



# GTP\_DUAL Tile Switching Characteristics

Consult UG196: Virtex-5 FPGA RocketIO GTP Transceiver User Guide for further information.

Table 30: GTP\_DUAL Tile Performance

Symbol	Description		Speed Grade			
			-2	-1	Units	
F <sub>GTPMAX</sub>	Maximum GTP transceiver data rate	3.75	3.75	3.2	Gb/s	
F <sub>GPLLMAX</sub>	Maximum PLL frequency	2.0	2.0	2.0	GHz	
F <sub>GPLLMIN</sub>	Minimum PLL frequency	1.0	1.0	1.0	GHz	

Table 31: Dynamic Reconfiguration Port (DRP) in the GTP\_DUAL Tile Switching Characteristics

Symbol	Description	S	peed Grad	е	Units
Syllibol	Description		-2	-1	Ullits
F <sub>GTPDRPCLK</sub>	GTP DCLK (DRP clock) maximum frequency		175	150	MHz

Table 32: GTP\_DUAL Tile Reference Clock Switching Characteristics

Symbol	Description	Conditions	Al	ades	Units	
Syllibol	Description		Min	Тур	Max	Ullits
F <sub>GCLK</sub>	Reference clock frequency range <sup>(1)</sup>	CLK	60		350	MHz
T <sub>RCLK</sub>	Reference clock rise time	20% – 80%		200	400	ps
T <sub>FCLK</sub>	Reference clock fall time	80% – 20%		200	400	ps
T <sub>DCREF</sub>	Reference clock duty cycle <sup>(2)</sup>	CLK	40	50	60	%
T <sub>GJTT</sub>	Reference clock total jitter, peak-peak <sup>(3)</sup>	CLK			40	ps
T <sub>LOCK</sub>	Clock recovery frequency acquisition time	Initial PLL lock			1	ms
T <sub>PHASE</sub>	Clock recovery phase acquisition time	Lock to data after PLL has locked to the reference clock			200	μs

- 1. The clock from the GTP\_DUAL differential clock pin pair can be used for all serial bit rates. GREFCLK can be used for serial bit rates up to 1 Gb/s.
- 2. For reference clock rates above 325 MHz, a duty cycle of 45% to 55% must be maintained.
- 3. Measured at the package pin. GTP\_DUAL jitter characteristics measured using a clock with specification T<sub>GJTT</sub>.

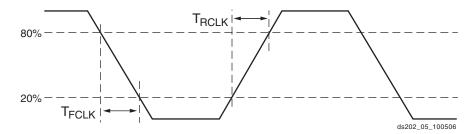


Figure 5: Reference Clock Timing Parameters



Table 33: GTP\_DUAL Tile User Clock Switching Characteristics(1)

Cumbal	Description	Conditions		Units		
Symbol		Conditions	-3	-2	-1	Units
F <sub>TXOUT</sub>	TXOUTCLK maximum frequency		375	375	320	MHz
F <sub>RXREC</sub>	RXRECCLK maximum frequency		375	375	320	MHz
T <sub>RX</sub>	RXUSRCLK maximum frequency		375	375	320	MHz
T <sub>RX2</sub>	RXUSRCLK2 maximum frequency	RXDATAWIDTH = 0	350	350	320	MHz
		RXDATAWIDTH = 1	187.5	187.5	160	MHz
T <sub>TX</sub>	TXUSRCLK maximum frequency		375	375	320	MHz
T <sub>TX2</sub>	TXUSRCLK2 maximum frequency	TXDATAWIDTH = 0	350	350	320	MHz
		TXDATAWIDTH = 1	187.5	187.5	160	MHz

Table 34: GTP\_DUAL Tile Transmitter Switching Characteristics

Symbol	Description		Min	Тур	Max	Units
F <sub>GTPTX</sub>	Serial data rate range		0.1		F <sub>GTPMAX</sub>	Gb/s
T <sub>RTX</sub>	TX Rise time			140		ps
T <sub>FTX</sub>	TX Fall time			120		ps
T <sub>LLSKEW</sub>	TX lane-to-lane skew <sup>(1)</sup>				855	ps
V <sub>TXOOBVDPP</sub>	Electrical idle amplitude				20	mV
T <sub>TXOOBTRANS</sub>	Electrical idle transition time				40	ns
T <sub>J3.75</sub>	Total Jitter <sup>(2)</sup>	3.75 Gb/s			0.35	UI
D <sub>J3.75</sub>	Deterministic Jitter <sup>(2)</sup>				0.19	UI
T <sub>J3.2</sub>	Total Jitter <sup>(2)</sup>	3.20 Gb/s			0.35	UI
D <sub>J3.2</sub>	Deterministic Jitter <sup>(2)</sup>				0.19	UI
T <sub>J2.5</sub>	Total Jitter <sup>(2)</sup>	2.50 Gb/s			0.30	UI
D <sub>J2.5</sub>	Deterministic Jitter <sup>(2)</sup>				0.14	UI
T <sub>J2.0</sub>	Total Jitter <sup>(2)</sup>	2.00 Gb/s			0.30	UI
D <sub>J2.0</sub>	Deterministic Jitter <sup>(2)</sup>				0.14	UI
T <sub>J1.25</sub>	Total Jitter <sup>(2)</sup>	1.25 Gb/s			0.20	UI
D <sub>J1.25</sub>	Deterministic Jitter <sup>(2)</sup>				0.10	UI
T <sub>J1.00</sub>	Total Jitter <sup>(2)</sup>	1.00 Gb/s			0.20	UI
D <sub>J1.00</sub>	Deterministic Jitter <sup>(2)</sup>				0.10	UI
T <sub>J500</sub>	Total Jitter <sup>(2)</sup>	500 Mb/s			0.10	UI
D <sub>J500</sub>	Deterministic Jitter <sup>(2)</sup>				0.04	UI
T <sub>J100</sub>	Total Jitter <sup>(2)</sup>	100 Mb/s			0.02	UI
D <sub>J100</sub>	Deterministic Jitter <sup>(2)</sup>				0.01	UI

- 1. Using same REFCLK input with TXENPMAPHASEALIGN enabled for up to four consecutive GTP\_DUAL sites.
- 2. Using PLL\_DIVSEL\_FB = 2, INTDATAWIDTH = 1.
- 3. All jitter values are based on a Bit-Error Ratio of  $1e^{-12}$ .

<sup>1.</sup> Clocking must be implemented as described in UG196: Virtex-5 FPGA RocketIO GTP Transceiver User Guide



Table 35: GTP\_DUAL Tile Receiver Switching Characteristics

Symbol	I	Description	Min	Тур	Max	Units
Г	Carial data rata	RX oversampler not enabled	0.5		F <sub>GTPMAX</sub>	Gb/s
F <sub>GTPRX</sub>	Serial data rate	RX oversampler enabled	0.1		0.5	Gb/s
R <sub>XOOBVDPP</sub>	OOB detect threshold peak-to-peak	OOBDETECT_THRESHOLD = 100	60	105	165	mV
R <sub>XSST</sub>	Receiver spread-spectrum tracking <sup>(1)</sup>	Modulated @ 33 KHz	-5000		0	ppm
R <sub>XRL</sub>	Run length (CID)	Internal AC capacitor bypassed			150	UI
		CDR 2 <sup>nd</sup> -order loop disabled with PLL_RXDIVSEL_OUT = 1 <sup>(3)</sup>	-200		200	ppm
R <sub>XPPMTOL</sub>	Data/REFCLK PPM offset tolerance <sup>(2)</sup>	CDR 2 <sup>nd</sup> -order loop disabled with PLL_RXDIVSEL_OUT = 2 <sup>(3)</sup>	-200		200	ppm
XI I MIGE	tolerance <sup>v-7</sup>	CDR 2 <sup>nd</sup> -order loop disabled with PLL_RXDIVSEL_OUT = 4 <sup>(3)</sup>	-100		100	ppm
		CDR 2 <sup>nd</sup> -order loop enabled	-1000		1000	ppm
SJ Jitter Tolerance <sup>(4)</sup>			*			•
JT_SJ <sub>3.75</sub>	Sinusoidal Jitter <sup>(5)</sup>	3.75 Gb/s	0.30			UI
JT_SJ <sub>3.2</sub>	Sinusoidal Jitter <sup>(5)</sup>	3.20 Gb/s	0.40			UI
JT_SJ <sub>2.50</sub>	Sinusoidal Jitter <sup>(5)</sup>	2.50 Gb/s	0.40			UI
JT_SJ <sub>2.00</sub>	Sinusoidal Jitter <sup>(5)</sup>	2.00 Gb/s	0.40			UI
JT_SJ <sub>1.00</sub>	Sinusoidal Jitter <sup>(5)</sup>	1.00 Gb/s	0.30			UI
JT_SJ <sub>500</sub>	Sinusoidal Jitter <sup>(5)</sup>	500 Mb/s	0.30			UI
JT_SJ <sub>500</sub>	Sinusoidal Jitter <sup>(5)</sup>	500 Mb/s OS	0.30			UI
JT_SJ <sub>100</sub>	Sinusoidal Jitter <sup>(5)</sup>	100 Mb/s OS	0.30			UI
SJ Jitter Tolerance w	rith Stressed Eye <sup>(4)</sup>					II.
JT_TJSE <sub>3.2</sub>	Total Jitter with Stressed Eye <sup>(6)</sup>	3.20 Gb/s	0.87			UI
JT_SJSE <sub>3.2</sub>	Sinusoidal Jitter with Stressed Eye <sup>(6)</sup>	3.20 Gb/s	0.30			UI

- 1. Using PLL\_RXDIVSEL\_OUT = 1 only.
- 2. Indicates the maximum offset between the receiver reference clock and the serial data. For example, a reference clock with ±100 ppm resolution results in a maximum offset of 200 ppm between the reference clock and the serial data.
- 3. CDR 1st-order step size set to 2.
- 4. All jitter values are based on a Bit Error Ratio of 1e<sup>-12</sup>.
- 5. Using 80 MHz sinusoidal jitter only in the absence of deterministic and random jitter.
- 6. Stimulus signal includes 0.4UI of DJ and 0.17UI of RJ. RX equalizer is enabled.



# **GTX\_DUAL Tile Specifications**

### **GTX DUAL Tile DC Characteristics**

Table 36: Absolute Maximum Ratings for GTX\_DUAL Tiles

Symbol	Description		Units
MGTAVCCPLL	Analog supply voltage for the GTX_DUAL shared PLL relative to GND	–0.5 to 1.1	V
MGTAVTTTX	Analog supply voltage for the GTX_DUAL transmitters relative to GND	-0.5 to 1.32	V
MGTAVTTRX	Analog supply voltage for the GTX_DUAL receivers relative to GND	-0.5 to 1.32	V
MGTAVCC	Analog supply voltage for the GTX_DUAL common circuits relative to GND	-0.5 to 1.1	V
MGTAVTTRXC	Analog supply voltage for the resistor calibration circuit of the GTX_DUAL column	-0.5 to 1.32	V

#### Notes:

Table 37: Recommended Operating Conditions for GTX\_DUAL Tiles(1)(2)

Symbol	Description		Max	Units
MGTAVCCPLL <sup>(1)</sup>	Analog supply voltage for the GTX_DUAL shared PLL relative to GND	0.95	1.05	V
MGTAVTTTX <sup>(1)</sup>	Analog supply voltage for the GTX_DUAL transmitters relative to GND	1.14	1.26	V
MGTAVTTRX <sup>(1)</sup>	Analog supply voltage for the GTX_DUAL receivers relative to GND	1.14	1.26	V
MGTAVCC <sup>(1)</sup>	Analog supply voltage for the GTX_DUAL common circuits relative to GND	0.95	1.05	V
MGTAVTTRXC <sup>(1)</sup>	Analog supply voltage for the resistor calibration circuit of the GTX_DUAL column	1.14	1.26	V

#### Notes:

- 1. Each voltage listed requires the filter circuit described in UG198: Virtex-5 FPGA RocketIO GTX Transceiver User Guide.
- 2. Voltages are specified for the temperature range of  $T_J = -40$ °C to +100°C.

Table 38: DC Characteristics Over Recommended Operating Conditions for GTX\_DUAL Tiles(1)

Symbol	Description		Тур	Max	Units
I <sub>MGTAVTTTX</sub>	GTX_DUAL tile transmitter termination supply current <sup>(2)</sup>		43.3	86.3	mA
I <sub>MGTAVCCPLL</sub>	GTX_DUAL tile shared PLL supply current		38.0	99.4	mA
I <sub>MGTAVTTRXC</sub>	GTX_DUAL tile resistor termination calibration supply current		0.1	0.5	mA
I <sub>MGTAVTTRX</sub>	GTX_DUAL tile receiver termination supply current <sup>(3)</sup>		40.3	56.5	mA
I <sub>MGTAVCC</sub>	GTX_DUAL tile internal analog supply current		80.5	179.5	mA
MGTR <sub>REF</sub>	Precision reference resistor for internal calibration termination 59.0 $\pm$ 1% tolerance		ance	Ω	

- 1. Typical values are specified at nominal voltage, 25°C, with a 3.2 Gb/s line rate.
- 2. I<sub>CC</sub> numbers are given per GTX\_DUAL tile with both GTX transceivers operating with default settings.
- 3. AC coupled TX/RX link.
- Values for currents other than the values specified in this table can be obtained by using the XPOWER Estimator (XPE) or XPOWER Analyzer (XPA) tools.

Stresses beyond those listed under Absolute Maximum Ratings might cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those listed under Operating Conditions is not implied. Exposure to Absolute Maximum Ratings conditions for extended periods of time might affect device reliability.



Table 39: GTX\_DUAL Tile Quiescent Supply Current

Symbol	Description	Typ <sup>(1)</sup>	Max	Units
I <sub>AVTTTXQ</sub>	Quiescent MGTAVTTTX (transmitter termination) supply current	8.2	21.6	mA
I <sub>AVCCPLLQ</sub>	Quiescent MGTAVCCPLL (PLL) supply current	0.8	4.8	mA
I <sub>AVTTRXQ</sub>	Quiescent MGTAVTTRX (receiver termination) supply current. Includes MGTAVTTRXCQ.		12.0	mA
I <sub>AVCCQ</sub>	Quiescent MGTAVCC (analog) supply current	9.0	50.4	mA

- Typical values are specified at nominal voltage, 25°C.
- 2. Device powered and unconfigured.
- 3. Currents for conditions other than values specified in this table can be obtained by using the XPOWER Estimator (XPE) or XPOWER Analyzer (XPA) tools.
- 4. GTX\_DUAL tile quiescent supply current for an entire device can be calculated by multiplying the values in this table by the number of available GTX\_DUAL tiles in the target TXT or FXT device.

## **GTX\_DUAL Tile DC Input and Output Levels**

Table 40 summarizes the DC output specifications of the GTX\_DUAL tiles in Virtex-5 FPGAs. Figure 6 shows the single-ended output voltage swing. Figure 7 shows the peak-to-peak differential output voltage.

Consult UG198: Virtex-5 FPGA RocketIO GTX Transceiver User Guide for further details.

Table 40: GTX\_DUAL Tile DC Specifications

Symbol	DC Parameter	Conditions	Min	Тур	Max	Units
DV	Differential peak-to-peak input	External AC coupled ≤ 4.25 Gb/s	125		1800	mV
DV <sub>PPIN</sub>	voltage	External AC coupled > 4.25 Gb/s	125		1800	mV
V <sub>IN</sub>	Absolute input voltage	DC coupled MGTAVTTRX = 1.2V	-400		MGTAVTTRX +400 up to 1320	mV
V <sub>CMIN</sub>	Common mode input voltage	DC coupled MGTAVTTRX = 1.2V		800		mV
DV <sub>PPOUT</sub>	Differential peak-to-peak output voltage <sup>(1)</sup>	TXBUFDIFFCTRL = 111			1400	mV
V <sub>SEOUT</sub>	Single-ended output voltage swing <sup>(1)</sup>	TXBUFDIFFCTRL = 111			700	mV
V <sub>CMOUT</sub>	Common mode output voltage	Equation based MGTAVTTTX = 1.2V		1200 – I	OV <sub>PPOUT</sub> /4	mV
R <sub>IN</sub>	Differential input resistance		85	100	120	Ω
R <sub>OUT</sub>	Differential output resistance		85	100	120	Ω
T <sub>OSKEW</sub>	Transmitter output skew			2	8	ps
$C_{EXT}$	Recommended external AC coup	pling capacitor <sup>(2)</sup>	75 100 200			nF

- The output swing and preemphasis levels are programmable using the attributes discussed in <u>UG198</u>: Virtex-5 FPGA RocketIO GTX Transceiver User Guide and can result in values lower than reported in this table.
- 2. Values outside of this range can be used as appropriate to conform to specific protocols and standards.

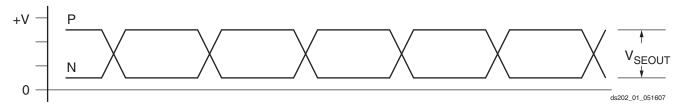


Figure 6: Single-Ended Output Voltage Swing

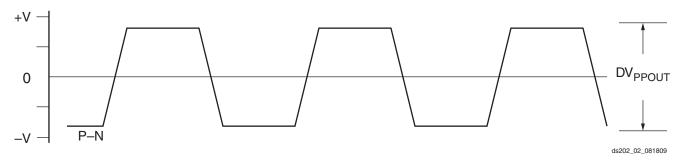


Figure 7: Peak-to-Peak Differential Output Voltage

Table 41 summarizes the DC specifications of the clock input of the GTX\_DUAL tile. Figure 8 shows the single-ended input voltage swing. Figure 9 shows the peak-to-peak differential clock input voltage swing. Consult <u>UG198</u>: *Virtex-5 FPGA RocketIO GTX Transceiver User Guide* for further details.

Table 41: GTX\_DUAL Tile Clock DC Input Level Specification(1)

Symbol	DC Parameter	Conditions	Min	Тур	Max	Units
$V_{IDIFF}$	Differential peak-to-peak input voltage		210	800	2000	mV
V <sub>ISE</sub>	Single-ended input voltage		105	400	1000	mV
R <sub>IN</sub>	Differential input resistance		90	105	130	Ω
C <sub>EXT</sub>	Required external AC coupling capacitor			100		nF

#### Notes:

1.  $V_{MIN} = 0V$  and  $V_{MAX} = 1200$ mV

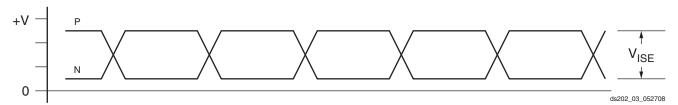


Figure 8: Single-Ended Clock Input Voltage Swing Peak-to-Peak

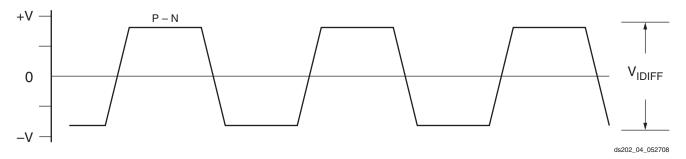


Figure 9: Differential Clock Input Voltage Swing Peak-to-Peak



# GTX\_DUAL Tile Switching Characteristics

Consult UG198: Virtex-5 FPGA RocketIO GTX Transceiver User Guide for further information.

Table 42: GTX DUAL Tile Performance

Symbol	Description		Speed Grade			
	Description	-3	-2	-1	Units	
F <sub>GTXMAX</sub>	Maximum GTX transceiver data rate	6.5	6.5	4.25	Gb/s	
F <sub>GPLLMAX</sub>	Maximum PLL frequency	3.25	3.25	3.25	GHz	
F <sub>GPLLMIN</sub>	Minimum PLL frequency	1.48	1.48	1.48	GHz	

Table 43: Dynamic Reconfiguration Port (DRP) in the GTX\_DUAL Tile Switching Characteristics

Symbol	Symbol Description	Speed Grade			Units
Syllibol	Description	-3	-2	-1	Ullits
F <sub>GTXDRPCLK</sub>	GTX DCLK (DRP clock) maximum frequency		175	150	MHz

Table 44: GTX\_DUAL Tile Reference Clock Switching Characteristics

Symbol	Description	Conditions	Α	Units		
Symbol	Description	Conditions	Min	Тур	Max	Units
F <sub>GCLK</sub>	Reference clock frequency range <sup>(1)</sup>	CLK	60		650	MHz
T <sub>RCLK</sub>	Reference clock rise time	20% – 80%		200		ps
T <sub>FCLK</sub>	Reference clock fall time	80% – 20%		200		ps
T <sub>DCREF</sub>	Reference clock duty cycle	CLK	40	50	60	%
T <sub>GJTT</sub>	Reference clock total jitter (2, 3)	At 100 KHz		-145		dBc/Hz
		At 1 MHz		-150		dBc/Hz
T <sub>LOCK</sub>	Clock recovery frequency acquisition time	Initial PLL lock		0.25	1	ms
T <sub>PHASE</sub>	Clock recovery phase acquisition time	Lock to data after PLL has locked to the reference clock			200	μs

- 1. GREFCLK can be used for serial bit rates up to 1 Gb/s; however, Jitter Specifications are not guaranteed when using GREFCLK.
- GTX\_DUAL jitter characteristics measured using a clock with specification T<sub>GJTT</sub>. A reference clock with higher phase noise can be used with link margin trade off.
- The selection of the reference clock is application dependent. This parameter describes the quality of the reference clock used during transceiver jitter characterization - see Table 46 and Table 47.

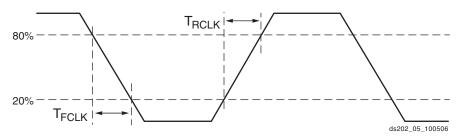


Figure 10: Reference Clock Timing Parameters



Table 45: GTX\_DUAL Tile User Clock Switching Characteristics(1)

Comphal	Description	Conditions	Davisa	;	Speed Grad	е	Units
Symbol	Description	Conditions	Device	-3	-2	-1	Units
F <sub>TXOUT</sub>	TXOUTCLK maximum frequency	Internal 20-bit datapath	FXT	325	325	212.5	MHz
			TXT	-	325	212.5	MHz
		Internal 16-bit datapath	FXT	406.25	406.25	265.625	MHz
			TXT	-	406.25	265.625	MHz
F <sub>RXREC</sub>	RXRECCLK maximum frequency		FXT	406.25	406.25	265.625	MHz
			TXT	-	406.25	265.625	MHz
T <sub>RX</sub>	RXUSRCLK maximum frequency		FXT	406.25	406.25	265.625	MHz
			TXT	-	406.25	265.625	MHz
T <sub>RX2</sub>	RXUSRCLK2 maximum frequency 1 byte interface FXT	FXT	375	312.5	235.625	MHz	
		2 byte interface		406.25	390.625	265.625	MHz
		4 byte interface		203.125	203.125	132.813	MHz
		1 byte interface	TXT	-	312.5	235.625	MHz
		2 byte interface		-	265.625	265.625	MHz
		4 byte interface		-	203.125	132.813	MHz
T <sub>TX</sub>	TXUSRCLK maximum frequency		FXT	406.25	406.25	265.625	MHz
			TXT	-	406.25	265.625	MHz
T <sub>TX2</sub>	TXUSRCLK2 maximum frequency	1 byte interface	FXT	375	312.5	235.625	MHz
		2 byte interface		406.25	390.625	265.625	MHz
		4 byte interface		203.125	203.125	132.813	MHz
		1 byte interface	TXT	-	312.5	235.625	MHz
		2 byte interface		-	265.625	265.625	MHz
		4 byte interface		-	203.125	132.813	MHz

Table 46: GTX\_DUAL Tile Transmitter Switching Characteristics

Symbol	Description	Condition	Min	Тур	Max	Units
F <sub>GTXTX</sub>	Serial data rate range	Serial data rate range			F <sub>GTXMAX</sub>	Gb/s
T <sub>RTX</sub>	TX Rise time	20%-80%		120		ps
T <sub>FTX</sub>	TX Fall time	80%–20%		120		ps
T <sub>LLSKEW</sub>	TX lane-to-lane skew <sup>(1)</sup>	1			350	ps
V <sub>TXOOBVDPP</sub>	Electrical idle amplitude				15	mV
T <sub>TXOOBTRANSITION</sub>	Electrical idle transition time				75	ns
T <sub>J6.5</sub>	Total Jitter <sup>(2)</sup>	6.5 Gb/s			0.33	UI
D <sub>J6.5</sub>	Deterministic Jitter <sup>(2)</sup>				0.17	UI
T <sub>J5.0</sub>	Total Jitter <sup>(2)</sup>	5.0 Gb/s			0.33	UI
D <sub>J5.0</sub>	Deterministic Jitter <sup>(2)</sup>				0.15	UI
T <sub>J4.25</sub>	Total Jitter <sup>(2)</sup>	4.25 Gb/s			0.33	UI
D <sub>J4.25</sub>	Deterministic Jitter <sup>(2)</sup>				0.14	UI

<sup>1.</sup> Clocking must be implemented as described in <u>UG198</u>: Virtex-5 FPGA RocketlO GTX Transceiver User Guide.



Table 46: GTX\_DUAL Tile Transmitter Switching Characteristics (Cont'd)

Symbol	Description	Condition	Min	Тур	Max	Units
T <sub>J3.75</sub>	Total Jitter <sup>(2)</sup>	3.75 Gb/s			0.34	UI
D <sub>J3.75</sub>	Deterministic Jitter <sup>(2)</sup>				0.16	UI
T <sub>J3.2</sub>	Total Jitter <sup>(2)</sup>	3.2 Gb/s			0.20	UI
D <sub>J3.2</sub>	Deterministic Jitter <sup>(2)</sup>				0.10	UI
T <sub>J3.2L</sub>	Total Jitter <sup>(2)</sup>	3.2 Gb/s <sup>(3)</sup>			0.36	UI
D <sub>J3.2L</sub>	Deterministic Jitter <sup>(2)</sup>				0.16	UI
T <sub>J2.5</sub>	Total Jitter <sup>(2)</sup>	2.5 Gb/s			0.20	UI
D <sub>J2.5</sub>	Deterministic Jitter <sup>(2)</sup>				0.08	UI
T <sub>J1.25</sub>	Total Jitter <sup>(2)</sup>	1.25 Gb/s			0.15	UI
D <sub>J1.25</sub>	Deterministic Jitter <sup>(2)</sup>				0.06	UI
T <sub>J750</sub>	Total Jitter <sup>(2)(4)</sup>	750 Mb/s			0.10	UI
D <sub>J750</sub>	Deterministic Jitter <sup>(2)(4)</sup>				0.03	UI
T <sub>J150</sub>	Total Jitter <sup>(2)(4)</sup>	150 Mb/s			0.02	UI
D <sub>J150</sub>	Deterministic Jitter <sup>(2)(4)</sup>				0.01	UI

- 1. Using same REFCLK input with TXENPMAPHASEALIGN enabled for up to four consecutive GTX\_DUAL sites.
- 2. Using PLL\_DIVSEL\_FB = 2, INTDATAWIDTH = 1. These values are NOT intended for protocol specific compliance determinations.
- 3. PLL frequency at 1.6 GHz and OUTDIV = 1.
- 4. GREFCLK can be used for serial data rates up to 1.0 Gb/s, but performance is not guaranteed.

Table 47: GTX\_DUAL Tile Receiver Switching Characteristics

Symbol	1	Description	Min	Тур	Max	Units
Е	Serial data rate	RX oversampler not enabled	0.75		F <sub>GTXMAX</sub>	Gb/s
F <sub>GTXRX</sub>	Serial data rate	RX oversampler enabled	0.15		0.75	Gb/s
T <sub>RXELECIDLE</sub>	Time for RXELECIDLE to respond to loss or restoration of data	OOBDETECT_THRESHOLD = 110			75	ns
R <sub>XOOBVDPP</sub>	OOB detect threshold peak-to-peak	OOBDETECT_THRESHOLD = 110	55		135	mV
R <sub>XSST</sub>	Receiver spread-spectrum tracking <sup>(1)</sup>	Modulated @ 33 KHz	-5000		0	ppm
R <sub>XRL</sub>	Run length (CID)	Internal AC capacitor bypassed			512	UI
В	Data/REFCLK PPM offset	CDR 2 <sup>nd</sup> -order loop disabled	-200		200	ppm
R <sub>XPPMTOL</sub>	tolerance <sup>(2)</sup>	CDR 2 <sup>nd</sup> -order loop enabled	-2000		2000	ppm
SJ Jitter Tolerance <sup>(3)</sup>						
JT_SJ <sub>6.5</sub>	Sinusoidal Jitter <sup>(4)</sup>	6.5 Gb/s	0.44			UI
JT_SJ <sub>5.0</sub>	Sinusoidal Jitter <sup>(4)</sup>	5.0 Gb/s	0.44			UI
JT_SJ <sub>4.25</sub>	Sinusoidal Jitter <sup>(4)</sup>	4.25 Gb/s	0.44			UI
JT_SJ <sub>3.75</sub>	Sinusoidal Jitter <sup>(4)</sup>	3.75 Gb/s	0.44			UI
JT_SJ <sub>3.2</sub>	Sinusoidal Jitter <sup>(4)</sup>	3.2 Gb/s	0.45			UI
JT_SJ <sub>3.2L</sub>	Sinusoidal Jitter <sup>(4)</sup>	3.2 Gb/s <sup>(5)</sup>	0.45			UI
JT_SJ <sub>2.5</sub>	Sinusoidal Jitter <sup>(4)</sup>	2.5 Gb/s	0.50			UI
JT_SJ <sub>1.25</sub>	Sinusoidal Jitter <sup>(4)</sup>	1.25 Gb/s	0.50			UI



Table 47: GTX\_DUAL Tile Receiver Switching Characteristics (Cont'd)

Symbol		Description	Min	Тур	Max	Units
JT_SJ <sub>750</sub>	Sinusoidal Jitter <sup>(4)(6)</sup>	750 Mb/s	0.57			UI
JT_SJ <sub>150</sub>	Sinusoidal Jitter <sup>(4)(6)</sup>	150 Mb/s	0.57			UI
SJ Jitter Tolerance with	Stressed Eye <sup>(3)</sup>					
JT_TJSE <sub>4.25</sub>	Total Jitter with Stressed Eye <sup>(7)</sup>	4.25 Gb/s	0.69			UI
JT_SJSE <sub>4.25</sub>	Sinusoidal Jitter with Stressed Eye <sup>(7)</sup>	4.25 Gb/s	0.1			UI

- 1. Using PLL\_RXDIVSEL\_OUT = 1, 2, and 4.
- Indicates the maximum offset between the receiver reference clock and the serial data. For example, a reference clock with ±100 ppm resolution results in a maximum offset of 200 ppm between the reference clock and the serial data.
- All jitter values are based on a Bit Error Ratio of 1e<sup>-12</sup>.
- 4. Using 80 MHz sinusoidal jitter only in the absence of deterministic and random jitter.
- 5. PLL frequency at 1.6 GHz and OUTDIV = 1.
- 6. GREFCLK can be used for serial data rates up to 1.0 Gb/s, but performance is not guaranteed.
- 7. Composite jitter with RX equalizer enabled. DFE disabled.

# **CRC Block Switching Characteristics**

Table 48: CRC Block Switching Characteristics

Symbol	Description	S	peed Grad	е	Units
Syllibol	Description	-3	-3 -2 -1		Units
F <sub>CRC</sub>	CRCCLK maximum frequency	325	325	270	MHz

# **Ethernet MAC Switching Characteristics**

Consult UG194: Virtex-5 FPGA Tri-mode Ethernet Media Access Controller User Guide for further information.

Table 49: Maximum Ethernet MAC Performance

Cumbal	Description Conditions		Speed Grade			Units
Symbol	Description	Conditions	-3	-2	-1	Units
F <sub>TEMACCLIENT</sub>	Client interface maximum frequency	10 Mb/s – 8-bit width	1.25	1.25	1.25	MHz
		100 Mb/s – 8-bit width	12.5	12.5	12.5	MHz
		1000 Mb/s - 8-bit width	125	125	125	MHz
		2000 Mb/s - 16-bit width	125	125	125	MHz
F <sub>TEMACPHY</sub>	Physical interface maximum frequency	10 Mb/s – 4-bit width	2.5	2.5	2.5	MHz
		100 Mb/s – 4-bit width	25	25	25	MHz
		1000 Mb/s – 8-bit width	125	125	125	MHz
		2000 Mb/s - 8-bit width	250	250	250	MHz

# **Endpoint Block for PCI Express Designs Switching Characteristics**

Consult <u>UG197</u>: Virtex-5 FPGA Integrated Endpoint Block for PCI Express Designs User Guide for further information.

Table 50: Maximum Performance for PCI Express Designs

Symbol	Description	Speed Grade		ed Grade	Units
Syllibol	Description	-3	-2	-1	Ullits
F <sub>PCIECORE</sub>	Core clock maximum frequency	250	250	250	MHz
F <sub>PCIEUSER</sub>	User clock maximum frequency	250	250	250	MHz



# **System Monitor Analog-to-Digital Converter Specification**

Table 51: Analog-to-Digital Specifications

Parameter	Symbol	Comments/Conditions	Min	Тур	Max	Units
$AV_{DD} = 2.5V \pm 2\%, V_{REFP} = 2.5\%$	V, V <sub>REFN</sub> = 0\	$I$ , ADCCLK = 5.2 MHz, $T_A = T_{MIN}$ to $T_{MAX}$ , Typic	al values	at T <sub>A</sub> =+2	25°C	
<b>DC Accuracy:</b> All external input and Common Mode = 0V	channels suc	ch as $V_P/V_N$ and $V_{AUXP}$ [15:0]/ $V_{AUXN}$ [15:0], Unip	olar Mode	Э,		
Resolution			10			Bits
Integral Nonlinearity	INL				±2	LSBs
Differential Nonlinearity	DNL	No missing codes (T <sub>MIN</sub> to T <sub>MAX</sub> ) Guaranteed Monotonic			±0.9	LSBs
Unipolar Offset Error <sup>(1)</sup>		Uncalibrated		±2	±30	LSBs
Bipolar Offset Error <sup>(1)</sup>		Uncalibrated measured in bipolar mode		±2	±30	LSBs
Gain Error <sup>(1)</sup>		Uncalibrated		±0.2	±2	%
Bipolar Gain Error <sup>(1)</sup>		Uncalibrated measured in bipolar mode		±0.2	±2	%
Total Unadjusted Error (Uncalibrated)	TUE	Deviation from ideal transfer function. V <sub>REFP</sub> - V <sub>REFN</sub> = 2.5V		±10		LSBs
Total Unadjusted Error (Calibrated)	TUE	Deviation from ideal transfer function. V <sub>REFP</sub> - V <sub>REFN</sub> = 2.5V		±1	±2	LSBs
Calibrated Gain Temperature Coefficient		Variation of FS code with temperature		±0.01		LSB/°C
DC Common-Mode Reject	CMRR <sub>DC</sub>	$V_N = V_{CM} = 0.5V \pm 0.5V,$ $V_P - V_N = 100mV$		70		dB
Conversion Rate <sup>(2)</sup>	1		ı	ı	I	
Conversion Time - Continuous	t <sub>CONV</sub>	Number of CLK cycles	26		32	
Conversion Time - Event	t <sub>CONV</sub>	Number of CLK cycles			21	
T/H Acquisition Time	t <sub>ACQ</sub>	Number of CLK cycles	4			
DRP Clock Frequency	DCLK	DRP clock frequency	8		250	MHz
ADC Clock Frequency	ADCCLK	Derived from DCLK	1		5.2	MHz
CLK Duty cycle			40		60	%
Analog Inputs <sup>(3)</sup>	1		I	I	1	
Dedicated Analog Inputs		Unipolar Operation	0		1	Volts
Input Voltage Range V <sub>P</sub> - V <sub>N</sub>		Differential Inputs	-0.25		+0.25	
Ab - AU		Unipolar Common Mode Range (FS input)	0		+0.5	
		Differential Common Mode Range (FS input)	+0.3		+0.7	
		Bandwidth		20		MHz
Auxiliary Analog Inputs		Unipolar Operation	0		1	Volts
Input Voltage Range		Differential Operation	-0.25		+0.25	
$V_{AUXP[0]}/V_{AUXN[0]}$ to $V_{AUXP[15]}/V_{AUXN[15]}$		Unipolar Common Mode Range (FS input)	0		+0.5	
		Differential Common Mode Range (FS input)	+0.3		+0.7	
		Bandwidth		10		kHz
Input Leakage Current		A/D not converting, ADCCLK stopped		±1.0		μA
Input Capacitance				10		pF
On-chip Supply Monitor Error		V <sub>CCINT</sub> and V <sub>CCAUX</sub> with calibration enabled			±1.0	% Reading
On-chip Temperature Monitor Error		-40°C to +125°C with calibration enabled			±4	°C



### Table 51: Analog-to-Digital Specifications (Cont'd)

Parameter	Symbol	Comments/Conditions	Min	Тур	Max	Units
External Reference Inputs <sup>(4)</sup>						
Positive Reference Input Voltage Range	V <sub>REFP</sub>	Measured Relative to V <sub>REFN</sub>	2.45	2.5	2.55	Volts
Negative Reference Input Voltage Range	V <sub>REFN</sub>	Measured Relative to AGND	-50	0	100	mV
Input current	I <sub>REF</sub>	ADCCLK = 5.2 MHz			100	μΑ
Power Requirements			<u> </u>			
Analog Power Supply	$AV_{DD}$	Measured Relative to AV <sub>SS</sub>	2.45	2.5	2.55	Volts
Analog Supply Current	Al <sub>DD</sub>	ADCCLK = 5.2 MHz	5		13	mA

- Offset and gain errors are removed by enabling the System Monitor automatic gain calibration feature. See <u>UG192</u>: Virtex-5 FPGA System Monitor User Guide.
- 2. See "System Monitor Timing" in UG192: Virtex-5 FPGA System Monitor User Guide.
- 3. See "Analog Inputs" in UG192: Virtex-5 FPGA System Monitor User Guide for a detailed description.
- 4. Any variation in the reference voltage from the nominal V<sub>REFP</sub> = 2.5V and V<sub>REFN</sub> = 0V will result is a deviation from the ideal transfer function. This also impacts the accuracy of the internal sensor measurements (i.e., temperature and power supply). However, for external ratiometric type applications allowing the supply voltage and reference to vary by ±2% is permitted.



# **Performance Characteristics**

This section provides the performance characteristics of some common functions and designs implemented in Virtex-5 devices. The numbers reported here are worst-case values; they have all been fully characterized. These values are subject to the same guidelines as the Switching Characteristics, page 30. Table 52 shows internal (register-to-register) performance.

Table 52: Register-to-Register Performance

	Register	-to-Register (with I	/O Delays)	
Description		Speed Grade		Units
	-3	-2	-1	
Basic Functions				
16:1 Multiplexer	550	500	450	MHz
32:1 Multiplexer	550	500	450	MHz
64:1 Multiplexer	511	467	407	MHz
9 x 9 Logic Multiplier with 4 pipe stages	468	438	428	MHz
9 x 9 Logic Multiplier with 5 pipe stages	550	500	428	MHz
16-bit Adder	550	500	450	MHz
32-bit Adder	550	500	447	MHz
64-bit Adder	423	377	323	MHz
Register to LUT to Register	550	500	450	MHz
16-bit Counter	550	500	450	MHz
32-bit Counter	550	500	450	MHz
64-bit Counter	428	381	333	MHz
Memory			1	
Cascaded block RAM (64K)	500	450	400	MHz
Block RAM Pipelined			1	1
Single-Port 512 x 36 bits	550	500	450	MHz
Single-Port 4096 x 4 bits	550	500	450	MHz
Dual-Port A: 4096 x 4 bits and B: 1024 x 18 bits	550	500	450	MHz
Distributed RAM			1	1
Single-Port 16 x 8	550	500	450	MHz
Single-Port 32 x 8	550	500	450	MHz
Single-Port 64 x 8	550	500	450	MHz
Dual-Port 16 x 8				MHz
Shift Register Chain	1	1	1	l
16-bit	550	500	450	MHz
32-bit	550	500	450	MHz
64-bit	550	500	438	MHz



Table 52: Register-to-Register Performance (Cont'd)

	Register	/O Delays)		
Description		Units		
	-3	-2	-1	
Dedicated Arithmetic Logic				
DSP48E Quad 12-bit Adder/Subtracter	550	500	450	MHz
DSP48E Dual 24-bit Adder/Subtracter	550	500	450	MHz
DSP48E 48-bit Adder/Subtracter	550	500	450	MHz
DSP48E 48-bit Counter	550	500	450	MHz
DSP48E 48-bit Comparator	550	500	450	MHz
DSP48E 25 x 18 bit Pipelined Multiplier	550	500	450	MHz
DSP48E Direct 4-tap FIR Filter Pipelined	510	458	397	MHz
DSP48E Systolic n-tap FIR Filter Pipelined	550	500	450	MHz

1. Device used is the XC5VLX50T- FF1136

Table 53: Interface Performances

Description		Speed Grade	
Description	-3	-2	-1
Networking Applications			
SFI-4.1 (SDR LVDS Interface) <sup>(1)</sup>	710 MHz	710 MHz	645 MHz
SPI-4.2 (DDR LVDS Interface) <sup>(2)</sup>	1.25 Gb/s	1.25 Gb/s	1.0 Gb/s
Memory Interfaces	1	<u>I</u>	1
DDR <sup>(3)</sup>	200 MHz	200 MHz	200 MHz
DDR2 <sup>(4)</sup>	333 MHz	300 MHz	267 MHz
QDR II SRAM <sup>(5)</sup>	300 MHz	300 MHz	250 MHz
RLDRAM II <sup>(6)</sup>	333 MHz	300 MHz	250 MHz

- Performance defined using design implementation described in application note XAPP856: SFI-4.1 16-Channel SDR Interface with Bus Alignment
- 2. Performance defined using design implementation described in application note XAPP860: 16-Channel, DDR LVDS Interface with Real-time Window Monitoring
- 3. Performance defined using design implementation described in application note XAPP851: DDR SDRAM Controller
- Performance defined using design implementation described in application note XAPP858: High-Performance DDR2 SDRAM Interface Data Capture
- 5. Performance defined using design implementation described in application note XAPP853: QDRII SRAM Interface
- 6. Performance defined using design implementation described in application note XAPP852: Synthesizable RLDRAM II Controller



# **Switching Characteristics**

All values represented in this data sheet are based on speed specification version 1.62. Switching characteristics are specified on a per-speed-grade basis and can be designated as Advance, Preliminary, or Production. Each designation is defined as follows:

#### **Advance**

These specifications are based on simulations only and are typically available soon after device design specifications are frozen. Although speed grades with this designation are considered relatively stable and conservative, some underreporting might still occur.

### **Preliminary**

These specifications are based on complete ES (engineering sample) silicon characterization. Devices and speed grades with this designation are intended to give a better indication of the expected performance of production silicon. The probability of under-reporting delays is greatly reduced as compared to Advance data.

#### **Production**

These specifications are released once enough production silicon of a particular device family member has been characterized to provide full correlation between specifications and devices over numerous production lots. There is no under-reporting of delays, and customers receive formal notification of any subsequent changes. Typically, the slowest speed grades transition to Production before faster speed grades.

All specifications are always representative of worst-case supply voltage and junction temperature conditions.

Since individual family members are produced at different times, the migration from one category to another depends completely on the status of the fabrication process for each device.

Table 54 correlates the current status of each Virtex-5 device on a per speed grade basis.

# **Testing of Switching Characteristics**

All devices are 100% functionally tested. Internal timing parameters are derived from measuring internal test patterns. Listed below are representative values.

Table 54: Virtex-5 Device Speed Grade Designations

Davis	Spe	ed Grade Desigr	nations
Device	Advance	Preliminary	Production
XC5VLX20T			-2, -1
XC5VLX30			-3, -2, -1
XC5VLX30T			-3, -2, -1
XC5VLX50			-3, -2, -1
XC5VLX50T			-3, -2, -1
XC5VLX85			-3, -2, -1
XC5VLX85T			-3, -2, -1
XC5VLX110			-3, -2, -1
XC5VLX110T			-3, -2, -1
XC5VLX155			-3, -2, -1
XC5VLX155T			-3, -2, -1
XC5VLX220			-2, -1
XC5VLX220T			-2, -1
XC5VLX330			-2, -1
XC5VLX330T			-2, -1
XC5VSX35T			-3, -2, -1
XC5VSX50T			-3, -2, -1
XC5VSX95T			-2, -1
XC5VSX240T			-2, -1
XC5VTX150T			-2, -1
XC5VTX240T			-2, -1
XC5VFX30T			-3, -2, -1
XC5VFX70T			-3, -2, -1
XC5VFX100T			-3, -2, -1
XC5VFX130T			-3, -2, -1
XC5VFX200T			-2, -1

For more specific, more precise, and worst-case guaranteed data, use the values reported by the static timing analyzer and back-annotate to the simulation net list. Unless otherwise noted, values apply to all Virtex-5 devices.



### **Production Silicon and ISE Software Status**

In some cases, a particular family member (and speed grade) is released to production before a speed specification is released with the correct label (Advance, Preliminary, Production). Any labeling discrepancies are corrected in subsequent speed specification releases. Table 55 lists the production released Virtex-5 family member, speed grade, and the minimum corresponding supported speed specification version and ISE® software revisions. The ISE software and speed specifications listed are the minimum releases required for production. All subsequent releases of software and speed specifications are valid.

**Table 55:** Virtex-5 Device Production Software and Speed Specification Release

Davisa	Speed Grad	e Designation	ons						
Device	-3	-2	-1						
XC5VLX20T	N/A ISE 10.1 SP2 v1.								
XC5VLX30	ISE 9.2i SP4 v1.58								
XC5VLX30T	ISE 9.2i	ISE 9.2i SP4 v1.58							
XC5VLX50	ISE 9.2i	SP4 v1.58							
XC5VLX50T	ISE 9.2i	SP4 v1.58							
XC5VLX85	ISE 9.2i	SP4 v1.58							
XC5VLX85T	ISE 9.2i	SP4 v1.58							
XC5VLX110	ISE 9.2i	SP4 v1.58							
XC5VLX110T	ISE 9.2i	SP4 v1.58							
XC5VLX155	ISE 10.1	SP2 v1.61							
XC5VLX155T	ISE 10.1	ISE 10.1 SP2 v1.61							
XC5VLX220	N/A	ISE 9.2i S	P4 v1.58						
XC5VLX220T	N/A	ISE 9.2i S	P4 v1.58						
XC5VLX330	N/A	ISE 9.2i S	P4 v1.58						
XC5VLX330T	N/A	ISE 9.2i S	P4 v1.58						
XC5VSX35T	ISE 9.2i	SP4 v1.58							
XC5VSX50T	ISE 9.2i	SP4 v1.58							
XC5VSX95T	N/A	ISE 9.2i S	P4 v1.58						
XC5VSX240T	N/A	ISE 10.1 S	SP3 v1.63						
XC5VTX150T	N/A	ISE 10.1 S	SP3 v1.63						
XC5VTX240T	N/A	ISE 10.1 S	SP3 v1.63						
XC5VFX30T	ISE 10.1	SP3 v1.63							
XC5VFX70T	ISE 10.1	SP3 v1.63							
XC5VFX100T	ISE 10.1	SP3 v1.63							
XC5VFX130T	ISE 10.1	SP3 v1.63							
XC5VFX200T	N/A	ISE 10.1 S	SP3 v1.63						

#### Notes:

 Blank entries indicate a device and/or speed grade in advance or preliminary status.



# IOB Pad Input/Output/3-State Switching Characteristics

Table 56 summarizes the values of standard-specific data input delay adjustments, output delays terminating at pads (based on standard) and 3-state delays.

T<sub>IOPI</sub> is described as the delay from IOB pad through the input buffer to the I-pin of an IOB pad. The delay varies depending on the capability of the SelectIO input buffer.

 $T_{IOOP}$  is described as the delay from the O pin to the IOB pad through the output buffer of an IOB pad. The delay varies depending on the capability of the SelectIO output buffer.

T<sub>IOTP</sub> is described as the delay from the T pin to the IOB pad through the output buffer of an IOB pad, when 3-state is disabled. The delay varies depending on the SelectIO capability of the output buffer.

Table 57 summarizes the value of T<sub>IOTPHZ</sub>. T<sub>IOTPHZ</sub> is described as the delay from the T pin to the IOB pad through the output buffer of an IOB pad, when 3-state is enabled (i.e., a high impedance state).

Table 56: IOB Switching Characteristics

	T <sub>IOPI</sub>			T <sub>IOOP</sub>						
I/O Standard	Sp	peed Gra	de	Speed Grade			Speed Grade			Units
	-3	-2	-1	-3	-2	-1	-3	-2	-1	
LVDS_25	0.80	0.90	1.06	1.13	1.29	1.44	1.13	1.29	1.44	ns
LVDSEXT_25	1.01	1.16	1.30	1.17	1.34	1.49	1.17	1.34	1.49	ns
HT_25	0.80	0.90	1.06	1.10	1.26	1.40	1.10	1.26	1.40	ns
BLVDS_25	0.80	0.90	1.06	1.24	1.38	1.58	1.24	1.38	1.58	ns
RSDS_25 (point to point)	0.80	0.90	1.06	1.13	1.29	1.44	1.13	1.29	1.44	ns
ULVDS_25	0.80	0.90	1.06	1.10	1.27	1.41	1.10	1.27	1.41	ns
PCl33_3	0.62	0.70	0.82	1.85	2.06	2.38	1.85	2.06	2.38	ns
PCI66_3	0.62	0.70	0.82	1.85	2.06	2.38	1.85	2.06	2.38	ns
PCI-X	0.62	0.70	0.82	1.40	1.56	1.80	1.40	1.56	1.80	ns
GTL	0.76	0.85	1.00	1.47	1.63	1.86	1.47	1.63	1.86	ns
GTLP	0.76	0.85	1.00	1.51	1.68	1.93	1.51	1.68	1.93	ns
HSTL_I	0.76	0.85	1.00	1.42	1.57	1.79	1.42	1.57	1.79	ns
HSTL_II	0.76	0.85	1.00	1.39	1.53	1.74	1.39	1.53	1.74	ns
HSTL_III	0.76	0.85	1.00	1.44	1.60	1.85	1.44	1.60	1.85	ns
HSTL_IV	0.76	0.85	1.00	1.44	1.60	1.83	1.44	1.60	1.83	ns
HSTL_I _18	0.76	0.85	1.00	1.40	1.55	1.77	1.40	1.55	1.77	ns
HSTL_II _18	0.76	0.85	1.00	1.36	1.51	1.72	1.36	1.51	1.72	ns
HSTL_III _18	0.76	0.85	1.00	1.45	1.61	1.85	1.45	1.61	1.85	ns
HSTL_IV_18	0.76	0.85	1.00	1.41	1.57	1.81	1.41	1.57	1.81	ns
SSTL2_I	0.76	0.85	1.00	1.48	1.64	1.87	1.48	1.64	1.87	ns
SSTL2_II	0.76	0.85	1.00	1.40	1.55	1.76	1.40	1.55	1.76	ns
LVTTL, Slow, 2 mA	0.62	0.70	0.82	4.10	4.47	5.01	4.10	4.47	5.01	ns
LVTTL, Slow, 4 mA	0.62	0.70	0.82	2.87	3.09	3.41	2.87	3.09	3.41	ns
LVTTL, Slow, 6 mA	0.62	0.70	0.82	2.66	2.91	3.29	2.66	2.91	3.29	ns
LVTTL, Slow, 8 mA	0.62	0.70	0.82	2.09	2.30	2.61	2.09	2.30	2.61	ns
LVTTL, Slow, 12 mA	0.62	0.70	0.82	1.94	2.15	2.46	1.94	2.15	2.46	ns
LVTTL, Slow, 16 mA	0.62	0.70	0.82	1.84	2.04	2.34	1.84	2.04	2.34	ns
LVTTL, Slow, 24 mA	0.62	0.70	0.82	1.87	2.07	2.38	1.87	2.07	2.38	ns



Table 56: IOB Switching Characteristics (Cont'd)

	T <sub>IOPI</sub>			T <sub>IOOP</sub>			Units			
I/O Standard	Sı	peed Gra	de	Speed Grade				T <sub>IOTP</sub> Speed Grade		
	-3	-2	-1	-3	-2	-1	-3	-2	-1	
LVTTL, Fast, 2 mA	0.62	0.70	0.82	3.32	3.61	4.05	3.32	3.61	4.05	ns
LVTTL, Fast, 4 mA	0.62	0.70	0.82	2.32	2.55	2.90	2.32	2.55	2.90	ns
LVTTL, Fast, 6 mA	0.62	0.70	0.82	2.10	2.31	2.63	2.10	2.31	2.63	ns
LVTTL, Fast, 8 mA	0.62	0.70	0.82	1.65	1.82	2.09	1.65	1.82	2.09	ns
LVTTL, Fast, 12 mA	0.62	0.70	0.82	1.47	1.63	1.89	1.47	1.63	1.89	ns
LVTTL, Fast, 16 mA	0.62	0.70	0.82	1.41	1.57	1.81	1.41	1.57	1.81	ns
LVTTL, Fast, 24 mA	0.62	0.70	0.82	1.36	1.52	1.74	1.36	1.52	1.74	ns
LVCMOS33, Slow, 2 mA	0.62	0.70	0.82	3.63	3.96	4.44	3.63	3.96	4.44	ns
LVCMOS33, Slow, 4 mA	0.62	0.70	0.82	2.82	3.09	3.49	2.82	3.09	3.49	ns
LVCMOS33, Slow, 6 mA	0.62	0.70	0.82	2.61	2.86	3.24	2.61	2.86	3.24	ns
LVCMOS33, Slow, 8 mA	0.62	0.70	0.82	2.06	2.26	2.57	2.06	2.26	2.57	ns
LVCMOS33, Slow, 12 mA	0.62	0.70	0.82	1.95	2.14	2.42	1.95	2.14	2.42	ns
LVCMOS33, Slow, 16 mA	0.62	0.70	0.82	1.86	2.04	2.31	1.86	2.04	2.31	ns
LVCMOS33, Slow, 24 mA	0.62	0.70	0.82	1.87	2.07	2.35	1.87	2.07	2.35	ns
LVCMOS33, Fast, 2 mA	0.62	0.70	0.82	2.94	3.20	3.59	2.94	3.20	3.59	ns
LVCMOS33, Fast, 4 mA	0.62	0.70	0.82	2.27	2.50	2.84	2.27	2.50	2.84	ns
LVCMOS33, Fast, 6 mA	0.62	0.70	0.82	2.06	2.27	2.59	2.06	2.27	2.59	ns
LVCMOS33, Fast, 8 mA	0.62	0.70	0.82	1.61	1.79	2.05	1.61	1.79	2.05	ns
LVCMOS33, Fast, 12 mA	0.62	0.70	0.82	1.45	1.61	1.86	1.45	1.61	1.86	ns
LVCMOS33, Fast, 16 mA	0.62	0.70	0.82	1.40	1.56	1.80	1.40	1.56	1.80	ns
LVCMOS33, Fast, 24 mA	0.62	0.70	0.82	1.35	1.51	1.74	1.35	1.51	1.74	ns
LVCMOS25, Slow, 2 mA	0.61	0.70	0.82	3.67	3.97	4.42	3.67	3.97	4.42	ns
LVCMOS25, Slow, 4 mA	0.61	0.70	0.82	2.37	2.60	2.94	2.37	2.60	2.94	ns
LVCMOS25, Slow, 6 mA	0.61	0.70	0.82	2.19	2.41	2.74	2.19	2.41	2.74	ns
LVCMOS25, Slow, 8 mA	0.61	0.70	0.82	2.05	2.26	2.56	2.05	2.26	2.56	ns
LVCMOS25, Slow, 12 mA	0.61	0.70	0.82	2.10	2.31	2.63	2.10	2.31	2.63	ns
LVCMOS25, Slow, 16 mA	0.61	0.70	0.82	1.84	2.02	2.30	1.84	2.02	2.30	ns
LVCMOS25, Slow, 24 mA	0.61	0.70	0.82	1.83	2.04	2.34	1.83	2.04	2.34	ns
LVCMOS25, Fast, 2 mA	0.61	0.70	0.82	3.14	3.41	3.82	3.14	3.41	3.82	ns
LVCMOS25, Fast, 4 mA	0.61	0.70	0.82	1.89	2.08	2.37	1.89	2.08	2.37	ns
LVCMOS25, Fast, 6 mA	0.61	0.70	0.82	1.74	1.92	2.20	1.74	1.92	2.20	ns
LVCMOS25, Fast, 8 mA	0.61	0.70	0.82	1.66	1.83	2.09	1.66	1.83	2.09	ns
LVCMOS25, Fast, 12 mA	0.61	0.70	0.82	1.52	1.69	1.94	1.52	1.69	1.94	ns
LVCMOS25, Fast, 16 mA	0.61	0.70	0.82	1.43	1.60	1.85	1.43	1.60	1.85	ns
LVCMOS25, Fast, 24 mA	0.61	0.70	0.82	1.40	1.54	1.76	1.40	1.54	1.76	ns



Table 56: IOB Switching Characteristics (Cont'd)

		T <sub>IOPI</sub>		T <sub>IOOP</sub>						
I/O Standard	S	peed Gra	de	Speed Grade			Speed Grade			Units
	-3	-2	-1	-3	-2	-1	-3	-2	-1	-
LVCMOS18, Slow, 2 mA	0.67	0.76	0.89	4.20	4.56	5.09	4.20	4.56	5.09	ns
LVCMOS18, Slow, 4 mA	0.67	0.76	0.89	3.03	3.32	3.75	3.03	3.32	3.75	ns
LVCMOS18, Slow, 6 mA	0.67	0.76	0.89	2.37	2.61	2.97	2.37	2.61	2.97	ns
LVCMOS18, Slow, 8 mA	0.67	0.76	0.89	2.15	2.37	2.69	2.15	2.37	2.69	ns
LVCMOS18, Slow, 12 mA	0.67	0.76	0.89	1.95	2.16	2.47	1.95	2.16	2.47	ns
LVCMOS18, Slow, 16 mA	0.67	0.76	0.89	1.93	2.14	2.45	1.93	2.14	2.45	ns
LVCMOS18, Fast, 2 mA	0.67	0.76	0.89	3.41	3.71	4.16	3.41	3.71	4.16	ns
LVCMOS18, Fast, 4 mA	0.67	0.76	0.89	2.36	2.61	2.98	2.36	2.61	2.98	ns
LVCMOS18, Fast, 6 mA	0.67	0.76	0.89	1.87	2.06	2.35	1.87	2.06	2.35	ns
LVCMOS18, Fast, 8 mA	0.67	0.76	0.89	1.69	1.87	2.13	1.69	1.87	2.13	ns
LVCMOS18, Fast, 12 mA	0.67	0.76	0.89	1.51	1.68	1.93	1.51	1.68	1.93	ns
LVCMOS18, Fast, 16 mA	0.67	0.76	0.89	1.44	1.61	1.86	1.44	1.61	1.86	ns
LVCMOS15, Slow, 2 mA	0.73	0.83	0.98	3.50	3.84	4.34	3.50	3.84	4.34	ns
LVCMOS15, Slow, 4 mA	0.73	0.83	0.98	2.17	2.40	2.74	2.17	2.40	2.74	ns
LVCMOS15, Slow, 6 mA	0.73	0.83	0.98	1.99	2.20	2.52	1.99	2.20	2.52	ns
LVCMOS15, Slow, 8 mA	0.73	0.83	0.98	1.91	2.12	2.43	1.91	2.12	2.43	ns
LVCMOS15, Slow, 12 mA	0.73	0.83	0.98	1.74	1.95	2.25	1.74	1.95	2.25	ns
LVCMOS15, Slow, 16 mA	0.73	0.83	0.98	1.71	1.91	2.20	1.71	1.91	2.20	ns
LVCMOS15, Fast, 2 mA	0.73	0.83	0.98	2.80	3.07	3.48	2.80	3.07	3.48	ns
LVCMOS15, Fast, 4 mA	0.73	0.83	0.98	1.76	1.95	2.23	1.76	1.95	2.23	ns
LVCMOS15, Fast, 6 mA	0.73	0.83	0.98	1.62	1.80	2.06	1.62	1.80	2.06	ns
LVCMOS15, Fast, 8 mA	0.73	0.83	0.98	1.57	1.74	2.00	1.57	1.74	2.00	ns
LVCMOS15, Fast, 12 mA	0.73	0.83	0.98	1.43	1.60	1.86	1.43	1.60	1.86	ns
LVCMOS15, Fast, 16 mA	0.73	0.83	0.98	1.37	1.53	1.77	1.37	1.53	1.77	ns
LVCMOS12, Slow, 2 mA	0.84	0.96	1.14	3.58	3.98	4.58	3.58	3.98	4.58	ns
LVCMOS12, Slow, 4 mA	0.84	0.96	1.14	2.10	2.33	2.66	2.10	2.33	2.66	ns
LVCMOS12, Slow, 6 mA	0.84	0.96	1.14	2.00	2.18	2.45	2.00	2.18	2.45	ns
LVCMOS12, Slow, 8 mA	0.84	0.96	1.14	1.91	2.14	2.48	1.91	2.14	2.48	ns
LVCMOS12, Fast, 2 mA	0.84	0.96	1.14	3.05	3.38	3.87	3.05	3.38	3.87	ns
LVCMOS12, Fast, 4 mA	0.84	0.96	1.14	1.71	1.91	2.20	1.71	1.91	2.20	ns
LVCMOS12, Fast, 6 mA	0.84	0.96	1.14	1.58	1.78	2.08	1.58	1.78	2.08	ns
LVCMOS12, Fast, 8 mA	0.84	0.96	1.14	1.52	1.70	1.97	1.52	1.70	1.97	ns
LVDCI_33	0.62	0.70	0.82	1.50	1.66	1.90	1.50	1.66	1.90	ns
LVDCI_25	0.61	0.70	0.82	1.55	1.71	1.93	1.55	1.71	1.93	ns
LVDCI_18	0.67	0.76	0.89	1.65	1.78	1.99	1.65	1.78	1.99	ns
LVDCI_15	0.73	0.83	0.98	1.58	1.75	2.02	1.58	1.75	2.02	ns
	-									



Table 56: IOB Switching Characteristics (Cont'd)

		T <sub>IOPI</sub>		T <sub>IOOP</sub>						
I/O Standard	Sį	oeed Gra	de	Speed Grade			Speed Grade			Units
	-3	-2	-1	-3	-2	-1	-3	-2	-1	
LVDCI_DV2_25	0.61	0.70	0.82	1.36	1.51	1.74	1.36	1.51	1.74	ns
LVDCI_DV2_18	0.67	0.76	0.89	1.43	1.60	1.85	1.43	1.60	1.85	ns
LVDCI_DV2_15	0.73	0.83	0.98	1.48	1.65	1.91	1.48	1.65	1.91	ns
GTL_DCI	0.76	0.85	1.00	1.36	1.47	1.65	1.36	1.47	1.65	ns
GTLP_DCI	0.76	0.85	1.00	1.37	1.52	1.76	1.37	1.52	1.76	ns
LVPECL_25	0.80	0.90	1.06	1.28	1.42	1.62	1.28	1.42	1.62	ns
HSTL_I_12	0.76	0.85	1.00	1.45	1.61	1.85	1.45	1.61	1.85	ns
HSTL_I_DCI	0.76	0.85	1.00	1.41	1.56	1.77	1.41	1.56	1.77	ns
HSTL_II_DCI	0.76	0.85	1.00	1.34	1.48	1.69	1.34	1.48	1.69	ns
HSTL_II_T_DCI	0.76	0.85	1.00	1.41	1.56	1.77	1.41	1.56	1.77	ns
HSTL_III_DCI	0.76	0.85	1.00	1.57	1.72	1.95	1.57	1.72	1.95	ns
HSTL_IV_DCI	0.76	0.85	1.00	1.34	1.46	1.64	1.34	1.46	1.64	ns
HSTL_I_DCI_18	0.76	0.85	1.00	1.36	1.50	1.70	1.36	1.50	1.70	ns
HSTL_II_DCI_18	0.76	0.85	1.00	1.30	1.43	1.64	1.30	1.43	1.64	ns
HSTL_II _T_DCI_18	0.76	0.85	1.00	1.36	1.50	1.70	1.36	1.50	1.70	ns
HSTL_III_DCI_18	0.76	0.85	1.00	1.55	1.69	1.91	1.55	1.69	1.91	ns
HSTL_IV_DCI_18	0.76	0.85	1.00	1.31	1.44	1.62	1.31	1.44	1.62	ns
DIFF_HSTL_I_18	0.80	0.90	1.06	1.40	1.55	1.77	1.40	1.55	1.77	ns
DIFF_HSTL_I_DCI_18	0.80	0.90	1.06	1.36	1.50	1.70	1.36	1.50	1.70	ns
DIFF_HSTL_I	0.80	0.90	1.06	1.42	1.57	1.79	1.42	1.57	1.79	ns
DIFF_HSTL_I_DCI	0.80	0.90	1.06	1.41	1.56	1.77	1.41	1.56	1.77	ns
DIFF_HSTL_II_18	0.80	0.90	1.06	1.36	1.51	1.72	1.36	1.51	1.72	ns
DIFF_HSTL_II_DCI_18	0.80	0.90	1.06	1.30	1.43	1.64	1.30	1.43	1.64	ns
DIFF_HSTL_II	0.80	0.90	1.06	1.39	1.53	1.74	1.39	1.53	1.74	ns
DIFF_HSTL_II_DCI	0.80	0.90	1.06	1.34	1.48	1.69	1.34	1.48	1.69	ns
SSTL2_I_DCI	0.76	0.85	1.00	1.42	1.56	1.78	1.42	1.56	1.78	ns
SSTL2_II_DCI	0.76	0.85	1.00	1.34	1.48	1.70	1.34	1.48	1.70	ns
SSTL2_II_T_DCI	0.76	0.85	1.00	1.42	1.56	1.78	1.42	1.56	1.78	ns
SSTL18_I	0.76	0.85	1.00	1.46	1.61	1.84	1.46	1.61	1.84	ns
SSTL18_II	0.76	0.85	1.00	1.39	1.53	1.75	1.39	1.53	1.75	ns
SSTL18_I_DCI	0.76	0.85	1.00	1.39	1.53	1.74	1.39	1.53	1.74	ns
SSTL18_II_DCI	0.76	0.85	1.00	1.30	1.44	1.64	1.30	1.44	1.64	ns
SSTL18_II_T_DCI	0.76	0.85	1.00	1.39	1.53	1.74	1.39	1.53	1.74	ns



Table 56: IOB Switching Characteristics (Cont'd)

	T <sub>IOPI</sub> Speed Grade			T <sub>IOOP</sub> Speed Grade			T <sub>IOTP</sub> Speed Grade			Units
I/O Standard										
	-3	-2	-1	-3	-2	-1	-3	-2	-1	
DIFF_SSTL2_I	0.80	0.90	1.06	1.48	1.64	1.87	1.48	1.64	1.87	ns
DIFF_SSTL2_I_DCI	0.80	0.90	1.06	1.42	1.56	1.78	1.42	1.56	1.78	ns
DIFF_SSTL18_I	0.80	0.90	1.06	1.46	1.61	1.84	1.46	1.61	1.84	ns
DIFF_SSTL18_I_DCI	0.80	0.90	1.06	1.39	1.53	1.74	1.39	1.53	1.74	ns
DIFF_SSTL2_II	0.80	0.90	1.06	1.40	1.55	1.76	1.40	1.55	1.76	ns
DIFF_SSTL2_II_DCI	0.80	0.90	1.06	1.34	1.48	1.70	1.34	1.48	1.70	ns
DIFF_SSTL18_II	0.80	0.90	1.06	1.39	1.53	1.75	1.39	1.53	1.75	ns
DIFF_SSTL18_II_DCI	0.80	0.90	1.06	1.30	1.44	1.64	1.30	1.44	1.64	ns

Table 57: IOB 3-state ON Output Switching Characteristics (T<sub>IOTPHZ</sub>)

Symbol	Description	S	Units		
Symbol	Description	-3	-2	-1	Units
T <sub>IOTPHZ</sub>	T input to Pad high-impedance	0.88	1.01	1.12	ns



## I/O Standard Adjustment Measurement Methodology

### **Input Delay Measurements**

Table 58 shows the test setup parameters used for measuring input delay.

Table 58: Input Delay Measurement Methodology

Description	I/O Standard Attribute	V <sub>L</sub> <sup>(1,2)</sup>	V <sub>H</sub> <sup>(1,2)</sup>	V <sub>MEAS</sub> (1,4,5)	V <sub>REF</sub> (1,3,5)
LVTTL (Low-Voltage Transistor-Transistor Logic)	LVTTL	0	3.0	1.4	-
LVCMOS (Low-Voltage CMOS), 3.3V	LVCMOS33	0	3.3	1.65	-
LVCMOS, 2.5V	LVCMOS25	0	2.5	1.25	-
LVCMOS, 1.8V	LVCMOS18	0	1.8	0.9	_
LVCMOS, 1.5V	LVCMOS15	0	1.5	0.75	-
LVCMOS, 1.2V	LVCMOS12	0	1.2	0.6	-
PCI (Peripheral Component Interconnect), 33 MHz, 3.3V	PCl33_3	Per	PCI™ Specification		-
PCI, 66 MHz, 3.3V	PCI66_3	Per	PCI Specification		_
PCI-X, 133 MHz, 3.3V	PCIX	Per P	CI-X™ Specification		-
GTL (Gunning Transceiver Logic)	GTL	V <sub>REF</sub> - 0.2	V <sub>REF</sub> + 0.2	V <sub>REF</sub>	0.80
GTL Plus	GTLP	V <sub>REF</sub> - 0.2	V <sub>REF</sub> + 0.2	V <sub>REF</sub>	1.0
HSTL (High-Speed Transceiver Logic), Class I & II	HSTL_I, HSTL_II	V <sub>REF</sub> – 0.5	V <sub>REF</sub> + 0.5	V <sub>REF</sub>	0.75
HSTL, Class III & IV	HSTL_III, HSTL_IV	V <sub>REF</sub> - 0.5	V <sub>REF</sub> + 0.5	V <sub>REF</sub>	0.90
HSTL, Class I & II, 1.8V	HSTL_I_18, HSTL_II_18	V <sub>REF</sub> – 0.5	V <sub>REF</sub> + 0.5	V <sub>REF</sub>	0.90
HSTL, Class III & IV, 1.8V	HSTL_III_18, HSTL_IV_18	V <sub>REF</sub> – 0.5	V <sub>REF</sub> + 0.5	V <sub>REF</sub>	1.08
SSTL (Stub Terminated Transceiver Logic), Class I & II, 3.3V	SSTL3_I, SSTL3_II	V <sub>REF</sub> – 1.00	V <sub>REF</sub> + 1.00	V <sub>REF</sub>	1.5
SSTL, Class I & II, 2.5V	SSTL2_I, SSTL2_II	V <sub>REF</sub> – 0.75	V <sub>REF</sub> + 0.75	V <sub>REF</sub>	1.25
SSTL, Class I & II, 1.8V	SSTL18_I, SSTL18_II	V <sub>REF</sub> – 0.5	V <sub>REF</sub> + 0.5	V <sub>REF</sub>	0.90
AGP-2X/AGP (Accelerated Graphics Port)	AGP	$V_{REF} - (0.2  \text{xV}_{CCO})$	$V_{REF} + (0.2  \text{xV}_{CCO})$	V <sub>REF</sub>	AGP Spec
LVDS (Low-Voltage Differential Signaling), 2.5V	LVDS_25	1.2 – 0.125	1.2 + 0.125	0(6)	
LVDSEXT (LVDS Extended Mode), 2.5V	LVDSEXT_25	1.2 – 0.125	1.2 + 0.125	0(6)	
LDT (HyperTransport), 2.5V	LDT_25	0.6 - 0.125	0.6 + 0.125	0(6)	
LVPECL (Low-Voltage Positive Emitter-Coupled Logic), 2.5V	LVPECL_25	1.15 – 0.3	1.15 – 0.3	0(6)	

- The input delay measurement methodology parameters for LVDCI are the same for LVCMOS standards of the same voltage. Input delay
  measurement methodology parameters for HSLVDCI are the same as for HSTL\_II standards of the same voltage. Parameters for all other DCI
  standards are the same for the corresponding non-DCI standards.
- 2. Input waveform switches between V<sub>L</sub>and V<sub>H</sub>.
- Measurements are made at typical, minimum, and maximum V<sub>REF</sub> values. Reported delays reflect worst case of these measurements. V<sub>REF</sub> values listed are typical.
- 4. Input voltage level from which measurement starts.
- 5. This is an input voltage reference that bears no relation to the V<sub>REF</sub> / V<sub>MEAS</sub> parameters found in IBIS models and/or noted in Figure 11.
- 6. The value given is the differential input voltage.

### **Output Delay Measurements**

Output delays are measured using a Tektronix P6245 TDS500/600 probe (< 1 pF) across approximately 4" of FR4 microstrip trace. Standard termination was used for all testing. The propagation delay of the 4" trace is characterized separately and subtracted from the final measurement, and is therefore not included in the generalized test setups shown in Figure 11 and Figure 12.

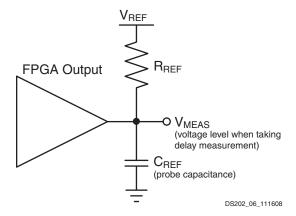


Figure 11: Single Ended Test Setup

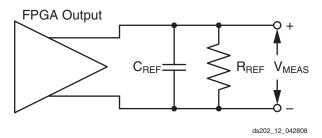


Figure 12: Differential Test Setup

Measurements and test conditions are reflected in the IBIS models except where the IBIS format precludes it. Parameters  $V_{REF}$ ,  $R_{REF}$ ,  $C_{REF}$ , and  $V_{MEAS}$  fully describe the test conditions for each I/O standard. The most accurate prediction of propagation delay in any given application can be obtained through IBIS simulation, using the following method:

- 1. Simulate the output driver of choice into the generalized test setup, using values from Table 59.
- Record the time to V<sub>MFAS</sub>.
- 3. Simulate the output driver of choice into the actual PCB trace and load, using the appropriate IBIS model or capacitance value to represent the load.
- Record the time to V<sub>MFAS</sub>.
- Compare the results of steps 2 and 4. The increase or decrease in delay yields the actual propagation delay of the PCB trace.

Table 59: Output Delay Measurement Methodology

Description	I/O Standard Attribute	R <sub>REF</sub> (Ω)	C <sub>REF</sub> <sup>(1)</sup> (pF)	V <sub>MEAS</sub> (V)	V <sub>REF</sub> (V)
LVTTL (Low-Voltage Transistor-Transistor Logic)	LVTTL (all)	1M	0	1.4	0
LVCMOS (Low-Voltage CMOS), 3.3V	LVCMOS33	1M	0	1.65	0
LVCMOS, 2.5V	LVCMOS25	1M	0	1.25	0
LVCMOS, 1.8V	LVCMOS18	1M	0	0.9	0
LVCMOS, 1.5V	LVCMOS15	1M	0	0.75	0
LVCMOS, 1.2V	LVCMOS12	1M	0	0.6	0
DCI (Devimberel Component Interface), 22 MHz, 2 2V	PCI33_3 (rising edge)	25	10 <sup>(2)</sup>	0.94	0
PCI (Peripheral Component Interface), 33 MHz, 3.3V	PCI33_3 (falling edge)	25	10 <sup>(2)</sup>	2.03	3.3
DCI 66 MHz 2 2V	PCI66_3 (rising edge)	25	10 <sup>(2)</sup>	0.94	0
PCI, 66 MHz, 3.3V	PCI66_3 (falling edge)	25	10 <sup>(2)</sup>	2.03	3.3
DCI V 100 MHz 2 2V	PCIX (rising edge)	25	10 <sup>(3)</sup>	0.94	
PCI-X, 133 MHz, 3.3V	PCIX (falling edge	25	10 <sup>(3)</sup>	2.03	3.3
GTL (Gunning Transceiver Logic)	GTL	25	0	0.8	1.2
GTL Plus	GTLP	25	0	1.0	1.5
HSTL (High-Speed Transceiver Logic), Class I	HSTL_I	50	0	V <sub>REF</sub>	0.75
HSTL, Class II	HSTL_II	25	0	V <sub>REF</sub>	0.75
HSTL, Class III	HSTL_III	50	0	0.9	1.5



Table 59: Output Delay Measurement Methodology (Cont'd)

Description	I/O Standard Attribute	R <sub>REF</sub> (Ω)	C <sub>REF</sub> <sup>(1)</sup> (pF)	V <sub>MEAS</sub> (V)	V <sub>REF</sub> (V)
HSTL, Class IV	HSTL_IV	25	0	0.9	1.5
HSTL, Class I, 1.8V	HSTL_I_18	50	0	V <sub>REF</sub>	0.9
HSTL, Class II, 1.8V	HSTL_II_18	25	0	V <sub>REF</sub>	0.9
HSTL, Class III, 1.8V	HSTL_III_18	50	0	1.1	1.8
HSTL, Class IV, 1.8V	HSTL_IV_18	25	0	1.1	1.8
SSTL (Stub Series Terminated Logic), Class I, 1.8V	SSTL18_I	50	0	V <sub>REF</sub>	0.9
SSTL, Class II, 1.8V	SSTL18_II	25	0	V <sub>REF</sub>	0.9
SSTL, Class I, 2.5V	SSTL2_I	50	0	$V_{REF}$	1.25
SSTL, Class II, 2.5V	SSTL2_II	25	0	$V_{REF}$	1.25
LVDS (Low-Voltage Differential Signaling), 2.5V	LVDS_25	100	0	0 <sup>(4)</sup>	1.2
LVDSEXT (LVDS Extended Mode), 2.5V	LVDS_25	100	0	0 <sup>(4)</sup>	1.2
BLVDS (Bus LVDS), 2.5V	BLVDS_25	100	0	0 <sup>(4)</sup>	0
LDT (HyperTransport), 2.5V	LDT_25	100	0	0 <sup>(4)</sup>	0.6
LVPECL (Low-Voltage Positive Emitter-Coupled Logic), 2.5V	LVPECL_25	100	0	0 <sup>(4)</sup>	0
LVDCI/HSLVDCI (Low-Voltage Digitally Controlled Impedance), 3.3V	LVDCI_33, HSLVDCI_33	1M	0	1.65	0
LVDCI/HSLVDCI, 2.5V	LVDCI_25, HSLVDCI_25	1M	0	1.25	0
LVDCI/HSLVDCI, 1.8V	LVDCI_18, HSLVDCI_18	1M	0	0.9	0
LVDCI/HSLVDCI, 1.5V	LVDCI_15, HSLVDCI_15	1M	0	0.75	0
HSTL (High-Speed Transceiver Logic), Class I & II, with DO	HSTL_I_DCI, HSTL_II_DCI	50	0	$V_{REF}$	0.75
HSTL, Class III & IV, with DCI	HSTL_III_DCI, HSTL_IV_DCI	50	0	0.9	1.5
HSTL, Class I & II, 1.8V, with DCI	HSTL_I_DCI_18, HSTL_II_DCI_18	50	0	$V_{REF}$	0.9
HSTL, Class III & IV, 1.8V, with DCI	HSTL_III_DCI_18, HSTL_IV_DCI_18	50	0	1.1	1.8
SSTL (Stub Series Termi.Logic), Class I & II, 1.8V, with DO	SSTL18_I_DCI, SSTL18_II_DCI	50	0	$V_{REF}$	0.9
SSTL, Class I & II, 2.5V, with DCI	SSTL2_I_DCI, SSTL2_II_DCI	50	0	V <sub>REF</sub>	1.25
GTL (Gunning Transceiver Logic) with DCI	GTL_DCI	50	0	0.8	1.2
GTL Plus with DCI	GTLP_DCI	50	0	1.0	1.5

- 1.  $C_{\mathsf{REF}}$  is the capacitance of the probe, nominally 0 pF.
- 2. Per PCI specifications.
- 3. Per PCI-X specifications.
- 4. The value given is the differential input voltage.



# **Input/Output Logic Switching Characteristics**

Table 60: ILOGIC Switching Characteristics

Symbol	Description		Speed Grad	le	I I mito
		-3	-2	-1	- Units
Setup/Hold					
T <sub>ICE1CK</sub> /T <sub>ICKCE1</sub>	CE1 pin Setup/Hold with respect to CLK	0.43 -0.24	0.49 -0.24	0.59 -0.24	ns
T <sub>ISRCK</sub> /T <sub>ICKSR</sub>	SR/REV pin Setup/Hold with respect to CLK	0.85 -0.20	1.00 -0.20	1.22 -0.20	ns
T <sub>IDOCK</sub> /T <sub>IOCKD</sub>	D pin Setup/Hold with respect to CLK without Delay	0.34 -0.12	0.37 -0.12	0.39 -0.12	ns
T <sub>IDOCKD</sub> /T <sub>IOCKDD</sub>	DDLY pin Setup/Hold with respect to CLK (using IODELAY)	0.31 -0.09	0.33 -0.09	0.36 -0.08	ns
Combinatorial			11		
T <sub>IDI</sub>	D pin to O pin propagation delay, no Delay	0.24	0.26	0.30	ns
T <sub>IDID</sub>	DDLY pin to O pin propagation delay (using IODELAY)	0.20	0.22	0.26	ns
Sequential Delays			11		
T <sub>IDLO</sub>	D pin to Q1 pin using flip-flop as a latch without Delay	0.44	0.50	0.58	ns
T <sub>IDLOD</sub>	DDLY pin to Q1 pin using flip-flop as a latch (using IODELAY)	0.41	0.46	0.55	ns
T <sub>ICKQ</sub>	CLK to Q outputs	0.47	0.52	0.60	ns
T <sub>RQ</sub>	SR/REV pin to OQ/TQ out	1.12	1.28	1.53	ns
T <sub>GSRQ</sub>	Global Set/Reset to Q outputs	7.30	7.30	10.10	ns
Set/Reset		•	•	•	
T <sub>RPW</sub>	Minimum Pulse Width, SR/REV inputs	0.78	0.95	1.20	ns, Min



Table 61: OLOGIC Switching Characteristics

Combal	Description	9	Speed Grad	de	Unito
Symbol		-3	-2	-1	Units
Setup/Hold					"
T <sub>ODCK</sub> /T <sub>OCKD</sub>	D1/D2 pins Setup/Hold with respect to CLK	0.30 -0.21	0.36 -0.21	0.44 -0.21	ns
T <sub>OOCECK</sub> /T <sub>OCKOCE</sub>	OCE pin Setup/Hold with respect to CLK	0.16 -0.07	0.19 -0.07	0.23 -0.07	ns
T <sub>OSRCK</sub> /T <sub>OCKSR</sub>	SR/REV pin Setup/Hold with respect to CLK	0.93 -0.20	1.02 -0.20	1.16 -0.20	ns
T <sub>OTCK</sub> /T <sub>OCKT</sub>	T1/T2 pins Setup/Hold with respect to CLK	0.28 -0.18	0.34 -0.18	0.41 -0.18	ns
T <sub>OTCECK</sub> /T <sub>OCKTCE</sub>	TCE pin Setup/Hold with respect to CLK	0.20 -0.06	0.23 -0.06	0.29 -0.06	ns
Combinatorial		-	1	1	
T <sub>DOQ</sub>	D1 to OQ out or T1 to TQ out	0.62	0.70	0.83	ns
Sequential Delays		'			
T <sub>OCKQ</sub>	CLK to OQ/TQ out	0.61	0.62	0.62	ns
T <sub>RQ</sub>	SR/REV pin to OQ/TQ out	1.63	1.89	2.27	ns
T <sub>GSRQ</sub>	Global Set/Reset to Q outputs	7.30	7.30	10.10	ns
Set/Reset		1	1	1	
T <sub>RPW</sub>	Minimum Pulse Width, SR/REV inputs	0.80	0.98	1.25	ns, Min
	·				



# Input Serializer/Deserializer Switching Characteristics

Table 62: ISERDES Switching Characteristics

Cumbal	Description	9	Speed Grade			
Symbol	Description	-3	-2	-1	Units	
Setup/Hold for Control Lines						
T <sub>ISCCK_BITSLIP</sub> / T <sub>ISCKC_BITSLIP</sub>	BITSLIP pin Setup/Hold with respect to CLKDIV	0.10 0.00	0.11 0.00	0.12 0.00	ns	
T <sub>ISCCK_CE</sub> / T <sub>ISCKC_CE</sub> <sup>(2)</sup>	CE pin Setup/Hold with respect to CLK (for CE1)	0.43 -0.24	0.49 -0.24	0.59 -0.24	ns	
T <sub>ISCCK_CE2</sub> / T <sub>ISCKC_CE2</sub> (2)	CE pin Setup/Hold with respect to CLKDIV (for CE2)	0.03 0.11	0.04 0.13	0.06 0.15	ns	
Setup/Hold for Data Lines					1	
T <sub>ISDCK_D</sub> /T <sub>ISCKD_D</sub>	D pin Setup/Hold with respect to CLK	0.34 -0.12	0.37 -0.12	0.39 -0.12	ns	
T <sub>ISDCK_DDLY</sub> /T <sub>ISCKD_DDLY</sub>	DDLY pin Setup/Hold with respect to CLK (using IODELAY)	0.31 -0.09	0.33 -0.09	0.36 -0.08	ns	
T <sub>ISDCK_DDR</sub> /T <sub>ISCKD_DDR</sub>	D pin Setup/Hold with respect to CLK at DDR mode	0.34 -0.12	0.37 -0.12	0.39 -0.12	ns	
TISDCK_DDLY_DDR TISCKD_DDLY_DDR	D pin Setup/Hold with respect to CLK at DDR mode (using IODELAY)	0.31 -0.09	0.33 -0.09	0.36 -0.08	ns	
Sequential Delays						
T <sub>ISCKO_Q</sub>	CLKDIV to out at Q pin	0.46	0.51	0.60	ns	
Propagation Delays						
T <sub>ISDO_DO</sub>	D input to DO output pin	0.20	0.22	0.26	ns	

- 1. Recorded at 0 tap value.
- 2.  $T_{ISCCK\_CE2}$  and  $T_{ISCKC\_CE2}$  are reported as  $T_{ISCCK\_CE}/T_{ISCKC\_CE}$  in TRACE report.



# **Output Serializer/Deserializer Switching Characteristics**

Table 63: OSERDES Switching Characteristics

Cumbal	December	9	Speed Grade			
Symbol	Description	-3	-2	-1	Units	
Setup/Hold						
T <sub>OSDCK_D</sub> /T <sub>OSCKD_D</sub>	D input Setup/Hold with respect to CLKDIV	0.21 -0.02	0.24 -0.02	0.30 -0.02	ns	
T <sub>OSDCK_T</sub> /T <sub>OSCKD_T</sub> <sup>(1)</sup>	T input Setup/Hold with respect to CLK	0.28 -0.18	0.34 -0.18	0.41 -0.18	ns	
T <sub>OSDCK_T2</sub> /T <sub>OSCKD_T2</sub> <sup>(1)</sup>	T input Setup/Hold with respect to CLKDIV	0.21 -0.03	0.24 -0.03	0.28 -0.03	ns	
T <sub>OSCCK_OCE</sub> /T <sub>OSCKC_OCE</sub>	OCE input Setup/Hold with respect to CLK	0.16 -0.07	0.19 -0.07	0.23 -0.07	ns	
T <sub>OSCCK_S</sub>	SR (Reset) input Setup with respect to CLKDIV	0.52	0.58	0.70	ns	
T <sub>OSCCK_TCE</sub> /T <sub>OSCKC_TCE</sub>	TCE input Setup/Hold with respect to CLK	0.20 -0.06	0.23 -0.06	0.29 -0.06	ns	
Sequential Delays						
T <sub>OSCKO_OQ</sub>	Clock to out from CLK to OQ	0.59	0.60	0.61	ns	
T <sub>OSCKO_TQ</sub>	Clock to out from CLK to TQ	0.61	0.62	0.62	ns	
Combinatorial		•		1		
T <sub>OSDO_TTQ</sub>	T input to TQ Out	0.62	0.70	0.83	ns	
T <sub>OSCO_OQ</sub>	Asynchronous Reset to OQ	1.57	1.82	2.19	ns	
T <sub>OSCO_TQ</sub>	Asynchronous Reset to TQ	1.63	1.89	2.27	ns	

<sup>1.</sup>  $T_{OSDCK\_T2}$  and  $T_{OSCKD\_T2}$  are reported as  $T_{OSDCK\_T}/T_{OSCKD\_T}$  in TRACE report.



# **Input/Output Delay Switching Characteristics**

Table 64: Input/Output Delay Switching Characteristics

Ohad	Donasistics.		I I a i k a		
Symbol	Description	-3	-2	-1	Units
IDELAYCTRL					
T <sub>IDELAYCTRLCO_RDY</sub>	Reset to Ready for IDELAYCTRL	3.00	3.00	3.00	μs
F <sub>IDELAYCTRL_REF</sub>	REFCLK frequency	200.00	200.00	200.00	MHz
IDELAYCTRL_REF_PRECISION	REFCLK precision	±10	±10	±10	MHz
T <sub>IDELAYCTRL_RPW</sub>	Minimum Reset pulse width	50.00	50.00	50.00	ns
IODELAY					
T <sub>IDELAYRESOLUTION</sub>	IODELAY Chain Delay Resolution	1/(	64 x F <sub>REF</sub> x 1e	6)(1)	ps
T	Pattern dependent period jitter in delay chain for clock pattern	0	0	0	Note 2
I IDELAYPAT_JIT	Pattern dependent period jitter in delay chain for random data pattern (PRBS 23)	±5	±5	±5	Note 2
T <sub>IODELAY_CLK_MAX</sub>	Maximum frequency of CLK input to IODELAY	300	250	250	MHz
T <sub>IODCCK_CE</sub> / T <sub>IODCKC_CE</sub>	CE pin Setup/Hold with respect to CK	0.29 -0.06	0.34 -0.06	0.42 -0.06	ns
T <sub>IODCK_INC</sub> / T <sub>IODCKC_INC</sub>	INC pin Setup/Hold with respect to CK	0.18 0.02	0.20 0.04	0.24 0.06	ns
T <sub>IODCK_RST</sub> / T <sub>IODCKC_RST</sub>	RST pin Setup/Hold with respect to CK	0.25 -0.12	0.28 -0.12	0.33 -0.12	ns
T <sub>IODDO_T</sub>	TSCONTROL delay to MUXE/MUXF switching and through IODELAY	Note 3	Note 3	Note 3	
T <sub>IODDO_IDATAIN</sub>	Propagation delay through IODELAY	Note 3	Note 3	Note 3	
T <sub>IODDO_ODATAIN</sub>	Propagation delay through IODELAY	Note 3	Note 3	Note 3	

#### Notes:

- 1. Average Tap Delay at 200 MHz = 78 ps.
- 2. Units in ps, peak-to-peak per tap, in High Performance mode.
- 3. Delay depends on IODELAY tap setting. See TRACE report for actual values.

## **CLB Switching Characteristics**

Table 65: CLB Switching Characteristics

Cumbal	December	S	Speed Grade			
Symbol	Description	-3	-2	-1	Units	
Combinatorial Delay	vs					
T <sub>ILO</sub>	An – Dn LUT address to A	0.08	0.09	0.10	ns, Max	
	An – Dn LUT address to AMUX/CMUX	0.20	0.22	0.25	ns, Max	
	An – Dn LUT address to BMUX_A	0.31	0.35	0.40	ns, Max	
T <sub>ITO</sub>	An – Dn inputs to A – D Q outputs	0.67	0.77	0.90	ns, Max	
T <sub>AXA</sub>	AX inputs to AMUX output	0.39	0.44	0.53	ns, Max	
T <sub>AXB</sub>	AX inputs to BMUX output	0.46	0.52	0.61	ns, Max	
T <sub>AXC</sub>	AX inputs to CMUX output	0.31	0.36	0.42	ns, Max	
T <sub>AXD</sub>	AX inputs to DMUX output	0.55	0.62	0.73	ns, Max	
T <sub>BXB</sub>	BX inputs to BMUX output	0.36	0.41	0.48	ns, Max	
T <sub>BXD</sub>	BX inputs to DMUX output	0.45	0.51	0.59	ns, Max	



Table 65: CLB Switching Characteristics (Cont'd)

Ohl	Description	9	Speed Grade			
Symbol	Description	-3	-2	-1	Units	
T <sub>CXB</sub>	CX inputs to CMUX output	0.33	0.36	0.42	ns, Max	
T <sub>CXD</sub>	CX inputs to DMUX output	0.37	0.42	0.49	ns, Max	
T <sub>DXD</sub>	DX inputs to DMUX output	0.38	0.42	0.49	ns, Max	
T <sub>OPCYA</sub>	An input to COUT output	0.43	0.50	0.59	ns, Max	
T <sub>OPCYB</sub>	Bn input to COUT output	0.39	0.44	0.51	ns, Max	
T <sub>OPCYC</sub>	Cn input to COUT output	0.33	0.37	0.43	ns, Max	
T <sub>OPCYD</sub>	Dn input to COUT output	0.30	0.34	0.40	ns, Max	
T <sub>AXCY</sub>	AX input to COUT output	0.36	0.42	0.50	ns, Max	
T <sub>BXCY</sub>	BX input to COUT output	0.26	0.30	0.37	ns, Max	
T <sub>CXCY</sub>	CX input to COUT output	0.20	0.22	0.26	ns, Max	
T <sub>DXCY</sub>	DX input to COUT output	0.20	0.22	0.26	ns, Max	
T <sub>BYP</sub>	CIN input to COUT output	0.09	0.10	0.11	ns, Max	
T <sub>CINA</sub>	CIN input to AMUX output	0.24	0.27	0.31	ns, Max	
T <sub>CINB</sub>	CIN input to BMUX output	0.27	0.30	0.35	ns, Max	
T <sub>CINC</sub>	CIN input to CMUX output	0.29	0.32	0.36	ns, Max	
T <sub>CIND</sub>	CIN input to DMUX output	0.31	0.35	0.41	ns, Max	
Sequential Delays	;	1	1		1	
T <sub>CKO</sub>	Clock to AQ – DQ outputs	0.35	0.40	0.47	ns, Max	
Setup and Hold Ti	mes of CLB Flip-Flops Before/After Clock CLK	"	1	1	1	
T <sub>DICK</sub> /T <sub>CKDI</sub>	AX – DX input to CLK on A – D Flip Flops	0.36 0.19	0.41 0.21	0.49 0.24	ns, Min	
T <sub>RCK</sub>	DX input to CLK when used as REV	0.37	0.42	0.51	ns, Min	
T <sub>CECK</sub> /T <sub>CKCE</sub>	CE input to CLK on A – D Flip Flops	0.18 -0.04	0.20 -0.04	0.23 -0.04	ns, Min	
T <sub>SRCK</sub> /T <sub>CKSR</sub>	SR input to CLK on A – D Flip Flops	0.41 -0.19	0.49 -0.19	0.59 -0.19	ns, Min	
T <sub>CINCK</sub> /T <sub>CKCIN</sub>	CIN input to CLK on A – D Flip Flops	0.14 0.14	0.16 0.16	0.18 0.19	ns, Min	
Set/Reset		I	I .		II.	
T <sub>SRMIN</sub>	SR input minimum pulse width	0.90	0.90	0.90	ns, Min	
T <sub>RQ</sub>	Delay from SR or REV input to AQ – DQ flip-flops	0.74	0.86	1.03	ns, Max	
T <sub>CEO</sub>	Delay from CE input to AQ – DQ flip-flops	0.46	0.52	0.63	ns, Max	
F <sub>TOG</sub>	Toggle frequency (for export control)	1412	1265	1098	MHz	

<sup>1.</sup> A Zero "0" Hold Time listing indicates no hold time or a negative hold time. Negative values cannot be guaranteed "best-case", but if a "0" is listed, there is no positive hold time.

<sup>2.</sup> These items are of interest for Carry Chain applications.



## **CLB Distributed RAM Switching Characteristics (SLICEM Only)**

Table 66: CLB Distributed RAM Switching Characteristics

Symbol	Description	9	Speed Grade			
	Description	-3	-2	-1	Units	
Sequential Delays	s					
T <sub>SHCKO</sub>	Clock to A – B outputs	1.08	1.26	1.54	ns, Max	
T <sub>SHCKO_1</sub>	Clock to AMUX – BMUX outputs	1.19	1.38	1.68	ns, Max	
Setup and Hold T	imes Before/After Clock CLK					
T <sub>DS</sub> /T <sub>DH</sub>	A – D inputs to CLK	0.72 0.20	0.84 0.22	1.03 0.26	ns, Min	
T <sub>AS</sub> /T <sub>AH</sub>	Address An inputs to clock	0.41 0.20	0.46 0.22	0.54 0.27	ns, Min	
T <sub>WS</sub> /T <sub>WH</sub>	WE input to clock	0.34 -0.06	0.39 -0.04	0.46 -0.02	ns, Min	
T <sub>CECK</sub> /T <sub>CKCE</sub>	CE input to CLK	0.36 -0.08	0.42 -0.07	0.51 -0.06	ns, Min	
Clock CLK		,	1	1	l .	
T <sub>MPW</sub>	Minimum pulse width	0.70	0.82	1.00	ns, Min	
T <sub>MCP</sub>	Minimum clock period	1.40	1.64	2.00	ns, Min	

#### Notes:

## **CLB Shift Register Switching Characteristics (SLICEM Only)**

Table 67: CLB Shift Register Switching Characteristics

O	Description	S	Speed Grad	le	11
Symbol		-3	-2	-1	- Units
Sequential Delays					
T <sub>REG</sub>	Clock to A – D outputs	1.23	1.43	1.73	ns, Max
T <sub>REG_MUX</sub>	Clock to AMUX – DMUX output	1.33	1.55	1.87	ns, Max
T <sub>REG_M31</sub>	Clock to DMUX output via M31 output	0.99	1.15	1.38	ns, Max
Setup and Hold Time	es Before/After Clock CLK				
T <sub>WS</sub> /T <sub>WH</sub>	WE input	0.21 -0.06	0.24 -0.04	0.29 -0.02	ns, Min
T <sub>CECK</sub> /T <sub>CKCE</sub>	CE input to CLK	0.23 -0.08	0.27 -0.07	0.33 -0.06	ns, Min
T <sub>DS</sub> /T <sub>DH</sub>	A – D inputs to CLK	0.57 0.07	0.66 0.09	0.78 0.11	ns, Min
Clock CLK					
T <sub>MPW</sub>	Minimum pulse width	0.60	0.70	0.85	ns, Min

<sup>1.</sup> A Zero "0" Hold Time listing indicates no hold time or a negative hold time. Negative values cannot be guaranteed "best-case", but if a "0" is listed, there is no positive hold time.

<sup>2.</sup> TSHCKO also represents the CLK to XMUX output. Refer to TRACE report for the CLK to XMUX path.

A Zero "0" Hold Time listing indicates no hold time or a negative hold time. Negative values cannot be guaranteed "best-case", but if a "0" is listed, there is no positive hold time.



# **Block RAM and FIFO Switching Characteristics**

Table 68: Block RAM and FIFO Switching Characteristics

Symbol	Description	9	Units		
Symbol	Description	-3	-2	-1	Ullits
Block RAM and FIFO Clock to	Out Delays				
T <sub>RCKO_DO</sub> and T <sub>RCKO_DOR</sub> <sup>(1)</sup>	Clock CLK to DOUT output (without output register) <sup>(2,3)</sup>	1.79	1.92	2.19	ns, Max
	Clock CLK to DOUT output (with output register) <sup>(4,5)</sup>	0.61	0.69	0.82	ns, Max
	Clock CLK to DOUT output with ECC (without output register) <sup>(2,3)</sup>	2.64	3.03	3.61	ns, Max
	Clock CLK to DOUT output with ECC (with output register) <sup>(4,5)</sup>	0.66	0.77	0.93	ns, Max
	Clock CLK to DOUT output with Cascade (without output register) <sup>(2)</sup>	2.10	2.44	2.94	ns, Max
	Clock CLK to DOUT output with Cascade (with output register) <sup>(4)</sup>	0.91	1.07	1.30	ns, Max
T <sub>RCKO_FLAGS</sub>	Clock CLK to FIFO flags outputs <sup>(6)</sup>	0.76	0.87	1.02	ns, Max
T <sub>RCKO_POINTERS</sub>	Clock CLK to FIFO pointer outputs <sup>(7)</sup>	1.10	1.26	1.48	ns, Max
T <sub>RCKO_ECCR</sub>	Clock CLK to BITERR (with output register)	0.66	0.77	0.93	ns, Max
T <sub>RCKO_ECC</sub>	Clock CLK to BITERR (without output register)	2.48	2.85	3.41	ns, Max
	Clock CLK to ECCPARITY in standard ECC mode	1.29	1.47	1.74	ns, Max
	Clock CLK to ECCPARITY in ECC encode only mode	0.77	0.89	1.05	ns, Max
Setup and Hold Times Before	/After Clock CLK			ll.	<u> </u>
T <sub>RCCK_ADDR</sub> /T <sub>RCKC_ADDR</sub>	ADDR inputs <sup>(8)</sup>	0.34 0.30	0.40 0.32	0.48 0.36	ns, Min
T <sub>RDCK_DI</sub> /T <sub>RCKD_DI</sub>	DIN inputs <sup>(9)</sup>	0.27 0.28	0.30 0.28	0.35 0.29	ns, Min
T <sub>RDCK_DI_ECC</sub> /T <sub>RCKD_DI_ECC</sub>	DIN inputs with ECC in standard mode <sup>(9)</sup>	0.33 0.32	0.37 0.33	0.42 0.36	ns, Min
	DIN inputs with ECC encode only <sup>(9)</sup>	0.68 0.32	0.72 0.33	0.77 0.36	ns, Min
T <sub>RCCK_EN</sub> /T <sub>RCKC_EN</sub>	Block RAM Enable (EN) input	0.32 0.15	0.36 0.15	0.42 0.15	ns, Min
T <sub>RCCK_REGCE</sub> /T <sub>RCKC_REGCE</sub>	CE input of output register	0.15 0.22	0.16 0.24	0.18 0.27	ns, Min
T <sub>RCCK_SSR</sub> /T <sub>RCKC_SSR</sub>	Synchronous Set/ Reset (SSR) input	0.17 0.23	0.21 0.25	0.26 0.28	ns, Min
T <sub>RCCK_WE</sub> /T <sub>RCKC_WE</sub>	Write Enable (WE) input	0.44 0.16	0.51 0.17	0.63 0.18	ns, Min
T <sub>RCCK_WREN</sub> /T <sub>RCKC_WREN</sub>	WREN/RDEN FIFO inputs <sup>(10)</sup>	0.36 0.30	0.41 0.34	0.48 0.40	ns, Min



Table 68: Block RAM and FIFO Switching Characteristics (Cont'd)

Symbol	December	S	Speed Grade			
	Description	-3	-2	-1	Units	
Reset Delays		·				
T <sub>RCO_FLAGS</sub>	Reset RST to FIFO Flags/Pointers <sup>(11)</sup>	1.10	1.26	1.48	ns, Max	
Maximum Frequency						
F <sub>MAX</sub>	Block RAM in all modes	550	500	450	MHz	
F <sub>MAX_CASCADE</sub>	Block RAM in cascade configuration	500	450	400	MHz	
F <sub>MAX_FIFO</sub>	FIFO in all modes	550	500	450	MHz	
F <sub>MAX_ECC</sub>	Block RAM and FIFO in ECC configuration	415	375	325	MHz	

- 1. TRACE will report all of these parameters as T<sub>RCKO\_DO</sub>.
- 2. T<sub>RCKO DOR</sub> includes T<sub>RCKO DOW</sub>, T<sub>RCKO DOPR</sub>, and T<sub>RCKO DOPW</sub> as well as the B port equivalent timing parameters.
- 3. These parameters also apply to synchronous FIFO with DO\_REG = 0.
- 4.  $T_{RCKO\_DO}$  includes  $T_{RCKO\_DOP}$  as well as the B port equivalent timing parameters.
- 5. These parameters also apply to multirate (asynchronous) and synchronous FIFO with DO\_REG = 1.
- $\textbf{6.} \quad \textbf{T}_{RCKO\_FLAGS} \text{ includes the following parameters: } \textbf{T}_{RCKO\_AEMPTY}, \textbf{T}_{RCKO\_AFULL}, \textbf{T}_{RCKO\_EMPTY}, \textbf{T}_{RCKO\_FULL}, \textbf{T}_{RCKO\_RDERR}, \textbf{T}_{RCKO\_WRERR}.$
- 7. T<sub>RCKO\_POINTERS</sub> includes both T<sub>RCKO\_RDCOUNT</sub> and T<sub>RCKO\_WRCOUNT</sub>.
- 8. The ADDR setup and hold must be met when EN is asserted even though WE is deasserted. Otherwise, block RAM data corruption is possible.
- 9.  $T_{RCKO\ DI}$  includes both A and B inputs as well as the parity inputs of A and B.
- 10. These parameters also apply to RDEN.
- 11. T<sub>RCO FLAGS</sub> includes the following flags: AEMPTY, AFULL, EMPTY, FULL, RDERR, WRERR, RDCOUNT, and WRCOUNT.

## **DSP48E Switching Characteristics**

Table 69: DSP48E Switching Characteristics

Complete I	Description		Speed		Units
Symbol	Description	-3	-2	-1	Units
Setup and Hold Times of Data/Control Pins to the Inp	out Register Clock			•	
TDSPDCK_{AA, BB, ACINA, BCINB}/ TDSPCKD_{AA, BB, ACINA, BCINB}	{A, B, ACIN, BCIN} input to {A, B} register CLK	0.17 0.17	0.21 0.23	0.26 0.30	ns
TDSPDCK_CC/TDSPCKD_CC	C input to C register CLK	0.14 0.26	0.16 0.31	0.20 0.37	ns
Setup and Hold Times of Data Pins to the Pipeline Re	egister Clock	l	l	1	l .
TDSPDCK_{AM, BM, ACINM, BCINM}/ TDSPCKD_{AM, BM, ACINM, BCINM}	{A, B, ACIN, BCIN} input to M register CLK	1.30 0.19	1.44 0.19	1.71 0.19	ns
Setup and Hold Times of Data/Control Pins to the Ou	tput Register Clock	I	I	1.	II.
TDSPDCK_{AP, BP, ACINP, BCINP}_M/ TDSPCKD_{AP, BP, ACINP, BCINP}_M	{A, B, ACIN, BCIN} input to P register CLK using multiplier	2.39 -0.30	2.74 -0.30	3.25 -0.30	ns
TDSPDCK_{AP, BP, ACINP, BCINP}_NM/ TDSPCKD_{AP, BP, ACINP, BCINP}_NM	{A, B, ACIN, BCIN} input to P register CLK not using multiplier	1.35 -0.10	1.54 -0.10	1.83 -0.10	ns
TDSPDCK_CP/TDSPCKD_CP	C input to P register CLK	1.30 -0.13	1.42 -0.13	1.70 -0.13	ns
TDSPDCK_{PCINP, CRYCINP, MULTSIGNINP}/ TDSPCKD_{PCINP, CRYCINP, MULTSIGNINP}	{PCIN, CARRYCASCIN, MULTSIGNIN} input to P register CLK	1.06 0.11	1.17 0.11	1.31 0.11	ns
Setup and Hold Times of the CE Pins		l	l	1	l .
TDSPCCK_{CEA1A, CEA2A, CEB1B, CEB2B}/ TDSPCKC_{CEA1A, CEA2A, CEB1A, CEB2B}	{CEA1, CEA2A, CEB1B, CEB2B} input to {A, B} register CLK	0.24 0.21	0.28 0.25	0.33 0.31	ns
TDSPCCK_CECC/TDSPCKC_CECC	CEC input to C register CLK	0.19 0.17	0.21 0.21	0.26 0.28	ns



Table 69: DSP48E Switching Characteristics (Cont'd)

Symbol	Description	Speed			Units
Symbol	Description	-3	-2	-1	Units
TDSPCCK_CEMM/TDSPCKC_CEMM	CEM input to M register CLK	0.25 0.18	0.29 0.21	0.36 0.26	ns
TDSPCCK_CEPP/TDSPCKC_CEPP	CEP input to P register CLK	0.56 0.01	0.63 0.01	0.73 0.01	ns
Setup and Hold Times of the RST Pins					
TDSPCCK_{RSTAA, RSTBB}/ TDSPCKC_{RSTAA, RSTBB}	{RSTA, RSTB} input to {A, B} register CLK	0.24 0.23	0.28 0.26	0.33 0.31	ns
TDSPCCK_RSTCC/ TDSPCKC_RSTCC	RSTC input to C register CLK	0.19 0.17	0.21 0.21	0.26 0.28	ns
TDSPCCK_RSTMM/ TDSPCKC_RSTMM	RSTM input to M register CLK	0.25 0.18	0.29 0.21	0.36 0.26	ns
TDSPCCK_RSTPP/TDSPCKC_RSTPP	RSTP input to P register CLK	0.56 0.01	0.63 0.01	0.73 0.01	ns
Combinatorial Delays from Input Pins to Output Pins	8				
TDSPDO_{AP, ACRYOUT, BP, BCRYOUT}_M	{A, B} input to {P, CARRYOUT} output using multiplier	2.78	3.22	3.84	ns
TDSPDO_{AP, ACRYOUT, BP, BCRYOUT}_NM	{A, B} input to {P, CARRYOUT} output not using multiplier	1.59	1.77	2.22	ns
TDSPDO_{CP, CCRYOUT, CRYINP, CRYINCRYOUT}	{C, CARRYIN} input to {P, CARRYOUT} output	1.50	1.67	2.08	ns
Combinatorial Delays from Input Pins to Cascading	Output Pins				
TDSPDO_{AACOUT, BBCOUT}	{A, B} input to {ACOUT, BCOUT} output	1.00	1.12	1.31	ns
TDSPDO_{APCOUT, ACRYCOUT, AMULTSIGNOUT, BPCOUT, BCRYCOUT, BMULTSIGNOUT}_M	{A, B} input to {PCOUT, CARRYCASCOUT, MULTSIGNOUT} output using multiplier	2.78	3.22	3.84	ns
TDSPDO_{APCOUT, ACRYCOUT, AMULTSIGNOUT, BPCOUT, BCRYCOUT, BMULTSIGNOUT}_NM	{A, B} input to {PCOUT, CARRYCASCOUT, MULTSIGNOUT} output not using multiplier	1.72	1.92	2.42	ns
TDSPDO_{CPCOUT, CCRYCOUT, CMULTSIGNOUT, CRYINPCOUT, CRYINCRYCOUT, CRYINMULTSIGNOUT}	{C, CARRYIN} input to {PCOUT, CARRYCASCOUT, MULTSIGNOUT} output	1.63	1.82	2.28	ns
Combinatorial Delays from Cascading Input Pins to	All Output Pins				
TDSPDO_{ACINP, ACINCRYOUT, BCINP, BCINCRYOUT}_M	{ACIN, BCIN} input to {P, CARRYOUT} output using multiplier	2.78	3.22	3.84	ns
TDSPDO_{ACINP, ACINCRYOUT, BCINP, BCINCRYOUT}_NM	{ACIN, BCIN} input to {P, CARRYOUT} output not using multiplier	1.59	1.77	2.22	ns
TDSPDO_{ACINACOUT, BCINBCOUT}	{ACIN, BCIN} input to {ACOUT, BCOUT} output	1.00	1.12	1.31	ns
TDSPDO_{ACINPCOUT, ACINCRYCOUT, ACINMULTSIGNOUT, BCINPCOUT, BCINCRYCOUT, BCINMULTSIGNOUT}_M	{ACIN, BCIN} input to {PCOUT, CARRYCASCOUT, MULTSIGNOUT} output using multiplier	2.78	3.22	3.84	ns
TDSPDO_{ACINPCOUT, ACINCRYCOUT, ACINMULTSIGNOUT, BCINPCOUT, BCINCRYCOUT, BCINMULTSIGNOUT}_NM	{ACIN, BCIN} input to {PCOUT, CARRYCASCOUT, MULTSIGNOUT} output not using multiplier	1.72	1.92	2.42	ns
TDSPDO_{PCINP, CRYCINP, MULTSIGNINP, PCINCRYOUT, CRYCINCRYOUT, MULTSIGNINCRYOUT}	{PCIN, CARRYCASCIN, MULTSIGNIN} input to {P, CARRYOUT} output	1.30	1.45	1.82	ns



Table 69: DSP48E Switching Characteristics (Cont'd)

Symbol	Description		Speed		Units	
Symbol	Description		-2	-1	Units	
TDSPDO_{PCINPCOUT, CRYCINPCOUT, MULTSIGNINPCOUT, PCINCRYCOUT, CRYCINCRYCOUT, MULTSIGNINCRYCOUT, PCINMULTSIGNOUT, CRYCINMULTSIGNOUT, MULTSIGNINMULTSIGNOUT}	{PCIN, CARRYCASCIN, MULTSIGNIN} input to {PCOUT, CARRYCASCOUT, MULTSIGNOUT} output	1.43	1.60	2.02	ns	
Clock to Outs from Output Register Clock to Output	Pins					
TDSPCKO_{PP, CRYOUTP}	CLK (PREG) to {P, CARRYOUT} output	0.45	0.48	0.56	ns	
TDSPCKO_{CRYCOUTP, PCOUTP, MULTSIGNOUTP}	CLK (PREG) to {CARRYCASCOUT, PCOUT, MULTSIGNOUT} output	0.48	0.53	0.62	ns	
Clock to Outs from Pipeline Register Clock to Output	t Pins					
TDSPCKO_{PM, CRYOUTM}	CLK (MREG) to {P, CARRYOUT} output	1.81	2.10	2.47	ns	
TDSPCKO_{PCOUTM, CRYCOUTM, MULTSIGNOUTM}	CLK (MREG) to {PCOUT, CARRYCASCOUT, MULTSIGNOUT} output	1.91	2.13	2.66	ns	
Clock to Outs from Input Register Clock to Output Pi	ns					
TDSPCKO_{PA, CRYOUTA, PB, CRYOUTB}_M	CLK (AREG, BREG) to {P, CARRYOUT} output using multiplier	3.09	3.57	4.23	ns	
TDSPCKO_{PA, CRYOUTA, PB, CRYOUTB}_NM	CLK (AREG, BREG) to {P, CARRYOUT} output not using multiplier	1.90	2.11	2.63	ns	
TDSPCKO_{PC, CRYOUTC}	CLK (CREG) to {P, CARRYOUT} output	1.89	2.11	2.62	ns	
Clock to Outs from Input Register Clock to Cascading	g Output Pins					
TDSPCKO_{ACOUTA, BCOUTB}	CLK (AREG, BREG) to {ACOUT, BCOUT}	0.61	0.68	0.79	ns	
TDSPCKO_{PCOUTA, CRYCOUTA, MULTSIGNOUTA, PCOUTB, CRYCOUTB, MULTSIGNOUTB}_M	CLK (AREG, BREG) to {PCOUT, CARRYCASCOUT, MULTSIGNOUT} output using multiplier	3.09	3.57	4.23	ns	
TDSPCKO_{PCOUTA, CRYCOUTA, MULTSIGNOUTA, PCOUTB, CRYCOUTB, MULTSIGNOUTB}_NM	CLK (AREG, BREG) to {PCOUT, CARRYCASCOUT, MULTSIGNOUT} output not using multiplier	2.03	2.27	2.82	ns	
TDSPCKO_{PCOUTC, CRYCOUTC, MULTSIGNOUTC}	CLK (CREG) to {PCOUT, CARRYCASCOUT, MULTSIGNOUT} output	2.03	2.26	2.82	ns	
Maximum Frequency			1	Ц	1	
F <sub>MAX</sub>	With all registers used	550	500	450	MHz	
F <sub>MAX_PATDET</sub>	With pattern detector	515	465	410	MHz	
F <sub>MAX_MULT_NOMREG</sub>	Two register multiply without MREG	374	324	275	MHz	
F <sub>MAX_MULT_NOMREG_PATDET</sub>	Two register multiply without MREG with pattern detect	345	300	254	MHz	



# **Configuration Switching Characteristics**

Table 70: Configuration Switching Characteristics

Cumbal	Description	5	Speed Grad	de	Units
Symbol	Description	-3	-2	-1	Units
Power-up Timing Characteris	stics				
T <sub>PL</sub>	Program Latency	3	3	3	ms, Max
T <sub>POR</sub>	Power-on-Reset	10 50	10 50	10 50	ms, Min/Max
T <sub>ICCK</sub>	CCLK (output) delay	400	400	400	ns, Min
T <sub>PROGRAM</sub>	Program Pulse Width	250	250	250	ns, Min
Master/Slave Serial Mode Pro	ogramming Switching <sup>(1)</sup>				
T <sub>DCCK</sub> /T <sub>CCKD</sub>	DIN Setup/Hold, slave mode	4.0 0.0	4.0 0.0	4.0 0.0	ns, Min
T <sub>DSCCK</sub> /T <sub>SCCKD</sub>	DIN Setup/Hold, master mode	4.0 0.0	4.0 0.0	4.0 0.0	ns, Min
T <sub>CCO</sub>	DOUT	7.5	7.5	7.5	ns, Max
F <sub>MCCK</sub>	Maximum Frequency, master mode with respect to nominal CCLK.	100	100	100	MHz, Max
F <sub>MCCKTOL</sub>	Frequency Tolerance, master mode with respect to nominal CCLK.	±50	±50	±50	%
F <sub>MSCCK</sub>	Slave mode external CCLK	100	100	100	MHz
SelectMAP Mode Programmi	ng Switching <sup>(1)</sup>		1	1	
T <sub>SMDCCK</sub> /T <sub>SMCCKD</sub>	SelectMAP Data Setup/Hold	3.0 0.5	3.0 0.5	3.0 0.5	ns, Min
T <sub>SMCSCCK</sub> /T <sub>SMCCKCS</sub>	CS_B Setup/Hold	3.0 0.5	3.0 0.5	3.0 0.5	ns, Min
T <sub>SMCCKW</sub> /T <sub>SMWCCK</sub>	RDWR_B Setup/Hold	8.0 0.5	8.0 0.5	8.0 0.5	ns, Min
T <sub>SMCKCSO</sub>	CSO_B clock to out (330 $\Omega$ pull-up resistor required)	10	10	10	ns, Min
T <sub>SMCO</sub>	CCLK to DATA out in readback	9.0	9.0	9.0	ns, Max
T <sub>SMCKBY</sub>	CCLK to BUSY out in readback	7.5	7.5	7.5	ns, Max
F <sub>SMCCK</sub>	Maximum Frequency with respect to nominal CCLK.	100	100	100	MHz, Max
F <sub>RBCCK</sub>	Maximum Readback Frequency with respect to nominal CCLK	60	60	60	MHz, Max
F <sub>MCCKTOL</sub>	Frequency Tolerance with respect to nominal CCLK.	±50	±50	±50	%
Boundary-Scan Port Timing S	Specifications			-1	
T <sub>TAPTCK</sub>	TMS and TDI Setup time before TCK	1.0	1.0	1.0	ns, Min
T <sub>TCKTAP</sub>	TMS and TDI Hold time after TCK	2.0	2.0	2.0	ns, Min
T <sub>TCKTDO</sub>	TCK falling edge to TDO output valid	6	6	6	ns, Max
F <sub>TCK</sub>	Maximum configuration TCK clock frequency	66	66	66	MHz, Max
F <sub>TCKB</sub>	Maximum boundary-scan TCK clock frequency	66	66	66	MHz, Max



Table 70: Configuration Switching Characteristics (Cont'd)

Combal	Decements	5	Speed Grad	Heite	
Symbol	Description	-3	-2	-1	- Units
BPI Master Flash Mode Programm	ning Switching			•	
T <sub>BPICCO</sub> <sup>(4)</sup>	ADDR[25:0], RS[1:0], FCS_B, FOE_B, FWE_B outputs valid after CCLK rising edge	10	10	10	ns
T <sub>BPIDCC</sub> /T <sub>BPICCD</sub>	Setup/Hold on D[15:0] data input pins	3.0 0.5	3.0 0.5	3.0 0.5	ns
T <sub>INITADDR</sub>	Minimum period of initial ADDR[25:0] address cycles	3.0	3.0	3.0	CCLK cycles
SPI Master Flash Mode Programm	ning Switching		1	II.	
T <sub>SPIDCC</sub> /T <sub>SPIDCCD</sub>	DIN Setup/Hold before/after the rising CCLK edge	4.0 0.0	4.0 0.0	4.0 0.0	ns
T <sub>SPICCM</sub>	MOSI clock to out	10	10	10	ns
T <sub>SPICCFC</sub>	FCS_B clock to out	10	10	10	ns
T <sub>FSINIT</sub> /T <sub>FSINITH</sub>	FS[2:0] to INIT_B rising edge Setup and Hold	2	2	2	μs
CCLK Output (Master Modes)			1	1	
T <sub>MCCKL</sub>	Master CCLK clock minimum Low time	3.0	3.0	3.0	ns, Min
T <sub>MCCKH</sub>	Master CCLK clock minimum High time	3.0	3.0	3.0	ns, Min
CCLK Input (Slave Modes)			1	1	
T <sub>SCCKL</sub>	Slave CCLK clock minimum Low time	2.0	2.0	2.0	ns, Min
T <sub>SCCKH</sub>	Slave CCLK clock minimum High time	2.0	2.0	2.0	ns, Min
Dynamic Reconfiguration Port (D	RP) for DCM and PLL Before and After DCLK				
F <sub>DCK</sub>	Maximum frequency for DCLK	500	450	400	MHz
T <sub>DMCCK_DADDR</sub> /T <sub>DMCKC_DADDR</sub>	DADDR Setup/Hold	1.2 0.0	1.35 0.0	1.56 0.0	ns
T <sub>DMCCK_DI</sub> /T <sub>DMCKC_DI</sub>	DI Setup/Hold	1.2 0.0	1.35 0.0	1.56 0.0	ns
T <sub>DMCCK_DEN</sub> /T <sub>DMCKC_DEN</sub>	DEN Setup/Hold time	1.2 0.0	1.35 0.0	1.56 0.0	ns
T <sub>DMCCK_DWE</sub> /T <sub>DMCKC_DWE</sub>	DWE Setup/Hold time	1.2 0.0	1.35 0.0	1.56 0.0	ns
T <sub>DMCKO_DO</sub>	CLK to out of DO <sup>(3)</sup>	1.0	1.12	1.3	ns
T <sub>DMCKO_DRDY</sub>	CLK to out of DRDY	1.0	1.12	1.3	ns

- 1. Maximum frequency and setup/hold timing parameters are for 3.3V and 2.5V configuration voltages.
- 2. To support longer delays in configuration, use the design solutions described in UG190: Virtex-5 FPGA User Guide.
- 3. DO will hold until next DRP operation.
- 4. Only during configuration, the last edge is determined by a weak pull-up/pull-down resistor in the I/O.



## **Clock Buffers and Networks**

Table 71: Global Clock Switching Characteristics (Including BUFGCTRL)

Cumbal	Description	Devices	S	peed Grac	le	Units
Symbol		Devices	-3	-2	-1	Units
T <sub>BCCCK_CE</sub> /T <sub>BCCKC_CE</sub> <sup>(1)</sup>	CE pins Setup/Hold	All	0.27 0.00	0.27 0.00	0.31 0.00	ns
T <sub>BCCCK_S</sub> /T <sub>BCCKC_S</sub> <sup>(1)</sup>	S pins Setup/Hold	All	0.27 0.00	0.27 0.00	0.31 0.00	ns
		LX20T	N/A	0.24	0.30	ns
(0)	BUFGCTRL delay from	LX30, LX30T, LX50, LX50T, LX85, LX85T, LX110, LX110T, SX35T, SX50T, FX70T, FX100T, and FX130T	0.19	0.22	0.25	ns
T <sub>BCCKO_O</sub> <sup>(2)</sup>	IO/I1 to O	FX30T	0.23	0.23	0.25	ns
		LX155 and LX155T	0.12	0.14	0.30	ns
		LX220, LX220T, LX330, LX330T, SX95T, SX240T, TX150T, TX240T, and FX200T	N/A	0.22	0.25	ns
Maximum Frequency	<u>'</u>					"
		LX20T	N/A	667	600	MHz
F <sub>MAX</sub> Glo		LX30, LX30T, LX50, LX50T, LX85, LX85T, LX110, LX110T, SX35T, SX50T, FX30T, and FX70T	710	667	600	MHz
	Global clock tree (BUFG)	LX155, LX155T, and FX100T	650	600	550	MHz
		FX130T	550	500	450	MHz
		LX220, LX220T, LX330, LX330T, SX95T, SX240T, TX150T, TX240T, and FX200T	N/A	500	450	MHz

#### Notes:

### Table 72: Input/Output Clock Switching Characteristics (BUFIO)

Symbol	Description	S	Units		
	Description	-3	-2	-1	Uiills
T <sub>BUFIOCKO_O</sub>	Clock to out delay from I to O	1.08	1.16	1.29	ns
Maximum Frequency					
F <sub>MAX</sub>	I/O clock tree (BUFIO)	710	710	644	MHz

<sup>1.</sup> T<sub>BCCCK\_CE</sub> and T<sub>BCCKC\_CE</sub> must be satisfied to assure glitch-free operation of the global clock when switching between clocks. These parameters do not apply to the BUFGMUX\_VIRTEX4 primitive that assures glitch-free operation. The other global clock setup and hold times are optional; only needing to be satisfied if device operation requires simulation matches on a cycle-for-cycle basis when switching between clocks.

<sup>2.</sup>  $T_{BGCKO\ O}$  (BUFG delay from I0 to O) values are the same as  $T_{BCCKO\ O}$  values.



Table 73: Regional Clock Switching Characteristics (BUFR)

Symbol	Description	Devices	S	peed Grad	е	Units
Symbol	Description	Devices	-3	-2	-1	Units
		LX20T	N/A	0.79	0.90	ns
		LX30, LX30T, LX50, LX50T, LX85, LX85T, LX110, LX110T, SX35T, SX50T, FX100T, and FX130T	0.56	0.59	0.67	ns
T <sub>BRCKO_O</sub>	Clock to out delay from I to O	FX30T	0.72	0.78	0.86	ns
5.161.6_6	1100	FX70T	0.69	0.74	0.83	ns
		LX155 and LX155T	0.73	0.80	0.90	ns
		LX220, LX220T, LX330, LX330T, SX95T, SX240T, TX150T, TX240T, and FX200T	N/A	0.59	0.67	ns
		LX20T	N/A	0.29	0.30	ns
T <sub>BRCKO_O_BYP</sub>	Clock to out delay from I to O with Divide Bypass	LX30, LX30T, LX50, LX50T, LX85, LX85T, LX110, LX110T, SX35T, SX50T, FX30T, FX70T, FX100T, and FX130T	0.23	0.24	0.26	ns
BHONO_O_BTT	attribute set	LX155 and LX155T	0.24	0.26	0.30	ns
		LX220, LX220T, LX330, LX330T, SX95T, SX240T, TX150T, TX240T, and FX200T	N/A	0.24	0.26	ns
T <sub>BRDO_CLRO</sub>	Propagation delay from CLR to O	All	0.61	0.70	0.82	ns
Maximum Frequency						-
F <sub>MAX</sub>	Regional clock tree (BUFR)	All	300	250	250	MHz



## **PLL Switching Characteristics**

Table 74: PLL Specification

Combal	Description	9	Unito		
Symbol	Description	-3	-2	-1	- Units
F <sub>INMAX</sub>	Maximum Input Clock Frequency	710	710	645	MHz
F <sub>INMIN</sub>	Minimum Input Clock Frequency	19	19	19	MHz
F <sub>INJITTER</sub>	Maximum Input Clock Period Jitter	<20% of	clock input	period or 1	ns Max
F <sub>INDUTY</sub>	Allowable Input Duty Cycle: 19—49 MHz		25/75		%
	Allowable Input Duty Cycle: 50—199 MHz		30/70		%
	Allowable Input Duty Cycle: 200—399 MHz		35/65		%
	Allowable Input Duty Cycle: 400—499 MHz		40/60		%
	Allowable Input Duty Cycle: >500 MHz		45/55		%
F <sub>VCOMIN</sub>	Minimum PLL VCO Frequency	400	400	400	MHz
F <sub>VCOMAX</sub>	Maximum PLL VCO Frequency	1440	1200	1000	MHz
F <sub>BANDWIDTH</sub>	Low PLL Bandwidth at Typical <sup>(1)</sup>	1	1	1	MHz
	High PLL Bandwidth at Typical <sup>(1)</sup>	4	4	4	MHz
T <sub>STAPHAOFFSET</sub>	Static Phase Offset of the PLL Outputs	120	120	120	ps
T <sub>OUTJITTER</sub>	PLL Output Jitter <sup>(2)</sup>		Note	1	-1
T <sub>OUTDUTY</sub>	PLL Output Clock Duty Cycle Precision <sup>(3)</sup>	±150	±200	±200	ps
T <sub>LOCKMAX</sub>	PLL Maximum Lock Time <sup>(4)</sup>	100	100	100	μs
	PLL Maximum Output Frequency for LX20T devices	N/A	667	600	MHz
	PLL Maximum Output Frequency for LX30, LX30T, LX50, LX50T, LX85, LX85T, LX110, LX110T, SX35T, SX50T, FX30T, and FX70Tdevices	710	667	600	MHz
F <sub>OUTMAX</sub>	PLL Maximum Output Frequency for LX155, LX155T, and FX100T devices	650	600	550	MHz
	PLL Maximum Output Frequency for FX130T devices	550	500	450	MHz
	PLL Maximum Output Frequency for LX220, LX220T, LX330, LX330T, SX95T, SX240T, TX150T, TX240T, and FX200T devices	N/A	500	450	MHz
F <sub>OUTMIN</sub>	PLL Minimum Output Frequency <sup>(5)</sup>	3.125	3.125	3.125	MHz
T <sub>EXTFDVAR</sub>	External Clock Feedback Variation	< 20% of	clock input	period or 1	ns Max
RST <sub>MINPULSE</sub>	Minimum Reset Pulse Width	5	5	5	ns
F <sub>PFDMAX</sub>	Maximum Frequency at the Phase Frequency Detector	550	500	450	MHz
F <sub>PFDMIN</sub>	Minimum Frequency at the Phase Frequency Detector	19	19	19	MHz
T <sub>FBDELAY</sub>	Maximum External Delay in the Feedback Path	3 ns Max or one CLKIN cycle			cle

- 1. The PLL does not filter typical spread spectrum input clocks because they are usually far below the bandwidth filter frequencies.
- 2. Values for this parameter are available in the Architecture Wizard.
- 3. Includes global clock buffer.
- The LOCK signal must be sampled after T<sub>LOCKMAX</sub>. The LOCK signal is invalid after configuration or reset until the T<sub>LOCKMAX</sub> time has expired.
- 5. Calculated as  $F_{VCO}/128$  assuming output duty cycle is 50%.



Table 75: PLL in PMCD Mode Switching Characteristics

Cumbal	Description	9	Speed Grade			
Symbol	Description	-3	-2	-1	Units	
T <sub>PLLCCK_REL</sub> /T <sub>PLLCKC_REL</sub>	REL Setup and Hold for all Outputs	0.00 0.60	0.00 0.60	0.00 0.60	ns	
T <sub>PLLCCKO</sub>	Maximum Clock Propagation Delay	4.6	4.6	5.2	ns	
CLKIN_FREQ_MAX	Maximum Input Frequency	710	710	645	MHz	
CLKIN_FREQ_MIN	Minimum Input Frequency	1	1	1	MHz	
CLKIN_DUTY_CYCLE	Allowable Input Duty Cycle: 1—49 MHz		25/75		%	
	Allowable Input Duty Cycle: 50—199 MHz		30/70			
	Allowable Input Duty Cycle: 200—399 MHz		35/65		%	
	Allowable Input Duty Cycle: 400—499 MHz		40/60		%	
	Allowable Input Duty Cycle: >500 MHz		45/55		%	
RES_REL_PULSE_MIN Minimum Pulse Width for RST and REL		5	5	5	ns	



## **DCM Switching Characteristics**

Table 76: Operating Frequency Ranges for DCM in Maximum Speed (MS) Mode

O. mah al	Donasiakia a		Speed Grade			
Symbol	Description	-3	-2	-1	Units	
Outputs Clocks (Low Frequency	Mode)		•	'	"	
F <sub>1XLFMSMIN</sub>	CLK0, CLK90, CLK180, CLK270	32.00	32.00	32.00	MHz	
F <sub>1XLFMSMAX</sub>		150.00	135.00	120.00	MHz	
F <sub>2XLFMSMIN</sub>	CLK2X, CLK2X180	64.00	64.00	64.00	MHz	
F <sub>2XLFMSMAX</sub>		300.00	270.00	240.00	MHz	
F <sub>DVLFMSMIN</sub>	CLKDV	2.0	2.0	2.0	MHz	
F <sub>DVLFMSMAX</sub>		100.00	90.00	80.00	MHz	
F <sub>FXLFMSMIN</sub>	CLKFX, CLKFX180	32.00	32.00	32.00	MHz	
F <sub>FXLFMSMAX</sub>		180.00	160.00	140.00	MHz	
Input Clocks (Low Frequency M	ode)					
F <sub>DLLLFMSMIN</sub>	CLKIN (using DLL outputs) <sup>(1, 3, 4)</sup>	32.00	32.00	32.00	MHz	
F <sub>DLLLFMSMAX</sub>		150.00	135.00	120.00	MHz	
F <sub>CLKINLFFXMSMIN</sub>	CLKIN (using DFS outputs only)(2, 3, 4)	1.00	1.00	1.00	MHz	
F <sub>CLKINLFFXMSMAX</sub>		180.00	160.00	140.00	MHz	
F <sub>PSCLKLFMSMIN</sub>	PSCLK	1.00	1.00	1.00	KHz	
F <sub>PSCLKLFMSMAX</sub>		550.00	500.00	450.00	MHz	
Outputs Clocks (High Frequence	y Mode)					
F <sub>1XHFMSMIN</sub>	CLK0, CLK90, CLK180, CLK270	120.00	120.00	120.00	MHz	
F <sub>1XHFMSMAX</sub>		550.00	500.00	450.00	MHz	
F <sub>2XHFMSMIN</sub>	CLK2X, CLK2X180	240.00	240.00	240.00	MHz	
F <sub>2XHFMSMAX</sub>		550.00	500.00	450.00	MHz	
F <sub>DVHFMSMIN</sub>	CLKDV	7.5	7.5	7.5	MHz	
F <sub>DVHFMSMAX</sub>		366.67	333.34	300.00	MHz	
F <sub>FXHFMSMIN</sub>	CLKFX, CLKFX180	140.00	140.00	140.00	MHz	
F <sub>FXHFMSMAX</sub>		400.00	375.00	350.00	MHz	
Input Clocks (High Frequency M	lode)					
F <sub>DLLHFMSMIN</sub>	CLKIN (using DLL outputs) <sup>(1, 3, 4)</sup>	120.00	120.00	120.00	MHz	
F <sub>DLLHFMSMAX</sub>		550.00	500.00	450.00	MHz	
F <sub>CLKINHFFXMSMIN</sub>	CLKIN (using DFS outputs only) <sup>(2, 3, 4)</sup>	25.00	25.00	25.00	MHz	
F <sub>CLKINHFFXMSMAX</sub>		400.00	375.00	350.00	MHz	
F <sub>PSCLKHFMSMIN</sub>	PSCLK	1.00	1.00	1.00	KHz	
F <sub>PSCLKHFMSMAX</sub>		550.00	500.00	450.00	MHz	

- 1. DLL outputs are used in these instances to describe the outputs: CLK0, CLK90, CLK180, CLK270, CLK2X, CLK2X180, and CLKDV.
- 2. DFS outputs are used in these instances to describe the outputs: CLKFX and CLKFX180.
- 3. When using the DCMs CLKIN\_DIVIDE\_BY\_2 attribute these values should be doubled. Other resources can limit the maximum input frequency.
- 4. When using a CLKIN frequency > 400 MHz and the DCMs CLKIN\_DIVIDE\_BY\_2 attribute, the CLKIN duty cycle must be within ±5% (45/55 to 55/45).



Table 77: Operating Frequency Ranges for DCM in Maximum Range (MR) Mode

Combal	Description		Speed Grade			
Symbol	Description	-3	-2	-1	Units	
Outputs Clocks (Low Frequer	ncy Mode)					
F <sub>1XMRMIN</sub>	CLK0, CLK90, CLK180, CLK270	19.00	19.00	19.00	MHz	
F <sub>1XMRMAX</sub>		32.00	32.00	32.00	MHz	
F <sub>2XMRMIN</sub>	CLK2X, CLK2X180	38.00	38.00	38.00	MHz	
F <sub>2XMRMAX</sub>		64.00	64.00	64.00	MHz	
F <sub>DLLMRMIN</sub>	CLKDV	1.19	1.19	1.19	MHz	
F <sub>DLLMRMAX</sub>		21.34	21.34	21.34	MHz	
F <sub>FXMRMIN</sub>	CLKFX, CLKFX180	19.00	19.00	19.00	MHz	
F <sub>FXMRMAX</sub>		40.00	40.00	40.00	MHz	
Input Clocks (Low Frequency	Mode)	·				
F <sub>CLKINDLLMRMIN</sub>	CLKIN (using DLL outputs) <sup>(1, 3, 4)</sup>	19.00	19.00	19.00	MHz	
F <sub>CLKINDLLMRMAX</sub>		32.00	32.00	32.00	MHz	
F <sub>CLKINFXMRMIN</sub>	CLKIN (using DFS outputs only) <sup>(2, 3, 4)</sup>	1.00	1.00	1.00	MHz	
F <sub>CLKINFXMRMAX</sub>		40.00	40.00	40.00	MHz	
F <sub>PSCLKMRMIN</sub>	PSCLK	1.00	1.00	1.00	KHz	
F <sub>PSCLKMRMAX</sub>		300.00	270.00	240.00	MHz	

- 1. DLL Outputs are used in these instances to describe the outputs: CLK0, CLK90, CLK180, CLK270, CLK2X, CLK2X180, and CLKDV.
- 2. DFS Outputs are used in these instances to describe the outputs: CLKFX and CLKFX180.
- 3. When using the DCMs CLKIN\_DIVIDE\_BY\_2 attribute these values should be doubled. Other resources can limit the maximum input frequency.
- When using a CLKIN frequency > 400 MHz and the DCMs CLKIN\_DIVIDE\_BY\_2 attribute, the CLKIN duty cycle must be within ±5% (45/55 to 55/45).



Table 78: Input Clock Tolerances

Symbol	Description	Frequency Range		Value	Units
Duty Cycle Input Tolerance (in %)					
T <sub>DUTYCYCRANGE_1</sub>	PSCLK only	< 1 MHz		25 - 75	%
T <sub>DUTYCYCRANGE_1_50</sub>	PSCLK and CLKIN	1 - 50	) MHz	25 - 75	%
T <sub>DUTYCYCRANGE_50_100</sub>		50 - 10	00 MHz	30 - 70	%
T <sub>DUTYCYCRANGE_100_200</sub>		100 - 2	00 MHz	40 - 60	%
T <sub>DUTYCYCRANGE_200_400</sub>		200 - 40	00 MHz <sup>(4)</sup>	45 - 55	%
T <sub>DUTYCYCRANGE_400</sub>		> 400	) MHz	45 - 55	%
Input Clock Cycle-Cycle Jitter (Low Frequence	cy Mode)		Speed Grade	е	Units
		-3	-2	-1	Units
T <sub>CYCLFDLL</sub>	CLKIN (using DLL outputs) <sup>(1)</sup>	300.00	300.00	345.00	ps
T <sub>CYCLFFX</sub>	CLKIN (using DFS outputs) <sup>(2)</sup>	300.00	300.00	345.00	ps
Input Clock Cycle-Cycle Jitter (High Frequency	uency Mode)	-	!	*	-!
T <sub>CYCHFDLL</sub>	CLKIN (using DLL outputs) <sup>(1)</sup>	150.00	150.00	173.00	ps
T <sub>CYCHFFX</sub>	CLKIN (using DFS outputs)(2)	150.00	150.00	173.00	ps
Input Clock Period Jitter (Low Frequency	Mode)				
T <sub>PERLFDLL</sub>	CLKIN (using DLL outputs) <sup>(1)</sup>	1.00	1.00	1.15	ns
T <sub>PERLFFX</sub>	CLKIN (using DFS outputs)(2)	1.00	1.00	1.15	ns
Input Clock Period Jitter (High Frequency	Mode)		1		
T <sub>PERHFDLL</sub>	CLKIN (using DLL outputs) <sup>(1)</sup>	1.00	1.00	1.15	ns
T <sub>PERHFFX</sub>	CLKIN (using DFS outputs) <sup>(2)</sup>	1.00	1.00	1.15	ns
Feedback Clock Path Delay Variation		•			
T <sub>CLKFB_DELAY_VAR</sub>	CLKFB off-chip feedback	1.00	1.00	1.15	ns

- 1. DLL Outputs are used in these instances to describe the outputs: CLK0, CLK90, CLK180, CLK270, CLK2X, CLK2X180, and CLKDV.
- 2. DFS Outputs are used in these instances to describe the outputs: CLKFX and CLKFX180.
- 3. If both DLL and DFS outputs are used, follow the more restrictive specifications.
- 4. This duty cycle specification does not apply to the GTP\_DUAL to DCM or GTX\_DUAL to DCM connection. The GTP transceivers drive the DCMs at the following frequencies: 320 MHz for -1 speed grade devices, 375 MHz for -2 speed grade devices, or 375 MHz for -3 speed grade devices. The GTX transceivers drive the DCMs at the following frequencies: 450 MHz for -1 speed grade devices or 500 MHz for -2 speed grade devices.



## **Output Clock Jitter**

Table 79: Output Clock Jitter

Symbol	Description	Constraints	Speed Grade			Units
Symbol	Description	Constraints	-3	-2	-1	Units
Clock Synthesis Period Jitter						
T <sub>PERJITT_0</sub>	CLK0		±120	±120	±120	ps
T <sub>PERJITT_90</sub>	CLK90		±120	±120	±120	ps
T <sub>PERJITT_180</sub>	CLK180		±120	±120	±120	ps
T <sub>PERJITT_270</sub>	CLK270		±120	±120	±120	ps
T <sub>PERJITT_2X</sub>	CLK2X, CLK2X180		±200	±200	±230	ps
T <sub>PERJITT_DV1</sub>	CLKDV (integer division)		±150	±150	±180	ps
T <sub>PERJITT_DV2</sub>	CLKDV (non-integer division)		±300	±300	±345	ps
T <sub>PERJITT_FX</sub>	CLKFX, CLKFX180		Note 1	Note 1	Note 1	ps

#### Notes:

## **Output Clock Phase Alignment**

Table 80: Output Clock Phase Alignment

Symbol	Description	Constraints	S	Speed Grade		
	Description	Constraints	-3	-2	-1	Units
Phase Offset Between C	LKIN and CLKFB					
T <sub>IN_FB_OFFSET</sub>	CLKIN/CLKFB		±50	±50	±60	ps
Phase Offset Between A	ny DCM Outputs <sup>(1)</sup>	<u>'</u>				
T <sub>OUT_OFFSET_1X</sub>	CLK0, CLK90, CLK180, CLK270		±140	±140	±160	ps
T <sub>OUT_OFFSET_2X</sub>	CLK2X, CLK2X180, CLKDV		±150	±150	±200	ps
T <sub>OUT_OFFSET_FX</sub>	CLKFX, CLKFX180		±160	±160	±220	ps
Duty Cycle Precision <sup>(2)</sup>						
T <sub>DUTY_CYC_DLL</sub>	DLL outputs <sup>(3)</sup>		±150	±150	±180	ps
T <sub>DUTY_CYC_FX</sub>	DFS outputs <sup>(4)</sup>		±150	±150	±180	ps

- 1. All phase offsets are in respect to group CLK1X.
- CLKOUT\_DUTY\_CYCLE\_DLL applies to the 1X clock outputs (CLK0, CLK90, CLK180, and CLK270) only if DUTY\_CYCLE\_CORRECTION = TRUE. The duty cycle distortion includes the global clock tree (BUFG).
- 3. DLL Outputs are used in these instances to describe the outputs: CLK0, CLK90, CLK180, CLK270, CLK2X, CLK2X180, and CLKDV.
- 4. DFS Outputs are used in these instances to describe the outputs: CLKFX and CLKFX180.

<sup>1.</sup> Values for this parameter are available in the Architecture Wizard.



Table 81: Miscellaneous Timing Parameters

Cumbal	Deceriation	Speed Grade		de	
Symbol	Description	-3	-2	-1	Units
Time Required to Achieve	e LOCK				
T <sub>DLL_240</sub>	DLL output – Frequency range > 240 MHz (1)	80.00	80.00	80.00	μs
T <sub>DLL_120_240</sub>	DLL output – Frequency range 120 - 240 MHz (1)	250.00	250.00	250.00	μs
T <sub>DLL_60_120</sub>	DLL output – Frequency range 60 - 120 MHz <sup>(1)</sup>	900.00	900.00	900.00	μs
T <sub>DLL_50_60</sub>	DLL output – Frequency range 50 - 60 MHz <sup>(1)</sup>	1300.00	1300.00	1300.00	μs
T <sub>DLL_40_50</sub>	DLL output – Frequency range 40 - 50 MHz (1)	2000.00	2000.00	2000.00	μs
T <sub>DLL_30_40</sub>	DLL output – Frequency range 30 - 40 MHz (1)	3600.00	3600.00	3600.00	μs
T <sub>DLL_24_30</sub>	DLL output – Frequency range 24 - 30 MHz <sup>(1)</sup>	5000.00	5000.00	5000.00	μs
T <sub>DLL_30</sub>	DLL output – Frequency range < 30 MHz (1)	5000.00	5000.00	5000.00	μs
T <sub>FX_MIN</sub>	DFS outputs <sup>(2)</sup>	10.00	10.00	10.00	ms
T <sub>FX_MAX</sub>		10.00	10.00	10.00	ms
T <sub>DLL_FINE_SHIFT</sub>	Multiplication factor for DLL lock time with Fine Shift	2.00	2.00	2.00	
Fine Phase Shifting					
T <sub>RANGE_MS</sub>	Absolute shifting range in maximum speed mode	7.00	7.00	7.00	ns
T <sub>RANGE_MR</sub>	Absolute shifting range in maximum range mode	10.00	10.00	10.00	ns
Delay Lines					
T <sub>TAP_MS_MIN</sub>	Tap delay resolution (Min) in maximum speed mode	7.00	7.00	7.00	ps
T <sub>TAP_MS_MAX</sub>	Tap delay resolution (Max) in maximum speed mode	30.00	30.00	30.00	ps
T <sub>TAP_MR_MIN</sub>	Tap delay resolution (Min) in maximum range mode	10.00	10.00	10.00	ps
T <sub>TAP_MR_MAX</sub>	Tap delay resolution (Max) in maximum range mode	40.00	40.00	40.00	ps

- 1. DLL Outputs are used in these instances to describe the outputs: CLK0, CLK90, CLK180, CLK270, CLK2X, CLK2X180, and CLKDV.
- 2. DFS Outputs are used in these instances to describe the outputs: CLKFX and CLKFX180.

## Table 82: Frequency Synthesis

Attribute	Min	Max
CLKFX_MULTIPLY	2	33
CLKFX_DIVIDE	1	32

## Table 83: DCM Switching Characteristics

Symbol	Description	S	- Units		
Symbol	Description	-3	-2	-1	Ullits
T <sub>DMCCK_PSEN</sub> / T <sub>DMCKC_PSEN</sub>	PSEN Setup/Hold	1.20 0.00	1.35 0.00	1.56 0.00	ns
T <sub>DMCCK_PSINCDEC</sub> / T <sub>DMCKC_PSINCDEC</sub>	PSINCDEC Setup/Hold	1.20 0.00	1.35 0.00	1.56 0.00	ns
T <sub>DMCKO_PSDONE</sub>	Clock to out of PSDONE	1.00	1.12	1.30	ns



# Virtex-5 Device Pin-to-Pin Output Parameter Guidelines

All devices are 100% functionally tested. The representative values for typical pin locations and normal clock loading are listed in Table 84. Values are expressed in nanoseconds unless otherwise noted.

Table 84: Global Clock Input to Output Delay Without DCM or PLL

O	De a salation	Davis	9	Speed Grad	le	Halta
Symbol	Description	Device	-3	-2	-1	Units
LVCMOS25 Globa	al Clock Input to Output Delay using Output Flip-Flop,	12mA, Fast Slew Rat	e, <i>without</i> D	CM or PLL		
T <sub>ICKOF</sub>	Global Clock and OUTFF without DCM or PLL	XC5VLX20T	N/A	5.98	6.69	ns
		XC5VLX30	5.54	6.04	6.73	ns
		XC5VLX30T	5.54	6.04	6.73	ns
		XC5VLX50	5.59	6.09	6.79	ns
		XC5VLX50T	5.59	6.09	6.79	ns
	XC5VLX85	5.78	6.28	6.99	ns	
		XC5VLX85T	5.78	6.28	6.99	ns
		XC5VLX110	5.84	6.35	7.06	ns
		XC5VLX110T	5.84	6.35	7.06	ns
		XC5VLX155	6.16	6.68	7.52	ns
		XC5VLX155T	6.16	6.68	7.52	ns
		XC5VLX220	N/A	6.99	7.71	ns
		XC5VLX220T	N/A	6.99	7.71	ns
		XC5VLX330	N/A	7.17	7.91	ns
		XC5VLX330T	N/A	7.17	7.91	ns
		XC5VSX35T	5.72	6.22	6.92	ns
		XC5VSX50T	5.77	6.27	6.97	ns
		XC5VSX95T	N/A	6.59	7.30	ns
		XC5VSX240T	N/A	7.24	7.98	ns
		XC5VTX150T	N/A	6.58	7.30	ns
		XC5VTX240T	N/A	6.88	7.61	ns
		XC5VFX30T	5.73	6.21	6.89	ns
		XC5VFX70T	5.82	6.33	7.04	ns
		XC5VFX100T	6.21	6.73	7.44	ns
		XC5VFX130T	6.28	6.80	7.52	ns
		XC5VFX200T	N/A	7.17	7.91	ns

#### Notes:

 Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.



Table 85: Global Clock Input to Output Delay With DCM in System-Synchronous Mode

Symbol	Symbol Description Des		5	Speed Grad	l Grade	
Symbol	Description	Device	-3	-2	-1	Units
LVCMOS25 Globa in System-Synchr	al Clock Input to Output Delay using Output Flip-Fronous Mode	lop, 12mA, Fast Slew Rat	e, <i>with</i> DCM	1		
T <sub>ICKOFDCM</sub>	Global Clock and OUTFF with DCM	XC5VLX20T	N/A	2.53	2.93	ns
		XC5VLX30	2.33	2.56	2.93	ns
		XC5VLX30T	2.33	2.56	2.93	ns
		XC5VLX50	2.35	2.58	2.95	ns
		XC5VLX50T	2.35	2.58	2.95	ns
		XC5VLX85	2.41	2.63	3.00	ns
		XC5VLX85T	2.41	2.63	3.00	ns
		XC5VLX110	2.46	2.69	3.06	ns
		XC5VLX110T	2.46	2.69	3.06	ns
		XC5VLX155	2.51	2.74	3.10	ns
		XC5VLX155T	2.51	2.74	3.10	ns
		XC5VLX220	N/A	2.83	3.18	ns
		XC5VLX220T	N/A	2.83	3.18	ns
		XC5VLX330	N/A	3.00	3.37	ns
		XC5VLX330T	N/A	3.00	3.37	ns
		XC5VSX35T	2.44	2.67	3.03	ns
		XC5VSX50T	2.46	2.69	3.05	ns
		XC5VSX95T	N/A	2.64	3.00	ns
		XC5VSX240T	N/A	3.00	3.36	ns
		XC5VTX150T	N/A	2.77	3.15	ns
		XC5VTX240T	N/A	2.78	3.15	ns
		XC5VFX30T	2.55	2.82	3.20	ns
		XC5VFX70T	2.48	2.74	3.12	ns
		XC5VFX100T	2.33	2.59	3.00	ns
		XC5VFX130T	2.40	2.67	3.07	ns
		XC5VFX200T	N/A	2.87	3.27	ns

<sup>1.</sup> Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.

<sup>2.</sup> DCM output jitter is already included in the timing calculation.



Table 86: Global Clock Input to Output Delay With DCM in Source-Synchronous Mode

Combal	Description	Speed Speed		Speed Grad	de	Units
Symbol	Description	Device	-3	-2	-1	Units
LVCMOS25 Globa in Source-Synchro	l Clock Input to Output Delay using Output Flip-Fonous Mode	lop, 12mA, Fast Slew Rate	e, <i>with</i> DCM	1		
T <sub>ICKOFDCM_0</sub>	Global Clock and OUTFF with DCM	XC5VLX20T	N/A	3.74	4.20	ns
		XC5VLX30	3.45	3.71	4.15	ns
		XC5VLX30T	3.45	3.71	4.15	ns
		XC5VLX50	3.47	3.73	4.17	ns
	XC5VLX50T	3.47	3.73	4.17	ns	
		XC5VLX85	3.60	3.86	4.29	ns
		XC5VLX85T	3.60	3.86	4.29	ns
		XC5VLX110	3.65	3.92	4.36	ns
		XC5VLX110T	3.65	3.92	4.36	ns
		XC5VLX155	3.91	4.18	4.62	ns
		XC5VLX155T	3.91	4.18	4.62	ns
		XC5VLX220	N/A	4.41	4.85	ns
		XC5VLX220T	N/A	4.41	4.85	ns
		XC5VLX330	N/A	4.58	5.04	ns
		XC5VLX330T	N/A	4.58	5.04	ns
		XC5VSX35T	3.63	3.89	4.33	ns
		XC5VSX50T	3.65	3.91	4.35	ns
		XC5VSX95T	N/A	4.16	4.59	ns
		XC5VSX240T	N/A	4.65	5.11	ns
		XC5VTX150T	N/A	4.07	4.51	ns
		XC5VTX240T	N/A	4.30	4.74	ns
		XC5VFX30T	3.74	4.05	4.50	ns
		XC5VFX70T	3.67	3.96	4.41	ns
		XC5VFX100T	3.82	4.10	4.53	ns
		XC5VFX130T	3.99	4.29	4.74	ns
		XC5VFX200T	N/A	4.60	5.03	ns

<sup>1.</sup> Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.

<sup>2.</sup> DCM output jitter is already included in the timing calculation.



Table 87: Global Clock Input to Output Delay With PLL in System-Synchronous Mode

Symbol	Description	Device	Speed Grade		de	Units
Symbol	Description	Device	-3	-2	-1	Ullits
LVCMOS25 Globa	al Clock Input to Output Delay using Output Flip-Flop	, 12mA, Fast Slew Rat	e, <i>with</i> PLL	in System-S	Synchronou	ıs Mode
T <sub>ICKOFPLL</sub>	Global Clock and OUTFF with PLL	XC5VLX20T	N/A	2.36	2.73	ns
		XC5VLX30	2.03	2.30	2.70	ns
		XC5VLX30T	2.03	2.30	2.70	ns
		XC5VLX50	2.20	2.47	2.86	ns
		XC5VLX50T	2.20	2.47	2.86	ns
	XC5VLX85	2.21	2.49	2.88	ns	
	XC5VLX85T	2.21	2.49	2.88	ns	
		XC5VLX110	2.25	2.53	2.92	ns
		XC5VLX110T	2.25	2.53	2.92	ns
		XC5VLX155	2.34	2.60	3.01	ns
		XC5VLX155T	2.34	2.60	3.01	ns
		XC5VLX220	N/A	2.74	3.12	ns
		XC5VLX220T	N/A	2.74	3.12	ns
		XC5VLX330	N/A	2.89	3.27	ns
		XC5VLX330T	N/A	2.89	3.27	ns
		XC5VSX35T	2.02	2.28	2.62	ns
		XC5VSX50T	2.12	2.36	2.76	ns
		XC5VSX95T	N/A	2.29	2.69	ns
		XC5VSX240T	N/A	2.96	3.34	ns
		XC5VTX150T	N/A	2.54	2.92	ns
		XC5VTX240T	N/A	2.67	3.04	ns
		XC5VFX30T	2.44	2.67	3.06	ns
		XC5VFX70T	2.48	2.71	3.10	ns
		XC5VFX100T	2.41	2.70	3.10	ns
		XC5VFX130T	2.48	2.75	3.17	ns
		XC5VFX200T	N/A	2.96	3.35	ns

<sup>1.</sup> Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.

<sup>2.</sup> PLL output jitter is included in the timing calculation.



Table 88: Global Clock Input to Output Delay With PLL in Source-Synchronous Mode

Symbol	Description	Device	Speed Grade			Units
			-3	-2	-1	Uiilis
LVCMOS25 Global	Clock Input to Output Delay using Output Flip-Flop, 12	2mA, Fast Slew Rate	e, <i>with</i> PLL	in Source-S	ynchronou	s Mode
T <sub>ICKOFPLL_0</sub>	Global Clock and OUTFF with PLL	XC5VLX20T	N/A	4.31	4.88	ns
		XC5VLX30	3.96	4.32	4.82	ns
		XC5VLX30T	3.96	4.32	4.82	ns
		XC5VLX50	4.05	4.40	4.91	ns
		XC5VLX50T	4.05	4.40	4.91	ns
		XC5VLX85	4.07	4.40	4.88	ns
		XC5VLX85T	4.07	4.40	4.88	ns
		XC5VLX110	4.11	4.44	4.92	ns
		XC5VLX110T	4.11	4.44	4.92	ns
		XC5VLX155	4.31	4.66	5.16	ns
		XC5VLX155T	4.31	4.66	5.16	ns
		XC5VLX220	N/A	4.85	5.29	ns
		XC5VLX220T	N/A	4.85	5.29	ns
		XC5VLX330	N/A	5.00	5.44	ns
		XC5VLX330T	N/A	5.00	5.44	ns
		XC5VSX35T	4.19	4.54	5.03	ns
		XC5VSX50T	4.20	4.54	5.02	ns
		XC5VSX95T	N/A	4.68	5.14	ns
		XC5VSX240T	N/A	5.07	5.51	ns
		XC5VTX150T	N/A	4.51	4.95	ns
		XC5VTX240T	N/A	4.71	5.14	ns
		XC5VFX30T	4.23	4.56	5.04	ns
		XC5VFX70T	4.22	4.54	5.02	ns
		XC5VFX100T	4.35	4.70	5.19	ns
		XC5VFX130T	4.49	4.86	5.40	ns
		XC5VFX200T	N/A	5.04	5.55	ns

<sup>1.</sup> Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.

<sup>2.</sup> PLL output jitter is included in the timing calculation.



Table 89: Global Clock Input to Output Delay With DCM and PLL in System-Synchronous Mode

Symbol	Description	Device	Speed Grade			Units
			-3	-2	-1	UIIIIS
LVCMOS25 Global in System-Synchro	Clock Input to Output Delay using Output Flip-Flop, nous Mode	12mA, Fast Slew Rate	e, <i>with</i> DCM	l and PLL		
T <sub>ICKOFDCM_PLL</sub>	Global Clock and OUTFF with DCM and PLL	XC5VLX20T	N/A	2.45	2.84	ns
		XC5VLX30	2.25	2.48	2.84	ns
		XC5VLX30T	2.25	2.48	2.84	ns
		XC5VLX50	2.27	2.50	2.86	ns
		XC5VLX50T	2.27	2.50	2.86	ns
		XC5VLX85	2.33	2.55	2.91	ns
		XC5VLX85T	2.33	2.55	2.91	ns
		XC5VLX110	2.38	2.61	2.97	ns
		XC5VLX110T	2.38	2.61	2.97	ns
		XC5VLX155	2.43	2.66	3.01	ns
		XC5VLX155T	2.43	2.66	3.01	ns
		XC5VLX220	N/A	2.75	3.09	ns
		XC5VLX220T	N/A	2.75	3.09	ns
		XC5VLX330	N/A	2.92	3.28	ns
		XC5VLX330T	N/A	2.92	3.28	ns
		XC5VSX35T	2.36	2.59	2.94	ns
		XC5VSX50T	2.38	2.61	2.96	ns
		XC5VSX95T	N/A	2.56	2.91	ns
		XC5VSX240T	N/A	2.92	3.27	ns
		XC5VTX150T	N/A	2.69	3.06	ns
		XC5VTX240T	N/A	2.70	3.06	ns
		XC5VFX30T	2.47	2.74	3.11	ns
		XC5VFX70T	2.40	2.66	3.03	ns
		XC5VFX100T	2.25	2.51	2.91	ns
		XC5VFX130T	2.32	2.59	2.98	ns
		XC5VFX200T	N/A	2.79	3.18	ns

<sup>1.</sup> Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.

<sup>2.</sup> DCM and PLL output jitter are already included in the timing calculation.



Table 90: Global Clock Input to Output Delay With DCM and PLL in Source-Synchronous Mode

Symbol	Description	Device	Speed Grade			Units
Symbol		Device	-3	-2	-1	Ullits
LVCMOS25 Global in Source-Synchron	Clock Input to Output Delay using Output Flip-Flop, 12 ous Mode	mA, Fast Slew Rate	e, <i>with</i> DCM	l and PLL		
T <sub>ICKOFDCM0_PLL</sub>	Global Clock and OUTFF with DCM and PLL	XC5VLX20T	N/A	3.66	4.11	ns
		XC5VLX30	3.37	3.63	4.06	ns
		XC5VLX30T	3.37	3.63	4.06	ns
		XC5VLX50	3.39	3.65	4.08	ns
		XC5VLX50T	3.39	3.65	4.08	ns
		XC5VLX85	3.52	3.78	4.20	ns
		XC5VLX85T	3.52	3.78	4.20	ns
		XC5VLX110	3.57	3.84	4.27	ns
		XC5VLX110T	3.57	3.84	4.27	ns
		XC5VLX155	3.83	4.10	4.53	ns
		XC5VLX155T	3.83	4.10	4.53	ns
		XC5VLX220	N/A	4.33	4.76	ns
		XC5VLX220T	N/A	4.33	4.76	ns
		XC5VLX330	N/A	4.50	4.95	ns
		XC5VLX330T	N/A	4.50	4.95	ns
		XC5VSX35T	3.55	3.81	4.24	ns
		XC5VSX50T	3.57	3.83	4.26	ns
		XC5VSX95T	N/A	4.08	4.50	ns
		XC5VSX240T	N/A	4.57	5.02	ns
		XC5VTX150T	N/A	3.99	4.42	ns
		XC5VTX240T	N/A	4.22	4.65	ns
		XC5VFX30T	3.66	3.97	4.41	ns
		XC5VFX70T	3.59	3.88	4.32	ns
		XC5VFX100T	3.74	4.02	4.44	ns
		XC5VFX130T	3.91	4.21	4.65	ns
		XC5VFX200T	N/A	4.52	4.94	ns

<sup>1.</sup> Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.

<sup>2.</sup> DCM and PLL output jitter are already included in the timing calculation.



## Virtex-5 Device Pin-to-Pin Input Parameter Guidelines

All devices are 100% functionally tested. The representative values for typical pin locations and normal clock loading are listed in Table 91. Values are expressed in nanoseconds unless otherwise noted.

Table 91: Global Clock Setup and Hold Without DCM or PLL

Symbol	Description	Dovice	Speed Grade			Unite
		Device	-3	-2	-1	Uiilis
Input Setup and	Hold Time Relative to Global Clock Input Signal	for LVCMOS25 Stan	dard. <sup>(1)</sup>			
T <sub>PSFD</sub> / T <sub>PHFD</sub>	Full Delay (Legacy Delay or Default Delay) Global Clock and IFF <sup>(2)</sup> without DCM or PLL	XC5VLX20T	N/A	1.63 -0.41	1.86 -0.41	ns
		XC5VLX30	1.49 -0.35	1.60 -0.35	1.77 -0.35	ns
		XC5VLX30T	1.49 -0.35	1.60 -0.35	1.76 -0.35	ns
		XC5VLX50	1.48 -0.30	1.59 -0.30	1.76 -0.30	ns
		XC5VLX50T	1.48 -0.30	1.59 -0.30	1.76 -0.30	ns
		XC5VLX85	1.75 -0.49	1.89 -0.49	2.09 -0.49	ns
		XC5VLX85T 1.75	1.75 -0.49	1.89 -0.49	2.09 -0.49	ns
		XC5VLX110	1.74 -0.43	1.88 -0.43	2.09 -0.43	ns
		XC5VLX110T	1.73 -0.43	1.88 -0.43	2.09 -0.43	ns ns ns ns ns
		XC5VLX155	2.06 -0.50	2.36 -0.50	2.78 -0.49	ns
		XC5VLX155T 2.06 2.36 -0.50 -0.50	2.78 -0.49	ns		
		XC5VLX220	N/A	2.57 -0.74	2.86 -0.74	ns
		XC5VLX220T	N/A	2.57 -0.74	2.86 -0.74	ns
		XC5VLX330	N/A	2.55 -0.56	2.85 -0.56	ns
		XC5VLX330T	N/A	2.57 -0.56	2.86 -0.56	ns
		XC5VSX35T	1.47 -0.16	1.59 -0.16	1.76 -0.16	ns
		XC5VSX50T	1.62 -0.31	1.74 -0.31	1.93 -0.31	ns
		XC5VSX95T	N/A	2.10 -0.44	2.32 -0.44	ns
		XC5VSX240T	N/A	2.01 0.18	2.28 0.18	ns



Table 91: Global Clock Setup and Hold Without DCM or PLL (Cont'd)

Symbol	Description	Device	S	Speed Grade		Units
	Description	Device	-3	-2	-1	Ullits
T <sub>PSFD</sub> / T <sub>PHFD</sub>	Full Delay (Legacy Delay or Default Delay) Global Clock and IFF <sup>(2)</sup> without DCM or PLL	XC5VTX150T	N/A	2.35 -0.82	2.59 -0.82	ns
		XC5VTX240T	N/A	2.59 -0.85	2.87 -0.85	ns
		XC5VFX30T	2.05 -0.27	2.25 -0.27	2.57 -0.27	ns
		XC5VFX70T	1.85 -0.30	2.06 -0.30	2.35 -0.30	ns
		XC5VFX100T	2.20 -0.42	2.38 -0.42	2.66 -0.42	ns
		XC5VFX130T	2.33 -0.55	2.59 -0.54	2.95 -0.54	ns
		XC5VFX200T	N/A	2.52 -0.43	2.81 -0.43	ns

- 1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage.
- 2. IFF = Input Flip-Flop or Latch
- 3. A Zero "0" Hold Time listing indicates no hold time or a negative hold time. Negative values can not be guaranteed "best-case", but if a "0" is listed, there is no positive hold time.



Table 92: Global Clock Setup and Hold With DCM in System-Synchronous Mode

Symbol	Description	Device	Speed Grade			Units
		Device	-3	-2	-1	Units
Input Setup and H	old Time Relative to Global Clock Input Signal fo	or LVCMOS25 Stand	dard. <sup>(1)</sup>			
T <sub>PSDCM</sub> / T <sub>PHDCM</sub>	No Delay Global Clock and IFF <sup>(2)</sup> with DCM in System-Synchronous Mode	XC5VLX20T	N/A	1.47 -0.56	1.59 -0.56	ns
		XC5VLX30	1.53 -0.50	1.70 -0.50	1.88 -0.50	ns
		XC5VLX30T	1.53 -0.50	1.70 -0.50	1.88 -0.50	ns
		XC5VLX50	1.52 -0.48	1.68 -0.48	1.86 -0.48	ns
		XC5VLX50T	1.52 -0.48	1.68 -0.48	1.86 -0.48	ns
		XC5VLX85	1.58 -0.43	1.76 -0.43	1.95 -0.43	ns
		XC5VLX85T	1.57 -0.43	1.76 -0.43	1.95 -0.43	ns
		XC5VLX110	1.58 -0.37	1.76 -0.37	1.95 -0.37	ns
		XC5VLX110T	1.58 -0.37	1.76 -0.37	1.95 -0.37	ns
		XC5VLX155	2.02 -0.32	2.16 -0.32	2.38 -0.32	ns ns
		XC5VLX155T	2.02 -0.32	2.16 -0.32	2.38 -0.32	ns
		XC5VLX220	N/A	2.17 -0.27	2.44 -0.27	ns
		XC5VLX220T	N/A	2.17 -0.27	2.44 -0.27	ns
		XC5VLX330	N/A	2.17 -0.10	2.44 -0.10	ns
		XC5VLX330T	N/A	2.17 -0.10	2.44 -0.10	ns
		XC5VSX35T	1.60 -0.39	1.78 -0.39	1.98 -0.39	ns
		XC5VSX50T	1.58 -0.37	1.76 -0.37	1.95 -0.37	ns
		XC5VSX95T	N/A	2.34 -0.41	2.35 -0.41	ns
		XC5VSX240T	N/A	2.25 -0.10	2.54 -0.10	ns



Table 92: Global Clock Setup and Hold With DCM in System-Synchronous Mode (Cont'd)

Symbol	Description	Dovice	Speed Grade  -3 -2 -1	le	Units	
	Description	Device		Ullits		
T <sub>PSDCM</sub> / T <sub>PHDCM</sub>	No Delay Global Clock and IFF <sup>(2)</sup> with DCM in System-Synchronous Mode	XC5VTX150T	N/A	1.85 -0.33	2.05 -0.33	ns
		XC5VTX240T	N/A	2.11 -0.32	2.35 -0.32	ns
		XC5VFX30T	1.80 -0.28	1.89 -0.28	2.02 -0.28	ns
		XC5VFX70T XC5VFX100T	1.76 -0.36	1.86 -0.36	1.98 -0.36	ns
			2.27 -0.51	2.35 -0.51	2.49 -0.49	ns
		XC5VFX130T	2.33 -0.43	2.48 -0.43	2.72 -0.42	ns
		XC5VFX200T	N/A	2.30 -0.23	2.43 -0.21	ns

- Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage. These measurements include DCM CLK0 jitter.
- 2. IFF = Input Flip-Flop or Latch
- 3. Use IBIS to determine any duty-cycle distortion incurred using various standards.



Table 93: Global Clock Setup and Hold With DCM in Source-Synchronous Mode

Symbol	Description	Device	S	peed Grad	le	Units
Symbol			-3	-2	-1	Office
Input Setup and Ho	old Time Relative to Global Clock Input Signal fo	or LVCMOS25 Stand	lard. <sup>(1)</sup>			
T <sub>PSDCM0</sub> / T <sub>PHDCM0</sub>	No Delay Global Clock and IFF <sup>(2)</sup> with DCM in Source-Synchronous Mode	XC5VLX20T	N/A	0.12 0.64	0.14 0.72	ns
		XC5VLX30	0.27 0.62	0.27 0.62	0.27 0.66	ns
		XC5VLX30T	0.27 0.62	0.27 0.62	0.27 0.66	ns
		XC5VLX50	0.26 0.64	0.26 0.64	0.26 0.68	ns
		XC5VLX50T	0.25 0.64	0.26 0.64	0.26 0.68	ns
		XC5VLX85	0.23 0.76	0.24 0.76	0.24 0.80	ns
	XC5VLX85T	0.23 0.76	0.24 0.76	0.24 0.80	ns	
	XC5VLX110	0.23 0.82	0.24 0.82	0.24 0.87	ns	
		XC5VLX110T	0.23 0.82	0.24 0.82	0.24 0.87	ns
		XC5VLX155	0.12 1.08	0.14 1.08	0.16 1.13	ns
		XC5VLX155T	0.12 1.08	0.14 1.08	0.16 1.13	ns
		XC5VLX220	N/A	0.21 1.31	0.22 1.36	ns
		XC5VLX220T	N/A	0.21 1.31	0.22 1.36	ns
		XC5VLX330	N/A	0.21 1.48	0.22 1.55	ns
		XC5VLX330T	N/A	0.21 1.48	0.22 1.55	ns
		XC5VSX35T	0.25 0.80	0.27 0.80	0.27 0.84	ns
		XC5VSX50T	0.24 0.82	0.25 0.82	0.25 0.86	ns
		XC5VSX95T	N/A	0.24 1.06	0.24 1.11	ns
		XC5VSX240T	N/A	0.20 1.55	0.21 1.62	ns



Table 93: Global Clock Setup and Hold With DCM in Source-Synchronous Mode (Cont'd)

Symbol	Description	Device	Speed Grade			Units
Symbol		Device	-3	-2	-1	Units
T <sub>PSDCM0</sub> / T <sub>PHDCM0</sub>	No Delay Global Clock and IFF <sup>(2)</sup> with DCM in Source-Synchronous Mode	XC5VTX150T	N/A	0.25 0.97	0.25 1.03	ns
		XC5VTX240T	N/A	0.24 1.20	0.24 1.26	ns
		XC5VFX30T	0.16 0.91	0.18 0.95	0.19 1.01	ns
		XC5VFX70T	0.13 0.83	0.14 0.86	0.14 0.92	ns
		XC5VFX100T	0.21 0.98	0.21 1.00	0.21 1.05	ns
		XC5VFX130T	0.19 1.15	0.21 1.19	0.24 1.25	ns
	XC5VFX200T	N/A	0.14 1.50	0.16 1.55	ns	

- Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage. These measurements include DCM CLK0 jitter.
- 2. IFF = Input Flip-Flop or Latch
- 3. Use IBIS to determine any duty-cycle distortion incurred using various standards.



Table 94: Global Clock Setup and Hold With PLL in System-Synchronous Mode

Symbol	Description	Device	S	Speed Grad	le	Units
Symbol		Device	-3	-2	-1	Units
Input Setup and H	lold Time Relative to Global Clock Input Signal fo	or LVCMOS25 Stand	dard. <sup>(1)</sup>			
T <sub>PSPLL</sub> / T <sub>PHPLL</sub>	No Delay Global Clock and IFF <sup>(2)</sup> with PLL in System-Synchronous Mode	XC5VLX20T	N/A	1.74 -0.82	2.02 -0.82	ns
	XC5VLX30	1.53 -0.80	1.68 -0.80	1.90 -0.79	ns	
		XC5VLX30T	1.52 -0.80	1.68 -0.80	1.90 -0.79	ns
	XC5VLX50	1.50 -0.64	1.65 -0.63	1.89 -0.62	ns	
		XC5VLX50T	1.50 -0.64	1.65 -0.63	1.89 -0.62	ns
		XC5VLX85	1.83 -0.63	1.95 -0.62	2.09 -0.61	ns
	XC5VLX85T	1.83 -0.63	1.95 -0.62	2.09 -0.61	ns	
	XC5VLX110	1.83 -0.58	1.96 -0.57	2.10 -0.57	ns	
		XC5VLX110T	1.83 -0.58	1.96 -0.57	2.10 -0.57	ns
		XC5VLX155	1.91 -0.49	2.09 -0.49	2.37 -0.47	ns
		XC5VLX155T	1.91 -0.49	2.09 -0.49	2.37 -0.47	ns
		XC5VLX220	N/A	1.93 -0.36	2.09 -0.36	ns
		XC5VLX220T	N/A	1.93 -0.36	2.09 -0.36	ns
		XC5VLX330	N/A	2.09 -0.21	2.33 -0.21	ns
		XC5VLX330T	N/A	2.12 -0.21	2.34 -0.21	ns
		XC5VSX35T	1.82 -0.82	2.02 -0.82	2.33 -0.82	ns
		XC5VSX50T	1.96 -0.72	2.07 -0.72	2.20 -0.72	ns
		XC5VSX95T	N/A	2.17 -0.80	2.35 -0.79	ns
		XC5VSX240T	N/A	2.11 -0.14	2.33 -0.14	ns



Table 94: Global Clock Setup and Hold With PLL in System-Synchronous Mode (Cont'd)

Symbol	Description	Device	Speed Grade			Units
Symbol		Device	-3	-2	-1	Ullits
	No Delay Global Clock and IFF <sup>(2)</sup> with PLL in System-Synchronous Mode	XC5VTX150T	N/A	1.82 -0.56	1.95 -0.56	ns
		XC5VTX240T	N/A	2.05 -0.43	2.26 -0.43	ns
		XC5VFX30T	1.82 -0.40	1.93 -0.40	2.09 -0.40	ns
		XC5VFX70T	1.79 -0.30	1.90 -0.30	2.07 -0.30	ns
		XC5VFX100T	1.81 -0.43	1.91 -0.40	2.09 -0.38	ns
		XC5VFX130T	1.79 -0.29	1.95 -0.28	2.14 -0.24	ns
		XC5VFX200T	N/A	2.06 -0.14	2.29 -0.14	ns

- Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage. These measurements include PLL CLKOUT0 jitter.
- 2. IFF = Input Flip-Flop or Latch.
- 3. Use IBIS to determine any duty-cycle distortion incurred using various standards.



Table 95: Global Clock Setup and Hold With PLL in Source-Synchronous Mode

Symbol	Description	Device	S	peed Grad	de	Units
Symbol		Device	-3	-2	-1	Units
Input Setup and H	old Time Relative to Global Clock Input Signal f	or LVCMOS25 Stand	dard. <sup>(1)</sup>			
T <sub>PSPLL0</sub> / T <sub>PHPLL0</sub>	No Delay Global Clock and IFF <sup>(2)</sup> with PLL in Source-Synchronous Mode	XC5VLX20T	N/A	-0.26 1.21	-0.25 1.40	ns
		XC5VLX30	-0.33 1.13	-0.33 1.22	-0.33 1.34	ns
		XC5VLX30T	-0.33 1.13	-0.33 1.22	-0.33 1.34	ns
		XC5VLX50	-0.24 1.21	-0.24 1.30	-0.23 1.42	ns
		XC5VLX50T	-0.24 1.21	-0.24 1.30	-0.23 1.42	ns
		XC5VLX85	-0.25 1.23	-0.23 1.30	-0.22 1.39	ns
	XC5VLX85T	-0.25 1.23	-0.23 1.30	-0.22 1.39	ns	
	XC5VLX110	-0.26 1.27	-0.24 1.34	-0.23 1.43	ns	
		XC5VLX110T	-0.26 1.27	-0.25 1.34	-0.23 1.43	ns
		XC5VLX155	-0.15 1.48	-0.12 1.56	-0.10 1.67	ns
		XC5VLX155T	-0.16 1.48	-0.12 1.56	-0.10 1.67	ns
		XC5VLX220	N/A	-0.34 1.75	-0.30 1.80	ns
		XC5VLX220T	N/A	-0.34 1.75	-0.31 1.80	ns
		XC5VLX330	N/A	-0.34 1.90	-0.30 1.95	ns
		XC5VLX330T	N/A	-0.34 1.90	-0.30 1.95	ns
		XC5VSX35T	-0.19 1.36	-0.18 1.44	-0.16 1.54	ns
		XC5VSX50T	-0.27 1.37	-0.26 1.44	-0.25 1.53	ns
		XC5VSX95T	N/A	-0.26 1.58	-0.24 1.65	ns
		XC5VSX240T	N/A	-0.35 1.97	-0.31 2.02	ns



Table 95: Global Clock Setup and Hold With PLL in Source-Synchronous Mode (Cont'd)

Symbol	Description	Device	Speed Grade			Units
Symbol		Device	-3	-2	-1	Ullits
T <sub>PSPLL0</sub> / T <sub>PHPLL0</sub>	No Delay Global Clock and IFF <sup>(2)</sup> with PLL in Source-Synchronous Mode	XC5VTX150T	N/A	-0.31 1.41	-0.29 1.47	ns
		XC5VTX240T	N/A	-0.31 1.61	-0.29 1.66	ns
		XC5VFX30T	-0.10 1.40	-0.09 1.46	-0.08 1.55	ns
		XC5VFX70T	-0.12 1.38	-0.10 1.44	-0.09 1.53	ns
		XC5VFX100T	-0.18 1.51	-0.18 1.60	-0.18 1.71	ns
		XC5VFX130T	-0.12 1.66	-0.11 1.76	-0.09 1.92	ns
		XC5VFX200T	N/A	-0.12 1.94	-0.10 2.06	ns

- Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage. These measurements include PLL CLKOUT0 jitter.
- 2. IFF = Input Flip-Flop or Latch.
- 3. Use IBIS to determine any duty-cycle distortion incurred using various standards.



Table 96: Global Clock Setup and Hold With DCM and PLL in System-Synchronous Mode

Cumbal	Decementary	Device	9	Speed Grad	de	Units
Symbol	Description		-3	-2	-1	Ullits
Input Setup and I	Hold Time Relative to Global Clock Input Signal f	or LVCMOS25 Stand	dard. <sup>(1)</sup>			
T <sub>PSDCMPLL</sub> / T <sub>PHDCMPLL</sub>	No Delay Global Clock and IFF <sup>(2)</sup> with DCM and PLL in System-Synchronous Mode	XC5VLX20T	N/A	1.67 -0.64	1.78 -0.64	ns
		XC5VLX30	1.72 -0.58	1.89 -0.58	2.07 -0.58	ns
		XC5VLX30T	1.72 -0.58	1.89 -0.58	2.06 -0.58	ns
		XC5VLX50	1.69 -0.56	1.86 -0.56	2.04 -0.56	ns
		XC5VLX50T	1.69 -0.56	1.86 -0.56	2.04 -0.56	ns
		XC5VLX85	1.74 -0.51	1.93 -0.51	2.13 -0.51	ns
		XC5VLX85T	1.74 -0.51	1.93 -0.51	2.13 -0.51	ns
	XC5VLX110	1.73 -0.45	1.93 -0.45	2.13 -0.45	ns	
		XC5VLX110T	1.73 -0.45	1.93 -0.45	2.13 -0.45	ns
		XC5VLX155	2.14 -0.40	2.31 -0.40	2.55 -0.40	ns
		XC5VLX155T	2.14 -0.40	2.31 -0.40	2.55 -0.40	ns
		XC5VLX220	N/A	2.32 -0.35	2.61 -0.35	ns
		XC5VLX220T	N/A	2.32 -0.35	2.61 -0.35	ns
		XC5VLX330	N/A	2.29 -0.18	2.60 -0.18	ns
		XC5VLX330T	N/A	2.32 -0.18	2.61 -0.18	ns
		XC5VSX35T	1.78 -0.47	1.97 -0.47	2.16 -0.47	ns
		XC5VSX50T	1.76 -0.45	1.94 -0.45	2.14 -0.45	ns
		XC5VSX95T	N/A	2.51 -0.49	2.53 -0.49	ns
		XC5VSX240T	N/A	2.39 -0.18	2.70 -0.18	ns



Table 96: Global Clock Setup and Hold With DCM and PLL in System-Synchronous Mode (Cont'd)

Symbol	Description	Device	Speed Grade			Units
Symbol		Device	-3	-2	-1	Ullits
T <sub>PSDCMPLL</sub> / T <sub>PHDCMPLL</sub>	No Delay Global Clock and IFF <sup>(2)</sup> with DCM and PLL in System-Synchronous Mode	XC5VTX150T	N/A	2.00 -0.41	2.22 -0.41	ns
		XC5VTX240T	N/A	2.25 -0.40	2.51 -0.40	ns
		XC5VFX30T	1.97 -0.36	2.08 -0.36	2.21 -0.36	ns
		XC5VFX70T	1.92 -0.44	2.03 -0.44	2.16 -0.44	ns
		XC5VFX100T	2.40 -0.59	2.51 -0.59	2.66 -0.58	ns
		XC5VFX130T	2.46 -0.51	2.64 -0.51	2.89 -0.51	ns
		XC5VFX200T	N/A	2.44 -0.31	2.59 -0.30	ns

- Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage. These measurements include CMT jitter; DCM CLK0 driving PLL, PLL CLKOUT0 driving BUFG.
- 2. IFF = Input Flip-Flop or Latch.
- 3. Use IBIS to determine any duty-cycle distortion incurred using various standards.



Table 97: Global Clock Setup and Hold With DCM and PLL in Source-Synchronous Mode

Symbol	Description	Device	S	peed Grad	de	Unit
Symbol	Description	Device	-3	-2	-1	Unit
ituations where clo	Setup and Hold Times Relative to a Forwarded Clock and data inputs conform to different standards, a hing Characteristics, page 32.	ck Input Pin, <sup>(1)</sup> Usir djust the setup and	ng DCM, PLL hold values	, and Globa accordingly	al Clock Burusing the v	ffer. Fo ⁄alues
PSDCMPLL_0/ PHDCMPLL_0	No Delay Global Clock and IFF <sup>(2)</sup> with DCM and PLL in Source-Synchronous Mode	XC5VLX20T	N/A	0.32 0.56	0.33 0.63	ns
		XC5VLX30	0.45 0.54	0.46 0.54	0.46 0.57	ns
		XC5VLX30T	0.45 0.54	0.46 0.54	0.46 0.57	ns
		XC5VLX50	0.43 0.56	0.44 0.56	0.44 0.59	ns
		XC5VLX50T	0.43 0.56	0.44 0.56	0.44 0.59	ns
	XC5VLX85	0.40 0.68	0.42 0.68	0.42 0.71	ns	
	XC5VLX85T	0.39 0.68	0.42 0.68	0.42 0.71	ns	
	XC5VLX110	0.38 0.74	0.41 0.74	0.41 0.78	ns	
		XC5VLX110T	0.38 0.74	0.41 0.74	0.41 0.78	ns
		XC5VLX155	0.24 1.00	0.29 1.00	0.33 1.04	ns
		XC5VLX155T	0.24 1.00	0.29 1.00	0.33 1.04	ns
		XC5VLX220	N/A	0.36 1.23	0.38 1.27	ns
		XC5VLX220T	N/A	0.36 1.23	0.38 1.27	ns
		XC5VLX330	N/A	0.34 1.40	0.37 1.46	ns
		XC5VLX330T	N/A	0.36 1.40	0.38 1.46	ns
		XC5VSX35T	0.44 0.72	0.46 0.72	0.46 0.75	ns
	XC5VSX50T	0.41 0.74	0.43 0.74	0.43 0.77	ns	
		XC5VSX95T	N/A	0.41 0.98	0.41 1.02	ns
		XC5VSX240T	N/A	0.35 1.47	0.38 1.53	ns



Table 97: Global Clock Setup and Hold With DCM and PLL in Source-Synchronous Mode

Symbol	Description	Device	Speed Grade			Units
Syllibol		Device	-3	-2	-1	Ullits
T <sub>PSDCMPLL_0</sub> / T <sub>PHDCMPLL_0</sub>	No Delay Global Clock and IFF <sup>(2)</sup> with DCM and PLL in Source-Synchronous Mode	XC5VTX150T	N/A	0.40 0.89	0.40 0.94	ns
	XC5VTX240T	N/A	0.38 1.12	0.39 1.17	ns	
		XC5VFX30T	0.34 0.83	0.36 0.87	0.37 0.92	ns
		XC5VFX70T	0.29 0.75	0.32 0.78	0.32 0.83	ns
		XC5VFX100T	0.35 0.90	0.35 0.92	0.35 0.96	ns
	XC5VFX130T	0.33 1.07	0.37 1.11	0.41 1.16	ns	
	XC5VFX200T	N/A	0.29 1.42	0.33 1.46	ns	

- 1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage. The timing values were measured using the fine-phase adjustment feature of the DCM. These measurements include CMT jitter; DCM CLK0 driving PLL, PLL CLKOUT0 driving BUFG. Package skew is not included in these measurements.
- 2. IFF = Input Flip-Flop.



# **Source-Synchronous Switching Characteristics**

The parameters in this section provide the necessary values for calculating timing budgets for Virtex-5 FPGA source-synchronous transmitter and receiver data-valid windows.

Table 98: Duty Cycle Distortion and Clock-Tree Skew

O la a l	Description	Davis	Speed Grade			Unito
Symbol		Device	-3	-2	-1	Units
T <sub>DCD_CLK</sub>	Global Clock Tree Duty Cycle Distortion <sup>(1)</sup>	All	0.12	0.12	0.12	ns
T <sub>CKSKEW</sub>	Global Clock Tree Skew <sup>(2)</sup>	XC5VLX20T	N/A	0.24	0.25	ns
		XC5VLX30	0.21	0.22	0.22	ns
		XC5VLX30T	0.21	0.22	0.22	ns
		XC5VLX50	0.26	0.27	0.28	ns
		XC5VLX50T	0.26	0.27	0.28	ns
		XC5VLX85	0.42	0.43	0.45	ns
		XC5VLX85T	0.42	0.43	0.45	ns
	XC5VLX110	0.48	0.50	0.51	ns	
	XC5VLX110T	0.48	0.50	0.51	ns	
	XC5VLX155	0.82	0.85	0.88	ns	
	XC5VLX155T	0.82	0.85	0.88	ns	
	XC5VLX220	N/A	1.07	1.10	ns	
	XC5VLX220T	N/A	1.07	1.10	ns	
		XC5VLX330	N/A	1.25	1.29	ns
		XC5VLX330T	N/A	1.25	1.29	ns
		XC5VSX35T	0.38	0.39	0.39	ns
		XC5VSX50T	0.43	0.44	0.45	ns
		XC5VSX95T	N/A	0.72	0.74	ns
		XC5VSX240T	N/A	1.32	1.36	ns
		XC5VTX150T	N/A	0.70	0.73	ns
		XC5VTX240T	N/A	0.97	1.00	ns
		XC5VFX30T	0.34	0.35	0.35	ns
		XC5VFX70T	0.41	0.42	0.43	ns
		XC5VFX100T	0.82	0.84	0.86	ns
		XC5VFX130T	0.82	0.84	0.86	ns
		XC5VFX200T	N/A	1.24	1.29	ns
T <sub>DCD_BUFIO</sub>	I/O clock tree duty cycle distortion	All	0.10	0.10	0.10	ns
T <sub>BUFIOSKEW</sub>	I/O clock tree skew across one clock region	All	0.07	0.07	0.08	ns
T <sub>DCD_BUFR</sub>	Regional clock tree duty cycle distortion	All	0.25	0.25	0.25	ns

<sup>1.</sup> These parameters represent the worst-case duty cycle distortion observable at the pins of the device using LVDS output buffers. For cases where other I/O standards are used, IBIS can be used to calculate any additional duty cycle distortion that might be caused by asymmetrical rise/fall times.

<sup>2.</sup> The T<sub>CKSKEW</sub> value represents the worst-case clock-tree skew observable between sequential I/O elements. Significantly less clock-tree skew exists for I/O registers that are close to each other and fed by the same or adjacent clock-tree branches. Use the Xilinx FPGA\_Editor and Timing Analyzer tools to evaluate clock skew specific to the application.



Table 99: Package Skew

Symbol	Description	Device	Package	Value	Units
T <sub>PKGSKEW</sub>	Package Skew <sup>(1)</sup>	XC5VLX20T	FF323	131	ps
		XC5VLX30	FF324	80	ps
		ACSVLA30	FF676	142	ps
		VOEVI VOOT	FF323	127	ps
		XC5VLX30T	FF665	93	ps
			FF324	80	ps
		XC5VLX50	FF676	142	ps
			FF1153	175	ps
		VOEVI VEOT	FF665	93	ps
		XC5VLX50T	FF1136	162	ps
		VOEVI VOE	FF676	142	ps
		XC5VLX85	FF1153	174	ps
		XC5VLX85T	FF1136	164	ps
			FF676	142	ps
		XC5VLX110	FF1153	173	ps
			FF1760	190	ps
		VOEVI VII OT	FF1136	163	ps
		XC5VLX110T	FF1738	171	ps
		V05VI V455	FF1153	161	ps
		XC5VLX155	FF1760	181	ps
		VOEVI V1EET	FF1136	147	ps
		XC5VLX155T	FF1738	174	ps
		XC5VLX220	FF1760	178	ps
		XC5VLX220T	FF1738	156	ps
		XC5VLX330	FF1760	177	ps
		XC5VLX330T	FF1738	155	ps
		XC5VSX35T	FF665	103	ps
		XC5VSX50T	FF665	103	ps
		VC2A2V201	FF1136	157	ps
		XC5VSX95T	FF1136	176	ps
		XC5VSX240T	FF1738	161	ps
		XC5VTX150T	FF1156		ps
		XC5VTX150T	FF1759	157	ps
		XC5VTX240T	FF1759	157	ps
		XC5VFX30T	FF665	102	ps
		VOEVEVZOT	FF665	102	ps
		XC5VFX70T	FF1136	153	ps
		VCEVEV100T	FF1136	144	ps
		XC5VFX100T	FF1738	172	ps
	>	XC5VFX130T	FF1738	181	ps
		XC5VFX200T	FF1738	164	ps

<sup>1.</sup> These values represent the worst-case skew between any two SelectIO resources in the package: shortest flight time to longest flight time from Pad to Ball (7.0 ps per mm).

<sup>2.</sup> Package trace length information is available for these device/package combinations. This information can be used to deskew the package.



### Table 100: Sample Window

Symbol	Description	Device	Speed Grade			Units
Symbol	Description	Device	-3	-2	-1	Offics
T <sub>SAMP</sub>	Sampling Error at Receiver Pins <sup>(1)</sup>	All	450	500	550	ps
T <sub>SAMP_BUFIO</sub>	Sampling Error at Receiver Pins using BUFIO <sup>(2)</sup>	All	350	400	450	ps

#### Notes:

- This parameter indicates the total sampling error of Virtex-5 FPGA DDR input registers across voltage, temperature, and process. The
  characterization methodology uses the DCM to capture the DDR input registers' edges of operation. These measurements include:
   CLK0 DCM jitter
  - DCM accuracy (phase offset)
  - DCM phase shift resolution

These measurements do not include package or clock tree skew.

2. This parameter indicates the total sampling error of Virtex-5 FPGA DDR input registers across voltage, temperature, and process. The characterization methodology uses the BUFIO clock network and IODELAY to capture the DDR input registers' edges of operation. These measurements do not include package or clock tree skew.

Table 101: Source-Synchronous Pin-to-Pin Setup/Hold and Clock-to-Out

Cumbal	Description	Speed Grade			l lasida		
Symbol		-3	-2	-1	Units		
Data Input Setup and Hol	Data Input Setup and Hold Times Relative to a Forwarded Clock Input Pin Using BUFIO						
T <sub>PSCS</sub> /T <sub>PHCS</sub>	Setup/Hold of I/O clock	-0.56 1.59	-0.54 1.72	-0.54 1.91	ns		
Pin-to-Pin Clock-to-Out Using BUFIO							
T <sub>ICKOFCS</sub>	Clock-to-Out of I/O clock	4.42	4.82	5.40	ns		

# **Revision History**

The following table shows the revision history for this document.

Date	Version	Revision
04/14/2006	1.0	Initial Xilinx release.
05/12/2006	1.1	<ul> <li>First version posted to the Xilinx website. Minor typographical edits. Revised design software version on page 30.</li> <li>Revised T<sub>IDELAYRESOLUTION</sub> in Table 64, page 44.</li> <li>Revised TDSPCKO in Table 69, page 48.</li> </ul>
05/24/2006	1.2	Added register-to-register parameters to Table 52.
08/04/2006	1.3	<ul> <li>Added V<sub>DRINT</sub>, V<sub>DRI</sub>, and C<sub>IN</sub> values to Table 3.</li> <li>Added HSTL_I_12 and LVCMOS12 to Table 7 and renumbered the notes.</li> <li>Removed pin-to-pin performance (Table 12). Updated and added values to register-register performance Table 52 (was Table 13).</li> <li>Added values to Table 53.</li> <li>Updated the speed specification version above Table 54.</li> <li>Added to Table 56 the I/O standards: HSTL_II_T_DCI, HSTL_II_T_DCI_18, SSTL2_II_T_DCI, and SSTL18_II_T_DCI.</li> <li>Revised F<sub>MAX</sub> values in Table 68, and RDWR_B Setup/Hold values in Table 70.</li> <li>In Table 74, changed F<sub>VCOMAX</sub>, removed T<sub>LOCKMIN</sub>, and revised T<sub>LOCKMAX</sub> values, also removed note pointing to Architecture Wizard.</li> <li>Removed Note 2 on Table 88.</li> </ul>



Date	Version	Revision
09/06/2006	2.0	<ul> <li>Added new sections for LXT devices and added LXT devices to the appropriate tables. The addition of the GTP_DUAL Tile Specifications required the tables to be renumbered.</li> <li>Changed maximum V<sub>IN</sub> values in Table 1 and Table 2.</li> <li>Updated values and added T<sub>j</sub> = 85°C to Table 4, page 3.</li> <li>Revised the cascade block RAM Memory, page 28 section in Table 52 to 64K with new I/O delays.</li> <li>Revised the setup and hold times in Table 60, page 40.</li> <li>Added F<sub>MAX_CASCADE</sub> to Table 68, page 47.</li> <li>Revised F<sub>FXLFMSMAX</sub> and F<sub>CLKINLFFXMSMAX</sub> in Table 76, page 57.</li> </ul>
10/13/2006	2.1	<ul> <li>Added System Monitor parameters. Added XC5VLX85T to appropriate tables.</li> <li>Revised Table 28 including notes. Added Table 29, and Figure 3 and Figure 4.</li> <li>Added Table 48, page 25: RocketIO CRC block.</li> <li>Revised design software version and Table 54 on page 30.</li> <li>Updated ILOGIC Switching Characteristics, page 40</li> <li>Updated F<sub>MAX_ECC</sub> in Table 68, page 47.</li> <li>Changed hold times for T<sub>SMDCCK</sub>/T<sub>SMCCKD</sub> and T<sub>BPIDCC</sub>/T<sub>BPICCD</sub> in Table 70, page 51.</li> <li>Revised T<sub>FBDELAY</sub>, F<sub>OUTMIN</sub>, F<sub>OUTMAX</sub>, and F<sub>INJITTER</sub> Table 74, page 55.</li> <li>Revised Table 76, page 57.</li> </ul>
01/05/2007	2.2	<ul> <li>Added I<sub>IN</sub> to Table 2. Added XC5VLX220T to appropriate tables.</li> <li>Added LVDCl33, LVDCl25, LVDCl18, LVDCl15 to Table 7.</li> <li>Update the symbols in the GTP Transceiver Table 24, Table 25, and Table 26.</li> <li>Add values for -1 speed grade in Table 30, page 16.</li> <li>Added SFI-4.1 values to Table 53, page 29.</li> <li>Removed -3 speed grade from available LX220 device list in Table 54, page 30.</li> <li>Added maximum frequency to Table 72 and Table 73, page 54.</li> <li>In Table 76, page 57 changed the all the CLKDV, CLKFX, and CLKFX180 Min values and the CLKIN Min values in the Input Clocks (High Frequency Mode) section.</li> <li>Added values to Table 79 and Table 80, page 60.</li> </ul>



Date	Version	Revision
02/02/2007	3.0	Added XC5VSX35T, XC5VSX50T, and SX5VSX95T devices to appropriate tables.
		Revised the I <sub>RPU</sub> values in Table 3, page 2.
		Revised the I <sub>CCAUXO</sub> values in Table 4, page 3.
		Added values to Table 5, page 6.
		Minor added notes and changed descriptions in Table 25, page 13 and Table 26, page 13.
		Revised the SFI-4.1 (SDR LVDS Interface) -1 values in Table 53, page 29.
		Revised gain error, bipolar gain error, and event conversion time in Table 51, page 26
		• Changed the design software version that matches this data sheet above Table 54 on page 30.
		In Switching Characteristics, the following values are revised:
		LVCMOS25, Fast, 12 mA in Table 56, page 32.
		<ul> <li>Setup and Hold and T<sub>ICKQ</sub> in Table 60, page 40.</li> </ul>
		T <sub>OCKQ</sub> in Table 61, page 41.
		Sequential delay values in Table 63, page 43.
		T <sub>CXB</sub> , T <sub>CEO</sub> , and T <sub>DICK</sub> in Table 65, page 44.
		• TRCKO_DO, TRCKO_POINTERS, TRCKO_ECCR, TRCKO_ECC, TRCCK_ADDR, TRDCK_DI, TRDCK_DI_ECC, TRCCK_WREN, and TRCO_FLAGS in Table 68, page 47.
		• TDSPDCK_CC, TDSPCCK_{RSTAA, RSTBB}, TDSPCKO_{PP, CRYOUTP}, FMAX_MULT_NOMREG and FMAX_MULT_NOMREG_PATDET in Table 69, page 48.
		• T <sub>BCCKO_O</sub> , and T <sub>BGCKO_O</sub> in Table 71, page 53.
		T <sub>BUFIOCKO_O</sub> and F <sub>MAX</sub> in Table 72, page 53.
		• T <sub>BRCKO_O</sub> and T <sub>BRCKO_O_BYP</sub> in Table 73, page 54.
		Parameters in Table 74, page 55 including notes.
		In Virtex-5 Device Pin-to-Pin Output Parameter Guidelines:
		Revised values in Table 84, Table 85, and Table 86.
		In Virtex-5 Device Pin-to-Pin Input Parameter Guidelines:
		Clarified description in Table 91, page 69.
		<ul> <li>Revised values in Table 91, Table 92, and Table 93.</li> </ul>
		<ul> <li>Removed duplicate T<sub>BUFR_MAX_FREQ</sub> and T<sub>BUFIO_MAX_FREQ</sub> from Table 98.</li> <li>Revised values in Table 101, page 85.</li> </ul>



Date	Version	Revision
05/18/2007	3.1	<ul> <li>Added typical values for n and r in Table 3.</li> <li>Revised and added values to Table 4.</li> <li>Revised standard I/O levels in Table 7.</li> <li>Additions and updates to Table 26, Table 28, Table 29, Table 30, Table 48, Table 32, Table 33, Table 34, and Table 35.</li> <li>Added Ethernet MAC Switching Characteristics, page 25.</li> <li>Changed the design software version that matches this data sheet above Table 54 on page 30.</li> <li>Added new section: I/O Standard Adjustment Measurement Methodology, page 37.</li> <li>In Switching Characteristics, the following values are revised: <ul> <li>LVTTL, Slow and Fast, 2 mA, 4 mA, and 6 mA (Table 56).</li> <li>LVCMOS33, Slow and Fast, 2 mA, 4 mA, and 6 mA (Table 56).</li> <li>LVCMOS35, Slow and Fast, 2 mA and 4 mA, and Fast 12 mA (Table 56).</li> <li>LVCMOS18, Slow and Fast, 2 mA, 4 mA, and 6 mA (Table 56).</li> <li>LVCMOS18, Slow and Fast, 2 mA, 4 mA, and 6 mA (Table 56).</li> <li>LVCMOS18 and LVCMOS12, Slow and Fast, 2 mA (Table 56).</li> <li>LVCMOS18 and LVCMOS12, Slow and Fast, 2 mA (Table 56).</li> </ul> </li> <li>LVCMOS18 and T<sub>IDOCKD</sub> in Table 60.</li> <li>Setup/Hold for Control Lines and Data Lines in Table 62.</li> <li>Add T<sub>IDELAYPAT_JIT</sub> and revised T<sub>IDELAYRESOLUTION</sub> in Table 64, page 44 and added Notes 1 and 2.</li> <li>Revised T<sub>RCK</sub> page 45 and removed T<sub>ICKSR</sub> Table 65, page 44.</li> <li>Replaced T<sub>TWC</sub> with T<sub>MCP</sub> symbol in Table 66, page 46.</li> <li>Revised T<sub>RCKO</sub> FLAGS and T<sub>RDCK_DL</sub> ECC encode only in Table 68.</li> <li>Revised T<sub>RCKO</sub> FLAGS and T<sub>RDCK_DL</sub> ECC encode only in Table 68.</li> <li>Revised T<sub>RCKO</sub> FLAGS and T<sub>RDCK_DL</sub> ECC encode only in Table 68.</li> <li>Revised T<sub>RCKO</sub> FLAGS and T<sub>RDCK_DL</sub> ECC encode only in Table 69.</li> <li>Updated and added values to Table 70, page 51.</li> <li>Revised 1 speed F<sub>MAX</sub> value in Table 72, page 53.</li> <li>Added note 4 to T<sub>LOCKMAX</sub> and revised F<sub>INDUTY</sub>, F<sub>INMAX</sub> and F<sub>VCOMAX</sub> in Table 74, page 55.</li> <li>Added 1 speed F<sub>MAX</sub> value in Table 80. Changed T<sub>OUT_OFFSET</sub> in Table 80.</li></ul>
06/15/2007	3.2	<ul> <li>Updated T<sub>STG</sub> in Table 1.</li> <li>Corrected V<sub>OH</sub>/V<sub>OL</sub> in Table 9 and Table 10, page 8.</li> <li>Changed the design software version that matches this data sheet above Table 54 on page 30.</li> <li>Added Production Silicon and ISE Software Status, page 31.</li> <li>Added T<sub>IODELAY_CLK_MAX</sub> and revised T<sub>CKSR</sub> in Table 64, page 44.</li> <li>In Virtex-5 Device Pin-to-Pin Output Parameter Guidelines: Revised values in Table 85 through Table 90.</li> <li>In Virtex-5 Device Pin-to-Pin Input Parameter Guidelines: Revised values in Table 92 through Table 97.</li> <li>Corrected units to ns in Table 98, page 83.</li> </ul>



Date	Version	Revision
06/26/2007	3.3	<ul> <li>Added conditions to DV<sub>PPIN</sub> in Table 28, page 14.</li> <li>Changed the F<sub>GTXMAX</sub> symbol name to F<sub>GTPMAX</sub>.</li> <li>Updated GTP maximum line rates to 3.75 Gb/s in Table 30, page 16.</li> <li>Updated maximum frequencies in Table 33, page 17.</li> <li>Added 3.75 Gb/s condition and changed maximum value of F<sub>GTX</sub> in Table 34, page 17.</li> <li>Added 3.75 Gb/s sinusoidal jitter specification and changed maximum value of F<sub>GRX</sub> in Table 35, page 18.</li> <li>Changed analog input common mode ranges in Table 51, page 26.</li> <li>Changed T<sub>PKGSKEW</sub> values in Table 99, page 84.</li> </ul>
07/26/2007	3.4	<ul> <li>Added maximum value of I<sub>REF</sub> to Table 3, page 2.</li> <li>Revised Table 54 and changed the design software version in Table 55 for production devices.</li> <li>In Table 64, page 44, added High Performance Mode to Note 2.</li> <li>In Table 70, page 51, revised description of T<sub>SMDCCK</sub>/T<sub>SMCCKD</sub>.</li> <li>Added Note 4 to T<sub>DUTYCYCRANGE_200_400</sub> frequency range in Table 78, page 59.</li> <li>In Virtex-5 Device Pin-to-Pin Input Parameter Guidelines: Revised note 1 in Table 91 through Table 96.</li> </ul>
09/27/2007	3.5	<ul> <li>Added I<sub>BATT</sub> value and Note 2 to Table 3.</li> <li>Added DRP Clock Frequency and Note 4 to Table 51. Revised the typical and maximum values and units for gain error and bipolar gain error.</li> <li>Removed unsupported XC5VSX95T -3 speed grade from Table 54 and Table 55.</li> <li>Removed unsupported I/O standards (LVDS_33, LVDSEXT_33, and ULVDS_25) from Table 51. Also updated LVDSEXT, 2.5V in Table 59.</li> <li>Added values to Dynamic Reconfiguration Port (DRP) for DCM and PLL Before and After DCLK in Table 70.</li> <li>In Virtex-5 Device Pin-to-Pin Input Parameter Guidelines: Revised note 1 in Table 91 through Table 97.</li> </ul>
11/05/2007	3.6	<ul> <li>Removed note 1 from Table 52, page 28. F<sub>MAX</sub> of clock is not an applicable limitation.</li> <li>Revised DDR2 memory interface performance in Table 53, page 29.</li> <li>Revised Table 55 to add ISE 9.2i SP3 where applicable.</li> <li>Removed XC5VSX95T -3 speed grade support from applicable tables.</li> <li>Removed unsupported I/O standard (LVPECL_33) from Table 58 and added LVPECL_25.</li> <li>Added T<sub>SMCO</sub> and T<sub>SMCKBY</sub> to Table 70, page 51.</li> <li>Revised note 3 in Table 76, page 57 and Table 77, page 58.</li> <li>Clarified notes in Table 87 to Table 90, and Table 94 to Table 97.</li> <li>Revised note 1 in Table 99.</li> </ul>
12/11/2007	3.7	<ul> <li>Added new devices (XC5VLX20T, XC5VLX155, and XC5VLX155T) throughout document.</li> <li>Removed -3 speed grade from XC5VSX95T device lists.</li> <li>Added Table 31, page 16.</li> <li>Revised Virtex-5 Device Pin-to-Pin Output Parameter Guidelines in Table 87 through Table 90, and Virtex-5 Device Pin-to-Pin Input Parameter Guidelines in Table 90 and Table 92 through Table 97. Also revised Note 1 on Table 92 through Table 97.</li> <li>Revised Note 1 on Table 99.</li> </ul>
02/05/2008	3.8	<ul> <li>Updated date on version 3.7. Other minor typographical edits.</li> <li>Updated the sentence: Xilinx does not specify the current or I/O behavior for other power-on sequences, on page 6.</li> <li>Added values and notes to Table 27, page 14. Removed I<sub>CCINTQ</sub> since it is included in Table 4, page 3. Combined I<sub>VTTRXQ</sub> into I<sub>VTTRXQ</sub> values.</li> <li>Revised T<sub>LLSKEW</sub> values in Table 34, page 17.</li> <li>Revised R<sub>XPPMTOL</sub> values and note 1 in Table 35, page 18.</li> <li>Revised -2 performance value for SPI-4.2 in Table 53, page 29.</li> <li>Added T<sub>IODDQ_T</sub>, T<sub>IODDQ_IDATAIN</sub>, T<sub>IODDQ_ODATAIN</sub>, and Note 3 to Table 64, page 44.</li> <li>Split out the F<sub>MAX</sub> rows in Table 71 and the F<sub>OUTMAX</sub> rows in Table 74, revised -2 value for smallest devices in both tables.</li> <li>Added Table 75: PLL in PMCD Mode Switching Characteristics, page 56.</li> <li>Updated Table 4 and Table 84 to Table 98 to match speed grade designations listed in Table 54.</li> <li>Revised Note 1 on Table 96 and Table 97.</li> </ul>



Date	Version	Revision
03/31/2008	4.0	<ul> <li>Added XC5VFX30T, XC5VFX70T, XC5VFX100T, XC5VFX130T, XC5VFX200T devices to appropriate tables.</li> <li>Updated Power-On Power Supply Requirements, page 6.</li> <li>Added GTX_DUAL Tile Specifications and PowerPC 440 Switching Characteristicssections.</li> <li>Corrected MGTAVCC in Table 24, page 13.</li> <li>Updated MGTR<sub>REF</sub> in Table 26, page 13.</li> <li>Changed the symbol names to F<sub>GTPTX</sub> in Table 34 and F<sub>GTPRX</sub> in Table 35.</li> <li>Moved the CRC Block Switching Characteristics to Table 48, page 25.</li> <li>Added notes to Table 53.</li> <li>Revised speed specification version to 1.59.</li> </ul>
04/25/2008	4.1	<ul> <li>Added XC5VSX240T to appropriate tables.</li> <li>Clarified maximum frequency descriptions in Table 68, page 47.</li> <li>Added Maximum Readback Frequency (F<sub>RBCCK</sub>) to SelectMAP Mode Programming Switching in Table 70.</li> <li>Revised speed specification version to 1.60.</li> </ul>
05/09/2008	4.2	<ul> <li>Revised Ethernet MAC Switching Characteristics and added Endpoint Block for PCI Express Designs Switching Characteristics.</li> <li>Revised some V<sub>MEAS</sub> values and added note 6 to Table 58, page 37. Added Figure 12, page 38 to Output Delay Measurements. Revised some V<sub>MEAS</sub> and R<sub>REF</sub> values and added note 4 to Table 59, page 38.</li> <li>Reversed the order of the setup/hold values for T<sub>PLLCCK_REL</sub>/T<sub>PLLCKC_REL</sub> in Table 75, page 56.</li> <li>Added Package Skew values to Table 99, page 84.</li> </ul>
05/15/2008	4.3	Revised Table 12, page 9.
06/12/2008	4.4	<ul> <li>Added values to some devices in Table 4.</li> <li>Increased the maximum V<sub>IN</sub> in Table 28, page 14.</li> <li>Revised V<sub>IDIFF</sub> and V<sub>ISE</sub> in Table 29, Figure 3, and Figure 4, page 15. Same change for GTX transceivers in Table 41, Figure 8, and Figure 9, page 21.</li> <li>Added values to Table 43.</li> <li>Updated Table 54 and Table 55 with production status on some devices.</li> <li>In Table 71, revised T<sub>BCCKO_0</sub>, T<sub>BGCKO_0</sub>. In Table 73, revised T<sub>BRCKO_O</sub>, and T<sub>BRCKO_O_BYP</sub></li> <li>Revised XC5VLX20T, XC5VLX155, XC5VLX155T, XC5VFX30T, XC5VFX70T, XC5VFX100T, XC5VFX130T, and some XC5VSX240T values in Table 84 through Table 98.</li> </ul>
06/18/2008	4.5	Added values to Table 5.
06/26/2008	4.6	<ul> <li>Added values to Table 5.</li> <li>Moved XC5VLX20T to production in Table 54 and Table 55.</li> <li>Updated the F<sub>OUTMAX</sub> in Table 74.</li> </ul>
09/23/2008	4.7	<ul> <li>Added XC5VTX150T and XC5VTX240T devices to appropriate tables.</li> <li>Added values to Table 4 and Table 5.</li> <li>Updated data in Table 38, Table 39, Table 40, Table 41, Table 42, Table 44, Table 45, Table 46, and Table 47.</li> <li>Moved XC5VLX20T to production in Table 54 and Table 55.</li> <li>Added note 8 to Table 68, page 47.</li> <li>Added note 1 to Table 74, page 55.</li> </ul>



Date	Version	Revision
12/02/2008	4.8	<ul> <li>Added I<sub>IN</sub> row to Absolute Maximum Ratings in Table 1, page 1.</li> <li>In Table 32, page 16, changed duty cycle values for T<sub>DCREF</sub> and added note 2.</li> <li>Changed Conditions for T<sub>PHASE</sub> in Table 32, page 16 and Table 44, page 22.</li> <li>In Table 35, page 18, updated R<sub>XPPMTOL</sub> values, updated note 1, and added note 2.</li> <li>In Table 45, page 23, updated parameters with separate FXT and TXT values.</li> <li>In Table 46, page 23, corrected units of T<sub>LLSKEW</sub>.</li> <li>In Table 54, page 30, updated SX240T, FXT, and TXT speed grade designations.</li> <li>In Table 55, page 31, updated SX240T and FXT rows.</li> <li>In Table 58, page 37, added LVCMOS, 1.2V row.</li> <li>In Table 59, page 38, corrected V<sub>MEAS</sub> value for LVCMOS, 1.2V row.</li> <li>In Table 80, page 60, updated note 3 with sentence about global clock tree.</li> </ul>
12/19/2008	4.9	Updated Table 5, page 6 with power-on current values for XC5VSX240T, XC5VTX150T, XC5VTX240T, XC5VFX100T, and XC5VFX200T devices.
01/14/2009	4.10	<ul> <li>In Table 1, page 1, changed note 2 to refer to UG112 for soldering guidelines.</li> <li>In Table 54, page 30, moved speed grades for the XC5VTX150T and XC5VTX240T devices to Production.</li> <li>In Table 55, page 31, added the ISE software version for the XC5VTX150T and XC5VTX240T devices.</li> <li>In Table 80, page 60, moved the reference to the duty cycle distortion note to apply to both TDUTY_CYC_DLL and TDUTY_CYC_FX.</li> </ul>
02/06/2009	5.0	<ul> <li>Changed document classification from Advance Product Specification to Product Specification.</li> <li>In Table 1, page 1, changed V<sub>IN</sub> and added note 5.</li> <li>In Table 5, page 6, removed the Max columns and added note 2 about calculating the maximum startup current.</li> <li>In Table 74, page 55, removed LX20T from second row of F<sub>OUTMAX</sub>.</li> </ul>
04/01/2009	5.1	<ul> <li>In Table 65, page 44, changed "A – D input" to "AX – DX input" for the T<sub>DICK</sub>/T<sub>CKDI</sub> parameter.</li> <li>In Table 74, page 55, prepended "±" to all speed grade values for the T<sub>OUTDUTY</sub> parameter.</li> </ul>
06/25/2009	5.2	<ul> <li>In Table 2, page 2, added note 6.</li> <li>In Table 11, page 9, changed V<sub>CCAUX</sub> to V<sub>CCO</sub> in note 1.</li> </ul>
05/05/2010	5.3	Removed DV <sub>PPIN</sub> from the examples in Figure 2 and Figure 7. In Table 31, changed "GTPDRPCLK" to "GTP DCLK (DRP clock)" in the Description column. In Table 35, added table note 2 about R <sub>XPPMTOL</sub> . In Table 41, changed the maximum value of V <sub>ISE</sub> to 1000 mV. In Table 42, changed the minimum PLL frequency (F <sub>GPLLMIN</sub> ) to 1.48 GHz for all three speed grades. In Table 43, changed "GTXDRPCLK" to "GTX DCLK (DRP clock)" in the Description column. In Table 45, removed "2 byte or 4 byte interface" from the Conditions column for T <sub>RX</sub> and T <sub>TX</sub> . In Table 47, added table note 2 about R <sub>XPPMTOL</sub> . In Table 51, changed the maximum value of Al <sub>DD</sub> to 13 mA. In Table 74, updated description of T <sub>FBDELAY</sub> .
12/04/2014	5.4	Revised VCMOUT in Table 40. Updated Notice of Disclaimer.



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